# Agilent Technologies 8935 Series E6381A TDMA Cellular/PCS Base Station Test Set

# **Assembly Level Repair**

Firmware Version A.02.01 and above



Manufacturing Part Number: E6381-90015 CDROM Part Number: E6381-90020 Revision E Printed in UK January 2001

# **Notice**

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# 1 General Information

This chapter contains generic information about the product, safety, warranty, sales and service offices, power cables, and other information.

## **Manufacturer's Declaration**

This statement is provided to comply with the requirements of the German Sound Emission Directive, from 18 January 1991.

This product has the following sound pressure emission specification:

- sound pressure Lp <70 dB(A)</li>
- at the operator position
- under normal operation
- according to ISO 7779:1988/EN 27779:1991 (Type Test).

#### Herstellerbescheinigung

Diese Information steht im Zusammenhang mit den Anforderungen der Maschinenlärminformationsverordnung vom 18 Januar 1991.

- Schalldruckpegel Lp < 70 dB(A).</li>
- · Am Arbeitsplatz.
- Normaler Betrieb.
- Nach ISO 7779:1988/EN 27779:1991 (Typprüfung).

# **Safety Considerations**

#### **GENERAL**

This product and related documentation must be reviewed for familiarization with safety markings and instructions before operation.

This product has been designed and tested in accordance with IEC Publication 61010-1+A1+A2:1992 Safety Requirements for Electrical Equipment for Measurement, Control and Laboratory Use and has been supplied in a safe condition. This instruction documentation contains information and warnings which must be followed by the user to ensure safe operation and to maintain the product in a safe condition.

#### SAFETY EARTH GROUND

A uninterruptible safety earth ground must be provided from the main power source to the product input wiring terminals, power cord, or supplied power cord set.

#### CHASSIS GROUND TERMINAL

To prevent a potential shock hazard, always connect the rear-panel chassis ground terminal to earth ground when operating this instrument from a dc power source.

#### SAFETY SYMBOLS



Indicates instrument damage can occur if indicated operating limits are exceeded. Refer to the instructions in this guide.



Indicates hazardous voltages.



Indicates earth (ground) terminal

#### **WARNING**

A WARNING note denotes a hazard. It calls attention to a procedure, practice, or the like, which, if not correctly performed or adhered to, could result in personal injury. Do not proceed beyond a WARNING sign until the indicated conditions are fully understood and met.

#### **CAUTION**

A CAUTION note denotes a hazard. It calls attention to an operation procedure, practice, or the like, which, if not correctly performed or adhered to, could result in damage to or destruction of part or all of the product. Do not proceed beyond an CAUTION note until the indicated conditions are fully understood and met.

## **Safety Considerations for this Instrument**

#### **WARNING**

Whenever it is likely that the protection has been impaired, the instrument must be made inoperative and be secured against any unintended operation.

If this instrument is to be energized via an autotransformer (for voltage reduction), make sure the common terminal is connected to the earth terminal of the power source.

If this product is not used as specified, the protection provided by the equipment could be impaired. This product must be used in a normal condition (in which all means for protection are intact) only.

No operator serviceable parts in this product. Refer servicing to qualified personnel. To prevent electrical shock, do not remove covers.

Servicing instructions are for use by qualified personnel only. To avoid electrical shock, do not perform any servicing unless you are qualified to do so.

The opening of covers or removal of parts is likely to expose dangerous voltages. Disconnect the product from all voltage sources while it is being opened.

Adjustments described in the manual are performed with power supplied to the instrument while protective covers are removed. Energy available at many points may, if contacted, result in personal injury.

For Continued protection against fire hazard, replace the line fuse(s) with T 250 V 5.0 A fuse(s) or the same current rating and type. Do not use repaired fuses or short circuited fuseholders.

#### WARNING



This product is a Safety Class I instrument (provided with a protective earthing ground incorporated in the power cord). The mains plug shall only be inserted in a socket outlet provided with a protective earth contact. Any interruption of the protective conductor inside or outside of the product is likely to make the product dangerous. Intentional interruption is prohibited.

#### **WARNING**

Always use the three-prong ac power cord supplied with this product. Failure to ensure adequate earth grounding by not using this cord may cause personal injury and/or product damage.

This product is designed for use in Installation Category II and Pollution Degree 3 per IEC 61010 and IEC 60664 respectively.

This product has autoranging line voltage input, be sure the supply voltage is within the specified range.

To prevent electrical shock, disconnect instrument from mains (line) before cleaning. Use a dry cloth or one slightly dampened with water to clean the external case parts. Do not attempt to clean internally.

Ventilation Requirements: When installing the product in a cabinet, the convection into and out of the product must not be restricted. The ambient temperature (outside the cabinet) must be less than the maximum operating temperature of the product by 4° C for every 100 watts dissipated in the cabinet. If the total power dissipated in the cabinet is greater than 800 watts, then forced convection must be used.

#### WARNING

#### RUBIDIUM REFERENCE ASSEMBLY

The optional Rubidium Reference assembly of the Test Set contains the radioactive isotope Rubidium 87. This assembly contains no user serviceable parts. <u>DO NOT</u> attempt to repair it. There is no measurable external radiation. This assembly does not present a safety hazard. This assembly is regulated as a hazardous waste and must be disposed of in accordance with local, state, and federal regulations. For important shipping information, see

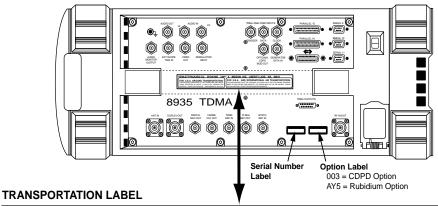
#### FOR GROUND TRANSPORTATION IN THE U.S.A:

This package conforms to the conditions and limitations specified in 49CFR 173.424 for radioactive material, excepted package – instruments, UN2910.

#### FOR AIR TRANSPORTATION IN THE U.S.A. AND INTERNATIONAL:

This instrument must be shipped as cargo with the following endorsement in the nature and quantity of goods box on the air waybill, "Radioactive material, excepted package – instruments."

Figure 1-1 Rubidium Transportation Labels



HEWLETT-PACKARD CO. SPOKANE 24001 E. MISSION AVE. LIBERTY LAKE, WA. 99019

FOR U.S.A. GROUND TRANSPORTATION: THIS PACKAGE CONFORMS TO THE CONDITIONS AND LIMITATIONS SPECIFIED IN 49CF 173.424 FOR "RADIOACTIVE MATERIAL, EXCEPTED PACKAGE - INSTRUMENTS, UN 2910"

FOR U.S.A. AND INTERNATIONAL AIR TRANSPORTATION: THIS INSTRUMENT MUST BE SHIPPING AS CARGO WITH THE FOLLOWING ENDORSE-MENT IN THE NATURE AND QUANTITY OF GOODS BOX ON THE AIR WAYBILL "RADIO-ACTIVE MATERIAL, EXCEPTED PACKAGE-INSTRUMENTS"

#### **WARNING**

The optional Rubidium Reference assembly (OPTION AY5) contains the radioactive isotope Rubidium 87. For Test Sets with this option, there are strict transportation requirements. See transportation label on Test Set. Fines and penalties can results if the directions on the label are not followed.

If the Test Set is upgraded with this option, you must place the transportation label on the Test Set. Failure to do so can result in fines and penalties.

If the rubidium assembly is permanently removed from the Test Set, the transportation label must also be removed. Failure to remove the label when the rubidium assembly is removed can also result in fines and penalties.

labels.eps

# **Product Markings**



The CE mark shows that the product complies with all relevant European legal Directives (if accompanied by a year, it signifies when the design was proven).



The CSA mark is a registered trademark of the Canadian Standards Association.

## Certification

Agilent Technologies certifies that this product met its published specifications at the time of shipment from the factory. Agilent further certifies that its calibration measurements are traceable to the United States National Institute of Standards and Technology, to the extent allowed by the Institute's calibration facility, and to the calibration facilities of other International Standards Organization members.

#### **DECLARATION OF CONFORMITY**

According to ISO/IEC Guide 22 and CEN/CENELEC EN45014

Manufacturer's Name: Agilent Technologies UK Limited

Manufacturer's Address: Electronic Products Solutions Group - Queensferry

South Queensferry West Lothian, EH30 9TG Scotland, United Kingdom

Declares that the product

**Product Name:** TDMA PCS Base Station Test Set

Model Number: E6381A

**Product Options:** This declaration covers all options of the above product as

detailed in TCF A-5951-9852-02.

EMC:

Conforms with the protection requirements of European Council Directive 89/336/EEC on the approximation of the laws of the member states relating to electromagnetic compatibility, against EMC test specifications EN 55011:1991 (Group 1, Class A) and EN 50082-1:1992.

As Detailed in: Electromagnetic Compatibility (EMC)

Technical Construction File (TCF) No. A-5951-9852-02.

Assessed by: DTI Appointed Competent Body

EMC Test Centre,

GEC-Marconi Avionics Ltd.,

Maxwell Building,

Donibristle Industrial Park,

Hillend, Dunfermline KY11 9LB

Scotland, United Kingdom

Technical Report Number:6893/2201/CBR, dated 23 September 1997

Safety:

The product conforms to the following safety standards:

IEC 61010-1(1990) +A1(1992) +A2(1995) / EN 61010-1:1993

IEC 60825-1(1993) / EN 60825-1:1994 Canada / CSA-C22.2 No. 1010.1-93

The product herewith complies with the requirements of the Low Voltage Directive 73/23/EEC, and carries the CE mark accordingly

South Queensferry, Scotland. 1<sup>st</sup> November 2000

RM Erm

R.M. Evans / Manufacturing Engineering Manager

For further information, please contact your local Agilent Technologies sales office, agent, or distributor.

# **Agilent Technologies Warranty Statement for Commercial Products**

E6381A TDMA/Cellular PCS Base Station Test Set

Duration of Warranty: 1 Year

- 1. Agilent warrants Agilent hardware, accessories and supplies against defects in materials and workmanship for the period specified above. If Agilent receives notice of such defects during the warranty period, Agilent will, at its option, either repair or replace products which prove to be defective. Replacement products may be either new or like-new.
- 2. Agilent warrants that Agilent software will not fail to execute its programming instructions, for the period specified above, due to defects in material and workmanship when properly installed and used. If Agilent receives notice of such defects during the warranty period, Agilent will replace software media which does not execute its programming instructions due to such defects.
- 3. Agilent does not warrant that the operation of Agilent products will be uninterrupted or error free. If Agilent is unable, within a reasonable time, to repair or replace any product to a condition as warranted, customer will be entitled to a refund of the purchase price upon prompt return of the product.
- 4. Agilent products may contain remanufactured parts equivalent to new in performance or may have been subject to incidental use.
- 5. The warranty period begins on the date of delivery or on the date of installation if installed by Agilent. If customer schedules or delays Agilent installation more than 30 days after delivery, warranty begins on the 31st day from delivery.
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# **Assistance**

Product maintenance agreements and other customer assistance agreements are available for Agilent Technologies products. For any assistance, contact your nearest Agilent Technologies Sales and Service Office.

Table 1-1 Regional Sales and Service Office s

| United States of America: Agilent Technologies Test and Measurement Call Center P.O. Box 4026 Englewood, CO 80155-4026 (tel) 1 800 452 4844                              | Canada: Agilent Technologies Canada Inc. 5150 Spectrum Way Mississauga, Ontario L4W 5G1 (tel) 1 877 894 4414   | Europe: Agilent Technologies European Marketing Organization P.O. Box 999 1180 AZ Amstelveen The Netherlands (tel) (3120) 547 9999  |
|--|--|---|
| Japan: Agilent Technologies Japan Ltd. Measurement Assistance Center 9-1 Takakura-Cho, Hachioji-Shi, Tokyo 192-8510, Japan (tel) (81) 456-56-7832 (fax) (81) 426-56-7840 | Latin America: Agilent Technologies Latin America Region Headquarters 5200 Blue Lagoon Drive, Suite #950 Miami, Florida 33126 U.S. A.  (tel) (305) 267 4245 (fax) (305) 267 4286 | Australia/New Zealand: Agilent Technologies Australia Pty Ltd. 347 Burwood Highway Forest Hill, Victoria 3131  (tel) 1 800 629 485 (Australia) (fax) (61 3) 9272 0749 (tel) 0 800 738 378 (New Zealand) (fax) (64 4) 802 6881 |
| Asia Pacific: Agilent Technologies 24/F, Cityplaza One, 111 Kings Road, Taikoo Shing, Hong Kong (tel) (852) 3197 7777 (fax) (852) 2506 9233                              |  |   |

### **Power Cables**

#### Table 1-2 Power Cables

| Plug Type                  | Plug Descriptions male/female | Agilent Part #<br>(cable & plug) | Cable Descriptions   |
|----------------------------|-------------------------------|----------------------------------|----------------------|
| Earth Ground  Line Neutral | Straight/Straight             | 8120-1689                        | 79 inches, mint gray |
|                            | Straight/90°                  | 8120-1692                        | 79 inches, mint gray |

Used in the following locations

Afghanistan, Albania, Algeria, Angola, Armenia, Austria, Azerbaijan, Azores

Bangladesh, Belgium, Benin, Bolivia, Boznia-Herzegovina, Bulgaria, Burkina Faso, Burma, Burundi, Byelarus

Cameroon, Canary Islands, Central AfricanRepublic, Chad, Chile, Comoros, Congo, Croatia, Czech Republic, Czechoslovakia

Denmark, Djibouti

East Germany, Egypt, Estonia, Ethiopia

Finland, France, French Guiana, French Indian Ocean Areas

Gabon, Gaza Strip, Georgia, Germany, Gozo, Greece

Hungary

Iceland, Indonesia, Iran, Iraq, Israel, Italy, Ivory Coast

Jordan

Kazakhstan, Korea, Kyrgystan

Latvia, Lebanon, Libya, Lithuania, Luxembourg

Macedonia, Madeira Islands, Malagasy Republic, Mali, Malta, Mauritania, Miquelon, Moldova, Mongolia, Morocco, Mozambique

Nepal, Netherlands, Netherlands Antilles, Niger, Norway

Oman

Pakistan, Paraguay, Poland, Portugal

Rep. South Africa, Romania, Russia, Rwanda

Saudi Arabia (220V), Senegal, Slovak Republic, Slovenia, Somalia, Spain, Spanish Africa, Sri Lanka, St.Pierce Islands

Table 1-2 Power Cables

| Plug Type                  | Plug Descriptions male/female | Agilent Part #<br>(cable & plug) | Cable Descriptions   |
|----------------------------|-------------------------------|----------------------------------|----------------------|
| Earth Ground  Line Neutral | Straight/Straight             | 8120-1689                        | 79 inches, mint gray |
|                            | Straight/90°                  | 8120-1692                        | 79 inches, mint gray |

Sweden, Syria

Tajikistan, Thailand, Togo, Tunisia, Turkey, Turkmenistan

USSR, Ukraine, Uzbekistan

Western Africa, Western Sahara

Yugoslavia

Zaire

Table 1-3 Power Cables

| Plug Type                       | Plug<br>Descriptions<br>male/female | Agilent Part<br>#<br>(cable & plug) | Cable Descriptions |  |  |  |
|---------------------------------|-------------------------------------|-------------------------------------|--------------------|--|--|--|
| Earth Ground Line               | Straight/Straight                   | 8120-0698                           | 90 inches, black   |  |  |  |
| Used in the following locations |                                     |                                     |                    |  |  |  |

Used in the following locations

Peru

#### Table 1-4 Power Cables

| Plug Type                       | Plug<br>Descriptions<br>male/female | Agilent Part #<br>(cable & plug) | Cable Descriptions                 |  |  |  |
|---------------------------------|-------------------------------------|----------------------------------|------------------------------------|--|--|--|
| Line Neutral                    | Straight/Straight<br>Straight/90°   | 8120-2104<br>8120-2296           | 79 inches, gray<br>79 inches, gray |  |  |  |
| Used in the following locations |                                     |                                  |                                    |  |  |  |

#### Table 1-4 Power Cables

| Plug Type   | Plug<br>Descriptions<br>male/female | Agilent Part #<br>(cable & plug) | Cable Descriptions |
|-------------|-------------------------------------|----------------------------------|--------------------|
| Switzerland |                                     |                                  |                    |

#### Table 1-5 Power Cables

| Plug Type                      | Plug<br>Descriptions<br>male/female | Agilent Part<br>#<br>(cable &<br>plug) | Cable Descriptions   |
|--------------------------------|-------------------------------------|--|----------------------|
| 125V Earth Ground Neutral Line | Straight/Straight                   | 8120-1378                              | 90 inches, jade gray |
|                                | Straight/90                         | 8120-1521                              | 90 inches, jade gray |
|                                | Straight/Straight                   | 8120-1751                              | 90 inches, jade gray |

Used in the following locations

American Samoa

Bahamas, Barbados, Belize, Bermuda, Brazil,

Caicos, Cambodia, Canada, Cayman Islands, Columbia, Costa Rica, Cuba

Dominican Republic

Ecuador, El Salvador

French West Indies

Guam, Guatemala, Guyana

Haiti, Honduras

Jamaica

Korea

Laos, Leeward and Windward Is., Liberia

Mexico, Midway Islands

Nicaragua

Other Pacific Islands

Panama, Philippines, Puerto Rico

Saudi Arabia (115V,127V), Suriname

## **Table 1-5 Power Cables**

| Plug Type  | Plug<br>Descriptions<br>male/female | Agilent Part<br>#<br>(cable &<br>plug) | Cable Descriptions |
|--|-------------------------------------|--|--------------------|
| Taiwan, Tobago, Trinidad, Trust Territories of Pacific Islands |                                     |  |                    |
| Turks Island   |                                     |  |                    |
| United States  |                                     |  |                    |
| Venezuela, Vietnam, Virgin Islands of the US                   |                                     |  |                    |
| Wake Island  |                                     |  |                    |

## **Table 1-6** Power Cables

| Plug Type                                      | Plug<br>Descriptions<br>male/female | Agilent Part #<br>(cable & plug) | Cable<br>Descriptions                        |
|--|-------------------------------------|----------------------------------|--|
| JIS C 8303, 100 V  Earth Ground  Neutral  Line | Straight/Straight<br>Straight/90°   | 8120-4753<br>8120-4754           | 90 inches, dark gray<br>90 inches, dark gray |
| Used in the following locations                |                                     |                                  |  |

## **Table 1-7 Power Cables**

Japan

| Plug Type                    | Plug<br>Descriptions<br>male/female          | Agilent Part #<br>(cable & plug)    | Cable<br>Descriptions                                 |
|------------------------------|--|-------------------------------------|---|
| Earth Groun Neutral Line     | 90°/STRAIGHT<br>90°/90°<br>Straight/Straight | 8120-2956<br>8120-2957<br>8120-3997 | 79 inches, gray<br>79 inches, gray<br>79 inches, gray |
| Used in the following locat: | ions   |                                     |   |
| Denmark                      |  |                                     |   |
| Greenland                    |  |                                     |   |

**Table 1-8** Power Cables

| Plug Type                       | Plug Descriptions male/female          | Agilent Part #<br>(cable & plug) | Cable Descriptions                           |
|---------------------------------|--|----------------------------------|--|
| Line Earth Ground Neutral       | Straight/Straight<br>Straight/90°      | 8120-4211<br>8120-4600           | 79 inches, mint gray<br>79 inches, mint gray |
| Used in the following locations |  |                                  |  |
| Botswana                        |  |                                  |  |
| India                           | India                                  |                                  |  |
| Lesotho                         |  |                                  |  |
| Malawi                          |  |                                  |  |
| South-West Africa (Nar          | South-West Africa (Namibia), Swaziland |                                  |  |
| Zambia, Zimbabwe                |  |                                  |  |

Table 1-9 Power Cables

| Plug Type (Male)                | Plug<br>Descriptions<br>male/female      | Agilent Part #<br>(cable & plug) | Cable Descriptions                           |  |
|---------------------------------|--|----------------------------------|--|--|
| Earth Ground                    | 90°/Straight<br>90°/90°                  | 8120-1351<br>8120-1703           | 90 inches, mint gray<br>90 inches, mint gray |  |
| Line Neutra                     | 1  |                                  |  |  |
| Used in the following locations |  |                                  |  |  |
| Bahrain, British Indian         | Ocean Terr., Brunei                      |                                  |  |  |
| Canton, Cyprus                  | Canton, Cyprus                           |                                  |  |  |
| Enderbury Island, Equa          | Enderbury Island, Equatorial Guinea      |                                  |  |  |
| Falkland Islands, Frenc         | Falkland Islands, French Pacific Islands |                                  |  |  |
| Gambia, Ghana, Gibralt          | Gambia, Ghana, Gibraltar, Guinea         |                                  |  |  |
| Hong Kong                       |  |                                  |  |  |
| Ireland                         |  |                                  |  |  |
| Kenya, Kuwait                   | Kenya, Kuwait                            |                                  |  |  |
| Macao, Malaysia, Mauritius      |  |                                  |  |  |
|                                 |  |                                  |  |  |

#### **Power Cables** Table 1-9

| Plug Type (Male)  | Plug<br>Descriptions<br>male/female | Agilent Part #<br>(cable & plug) | Cable Descriptions |  |
|---|-------------------------------------|----------------------------------|--------------------|--|
| Nigeria   |                                     |                                  |                    |  |
| Qatar   | Qatar                               |                                  |                    |  |
| Seychelles, Sierra Leone, Singapore, Southern Asia, Southern Pacific Islands, St. Helena, Sudan |                                     |                                  |                    |  |
| Tanzania  |                                     |                                  |                    |  |
| Uganda, United Arab Emirates, United Kingdom  |                                     |                                  |                    |  |
| Yeman (Aden & Sana)   |                                     |                                  |                    |  |

#### **Table 1-10 Power Cables**

| Plug Type                  | Plug<br>Descriptions<br>male/female | Agilent Part #<br>(cable & plug) | Cable<br>Descriptions              |
|----------------------------|-------------------------------------|----------------------------------|------------------------------------|
| Earth Ground  Line Neutral | Straight/Straight<br>Straight/90°   | 8120-1369<br>8120-0696           | 79 inches, gray<br>80 inches, gray |
| Used in the following loc  | ations                              |                                  |                                    |
| Argentina Australia        |                                     |                                  |                                    |

Argentina, Australia

China (People's Republic)

New Zealand

Papua New Guinea

Uruguay

Western Samoa

**Table 1-11 Power Cables** 

| Plug Type                       | Plug<br>Descriptions<br>male/female                    | Agilent Part #<br>(cable & plug)                 | Cable Descriptions   |
|---------------------------------|--|--|--|
| Earth Ground Line Neutral       | Straight/Straight<br>Straight/Straight<br>Straight/90° | 8120-1860<br>8120-1575<br>8120-2191<br>8120-4379 | 60 inches, jade gray<br>30 inches, jade gray<br>60 inches, jade gray<br>15.5 inches, jade gray |
| Used in the following locations |  |  |  |
| System Cabinets                 |  |  |  |



**ATTENTION** 

Static Sensitive Devices

This instrument was constructed in an ESD (electro-static discharge) protected environment. This is because most of the semiconductor devices used in this instrument are susceptible to damage by static discharge.

Depending on the magnitude of the charge, device substrates can be punctured or destroyed by contact or mere proximity of a static charge. The result can cause degradation of device performance, early failure, or immediate destruction.

These charges are generated in numerous ways such as simple contact, separation of materials, and normal motions of persons working with static sensitive devices.

When handling or servicing equipment containing static sensitive devices, adequate precautions must be taken to prevent device damage or destruction.

Only those who are thoroughly familiar with industry accepted techniques for handling static sensitive devices should attempt to service circuitry with these devices.

## **Documentation**

#### **Conventions Used in This Manual**

The following conventions are used throughout this manual to help clarify instructions and reduce unnecessary text:

- "Test Set" refers to the Agilent Technologies 8935 Series E6381A TDMA Base Station Test Set.
- Test Set keys are indicated like this: Preset
- Test Set screen information, such as a measurement result or an error message, is shown like this: TX Channel Power -1.3 dBm

**NOTE** 

HP-IB and GPIB are one and the same.

#### What is in This Manual

Chapter 1, "General Information," on page 11

This chapter contains generic information about the product, safety, warranty, sales and sercvice offices, power-cables, and other information.

Chapter 2, "Product Information," on page 35

This chapter contains general information about the Test Set and how to service it.

Chapter 3, "Troubleshooting," on page 47

This chapter explains how to isolate a problem to the defective assembly. Troubleshooting uses the Test Set's built-in diagnostics. If diagnostics can't identify the faulty assembly, supplementary information in the form of manual troubleshooting procedures is provided.

Chapter 4, "Preventative Maintenance," on page 95

This chapter describes the preventative maintenance procedures recommended for the Test Set.

Chapter 5, "Disassembly," on pag e101

This chapter explains how to disassemble the Test Set for major assembly replacement.

Chapter 6, "Replaceable Parts," on pag e135

This chapter contains the replaceable assembly and component information for the Test Set. Use the illustrations in this chapter to identify the replaceable parts and See "Parts List" on page 153 for part numbers.

#### Chapter 7, "Periodic Adjustments," on page159

This chapter contains the periodic adjustment procedures for the Test Set.

#### Chapter 8, "Performance Tests," on page 173

This chapter contains the performance test procedures for the Test Set. The tests in this chapter verify that the Test Set performs to it's published specifications.

#### Chapter 9, "Performance Test Records," on page 223

Use this chapter to record the results of the performance tests in Chapter 8, "Performance Tests," on page 173

#### Chapter 10, "Block Diagrams," on page 273

This chapter contains block diagrams and descriptions that focus on how the Test Set generates signals and makes measurements. It also has I/O signal information that can be used to help isolate a problem to the assembly level if the Test Set's diagnostic programs.

## Which Document is Required?

The following documents are part of the Agilent Technologies 8935 document set. Use the table to help you decide which document you need.

Table 1-12 Document Navigation

| Document                                     | Part Number | Usage   |
|--|-------------|---|
| Technical Specifications<br>Publication      | 5966-3732EE | Test Set's specifications data sheet  |
| GPIB Syntax                                  | E6381-90014 | GPIB guide  |
| Assembly Level Repair<br>Guide (this manual) | E6381-90015 | Use this manual to perform calibration on the Test Set and for general service information.   |
| AMPS Application Guide                       | E6381-90017 | Use this manual for making AMPS base station measurements.  |
| Programmer's Guide                           | E6380-90018 | Use this manual to learn how to write programs for the Test Set.  |
| Reference Guide                              | E6381-90019 | Use this manual for general information on accessing and changing settings, general Test Set operation, connector descriptions, and error messages. It also contains information on loading and running the various automated test routines (RF Tools) built in the Test Set. |
| CD-ROM Disk                                  | E6381-90020 | This disk contains all or most of the above mentioned manuals.  |

## **Trademark Acknowledgments**

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ProComm, is a registered trademark of DataStorm Technologies, Inc.

HyperTerminal© is a registered trademark of Hilgraeve, Incorporated.

Pentium® is a registered trademark of Intel Corporation.

# 2 Product Information

This chapter contains general information about the Test Set and how to service it.

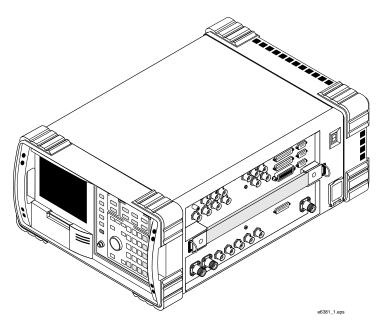
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## **Instrument Description**

The Agilent Technologies 8935 Series E6381A TDMA Base Station Test Set is a one-box tool designed to meet the needs of installation teams, service providers, and network manufacturers when installing, testing, and maintaining TDMA base stations at both the cellular and PCS frequency bands. It also can be used to test AMPS base stations. Features include:

- · Analog and digital (TDMA) capabilities
- · Waveform quality EVM, frequency, timing, and phase analysis
- Automation software to increase measurement repeatability
- · Optional CDPD (Cellular Digital Packet Data) capability
- Firmware upgradeable via PCMCIA to flash memory

Figure 2-1 The Agilent Technologies 8935 Series E6381A TDMA Base Station Test Set



This Test Set utilizes a bright electroluminescent display for reading data. All connectors are recessed and mounted on one side allowing unobstructed, out-of-the-way hook up. Its rugged design includes a hand strap for portability, a membrane keypad, gasketed display, stand up operation, filtered airflow, and a rugged exterior to help protect the Test Set from bumps and shocks.

The user interface features pull down menus, one-key measurement execution, and fast measurement speed. Measurement data can be output to a printer or a PCMCIA memory card.

The Test Set's firmware is user upgradeable from the front panel (PCMCIA

memory card to internal flash memory). Thus, new features and capabilities can be added without returning the unit to the service center.

The Test Set contains a TDMA signal generator and a frequency translator which allow generation of TDMA signals at both cellular and PCS frequencies. TDMA tools include:

- Digital Analyzer
- · Digital Generator
- Power Meter (peak and average)

Other test tools include:

- Spectrum Analyzer
- Oscilloscope
- AMPS Analyzer
- AC/DC Voltmeter
- · AF and RF Generators
- Signaling Encoder and Decoder
- Built-in IBASIC Controller

For documentation on this Test Set, see "Which Document is Required?" on page 33.

#### CDPD, Option 003

This option supports Cellular Digital Packet Data (CDPD) digital signal generation and analysis. CDPD is a packet data system which overlays the existing Advanced Mobile Phone System (AMPS) voice system. CDPD is designed for small bursts of data and is not efficient for large file transfer applications.

CDPD uses a separate base station (Mobile Data Base Station, MDBS) and is integrated into the antenna system of a cell site. When there is no voice traffic on a designated AMPS voice channel, the MDBS may transmit packet data to mobile or fixed end stations. When AMPS voice traffic is assigned to that channel, the MDBS must power down and reacquire communications on another designated CDPD channel if available.

In the Test Set, the CDPD reference assembly, A2A35, and CDPD directional coupler, A2A135, provide the hardware and firmware for performing CDPD protocol processing.

#### **Rubidium Reference, Option AY5**

This option provides a rubidium oscillator which is used as the internal high stability timebase. The rubidium oscillator has increased frequency accuracy and reduced frequency drift over time than the standard high stability timebase.

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The timebase is used as a reference for all of the RF signals generated by the Test Set. Adjusting a base station's transceivers using this timebase can minimize frequency errors. If this error is too large some mobile phones may not be able to synchronize with the base station. Also, see "RUBIDIUM REFERENCE ASSEMBLY" on page 16 for important information regarding this option.

### **Instrument Assemblies**

Table 2-1 describes the major assemblies of the Agilent Technologies 8935 TDMA Cellular/PCS Base Station Test Set. Figure 2-2 on page 40 is a block diagram overview of the Test Set.

Table 2-1

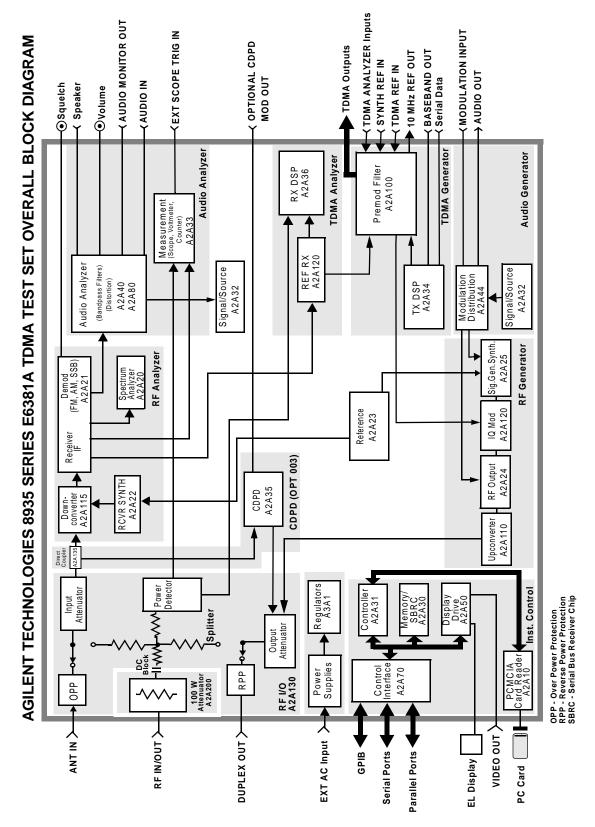
| Reference<br>Designator | Assembly Name (Abbreviated Name)           | Function or Description  |
|-------------------------|--|--|
| A1                      | Front Panel                                | Contains display and keyboard sub assemblies                     |
| A1A1                    | Display                                    | Display screen   |
| A1A2                    | Keypad w/Frame                             | Keypad with frame  |
| A1A3                    | RPG Assembly                               | Interface for front-panel-knob rotary pulse generator            |
| A2A1                    | Motherboard                                | Provides connection and interface for assemblies                 |
| A2A10                   | PCMCIA Card Reader                         | Controller for PCMCIA card reader                                |
| A2A15                   | Rubidium Reference                         | OPTION AY5 only - optional precision timebase                    |
| A2A20                   | Spectrum Analyzer                          | Spectrum analyzer for signal analysis                            |
| A2A21                   | Receiver (RCVR)                            | IF filtering and demodulation                                    |
| A2A22                   | Receiver Synthesizer<br>(RCVR SYNTH)       | Supplies local oscillator (LO) signal for IF creation            |
| A2A23                   | High Stability Reference                   | Standard high stability timebase                                 |
| A2A24                   | RF Output                                  | Amplifies and conditions output signal of instrument             |
| A2A25                   | Signal Generator Synthesizer               | Provides CW signal for RF generator                              |
| A2A30                   | Memory/SBRC                                | Test Set's RAM and gated bus control                             |
| A2A31                   | Controller                                 | Provides overall instrument control                              |
| A2A32                   | Signaling/Source                           | Source for the RF generator and AF generator and analyzer system |
| A2A33                   | Measurement                                | Provides oscilloscope, voltmeter, and counter functions          |
| A2A34                   | Transmit Digital Signal Processor (TX DSP) | Generates digital signal for output signal and TDMA generator    |

Table 2-1

| Reference<br>Designator | Assembly Name (Abbreviated Name)                    | Function or Description  |
|-------------------------|---|--|
| A2A35                   | CDPD  | Option 003 only - CDPD reference   |
| A2A36                   | Receive Digital Signal Processor<br>(RX DSP)        | Digital signal processing for the TDMA and CDPD Analyzers  |
| A2A40                   | Audio Analyzer 2                                    | Provides audio distortion analysis   |
| A2A44                   | Modulation Distribution                             | Source for FM generator  |
| A2A50                   | Display Drive                                       | Controls display screen  |
| A2A70                   | Control Interface                                   | Interface assembly for side-panel GPIB, parallel, and serial ports   |
| A2A80                   | Audio Analyzer 1                                    | Provides audio filtering   |
| A2A80A1                 | C-Message Filter                                    | Audio filter   |
| A2A80A2                 | 6 kHz Bandpass Filter                               | Audio filter   |
| A2A100                  | Premodulation Filter (Premod Filter)                | TDMA data generation and instrument reference master (with external reference)   |
| A2A110                  | Upconverter   | Converts output signal to PCS frequencies  |
| A2A115                  | Downconverter                                       | Converts input frequencies to instrument level IF  |
| A2A120                  | Reference Receiver/ IQ Modulator<br>(REF RX/IQ MOD) | Receive-path IF downconversion and generator-path IQ modulation  |
| A2A130                  | RF Input/Output (RF I/O)                            | RF input and output is directed through one assembly   |
| A2A135                  | CDPD Directional Coupler                            | Option 003 only - couples CDPD signal to CDPD module   |
| A2A200                  | 100W Attenuator                                     | Provides high-power RF attenuation   |
| A2U1                    | DC Block Assembly                                   | Standard AC Coupled feature on the RF Input /<br>Output connector. Test sets with a serial prefix<br>greater than GB4005xxxx include this feature and<br>can be recognized by the AC Coupled label by the RF<br>IN/Out connector |
| A3                      | Power Supply Assembly                               | Contains power supply, regulator, and fan assemblies   |
| A3A1                    | Power Supply Regulator                              | Regulates the power supply output voltages   |

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Figure 2-2 Overall Block Diagram



# **Upgrades**

#### **Hardware and Firmware Enhancements**

The hardware and firmware for this Test Set are being enhanced on a continuous basis. Hardware can be upgraded by ordering specific retrofit kits. Firmware is upgraded by downloading new firmware on PCMCIA memory cards onto flash ROMs located on the Controller assembly. The firmware for this Test Set has gone through several revisions to improve performance and fix problems.

It is recommended that the firmware be upgraded to the latest revision whenever the Test Set is repaired or a performance problem is found. This is important, especially if an assembly-level repair is performed by the exchange of assemblies. The replacement assemblies may require a later revision of the firmware for the assembly or Test Set to function correctly.

When downloading new firmware, a program is used that downloads the new firmware files from a PC memory card to the instrument. Table 2-2 and table 2-3 list the upgrade kits available. For ordering information, see "Service Information" on page 45.

Table 2-2 Firmware Upgrade Kits

| Kit         | Description   |
|-------------|---|
| E6381A R58  | Agilent Technologies 8935 Series E6381A<br>TDMA Base StationTest Set Firmware (for<br>customer/non-Agilent support personnel) |
| E6381-61858 | Agilent Technologies 8935 Series E6381A<br>TDMA Base StationTest Set Firmware (for<br>Agilent Technologies support personnel) |

Table 2-3 Hardware Upgrade Kits

| Kit  | Description   |
|--|---|
| Agilent 8935 RD5 E6381A RD5 E6381ART R20 E6381ART R23 E6381ART R2K | <ul> <li>Rubidium Timebase. Contact factory at 1-800-827-3848. Installation may require return to the factory</li> <li>DC BLOCK</li> <li>SIDE IMPACT</li> <li>CDMA_2000</li> <li>.</li> </ul> |
| E6381A 003   | CDPD Capability. Contact factory at 1-800-827-3848. Installation may require return to the factory.   |

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Table 2-3 Hardware Upgrade Kits

| Kit              | Description             |
|------------------|-------------------------|
| Agilent 8935 RD5 | High Stability Timebase |
| E6380A RD5       | DC Block                |
| E6380ART R20     | Side Impact             |
| E6380ART R23     | • CDMA 2000             |
| E6380ART R2K     | _                       |

### **Loading the Host or DSP Firmware**

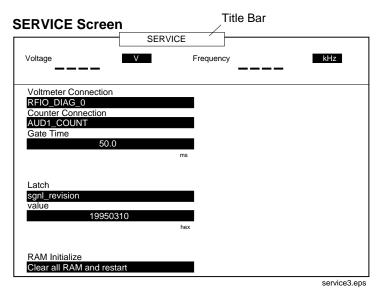
Follow the installation instructions supplied with the firmware upgrade kit.

### **Checking Firmware Version**

The following procedure checks the current version of firmware in the Test Set.

- 1. Power on the Test Set.
- 2. Press the **Inst Config** key. The host firmware revision appears in the upper right corner of this screen.
- 3. To find the Receive (RX) DSP firmware revision level, select the title bar of the INSTRUMENT CONFIGURE screen. A drop down menu appears.
- 4. Select SERVICE. See figure 2-3.

Figure 2-3 SERVICE Screen



5. Select the Latch field.

6. Move the cursor to rx\_dsp\_revision under the Choices: menu and press

the knob.

7. The Value data field contains the RX DSP firmware revision date in the format YYYYMMDD (Y=year, M=month, D=day).

Chapter 2 43

# **Repair Process**

Repairing the Test Set consists of the following steps:

- 1. Isolate the problem to a faulty assembly within the Test Set. Refer to the Chapter 3, "Troubleshooting" on page 47.
- 2. Replace the faulty assembly.
- 3. Calibrate the Test System by regenerating calibration data, see Chapter 7, "Periodic Adjustments" on page 159.
- 4. Verify the performance of the Test Set, see Chapter 8, "Performance Tests" on page 173.

# **Lifting and Handling**

When lifting and handling the Agilent 8935 CDMA Cellular/PCS Base Station Test Set use ergonomically correct procedures. Lift and carry by the strap on the side panel.

When moving the Test Set more than a few feet, be sure to replace the front screen cover.

### **Consumables**

Two AA alkalyne batteries are supplied with the Test Set and must be replaced periodically. When replacing batteries always dispose of old batteries in a conscientious manner, following manufacturer's instructions.

# **Service Information**

## **Factory Support**

Troubleshooting assistance is available by e-mail (electronic mail), website, or telephone:

- Internet e-mail address spokane\_service@agilent.com
- Agilent Support Website
   Use the URL: http://www.agilent.com, select Products & Services,
   then select Test & Measurement and finally select Technical Support. A
   wide range of documentation, hardware drivers and support information is
   available, including a part number search engine.
- U.S.A. and Canada only, M-F 8am -5 pm PST, toll free800-827-3848
- Outside North America, M-F 8 am 5 pm PST, phone509-921-3848
- Application Support, M-F 8 am -5 pm PST, phone800-922-8920

# **Ordering Parts**

To order parts, call Agilent Global Support Logistics (GSL):

- U.S.A only, Agilent Direct Parts Ordering, phone877-447-7278
- U.S.A and international, Agilent Service Parts Identification, phone877-447-7278

# Repair and Calibration/ Instrument Support Center

USA only, 800-403-0801

### **Test & Measurement Call Center**

USA only, 800-452-4844

Chapter 2 45

# 3 Troubleshooting

This chapter explains how to isolate a problem to the defective assembly. Troubleshooting uses the Test Set's built-in diagnostics. If diagnostics can't identify the faulty assembly, supplementary information in the form of manual troubleshooting procedures is provided.

### How to Troubleshoot the Test Set

The self-test diagnostic can be run three ways:

- 1. The test runs automatically when the Test Set is turned on. After the Test Set powers up, a message appears at the top of the display. If one or more tests fail, the message reports the failure with a hexadecimal code.
  - During the test, coded failure information is displayed on four LEDs on the top of the Controller (A2A31) assembly, see figure 3-5 on page 53. The Test Set's cover must be removed to view these LEDs. See chapter 3 for disassembly and replacement instructions.
- 2. The test runs when the Test Set receives the query \*TST? over GPIB. The resultant decimal code can be read over the bus.
- 3. The test runs when Functional Diagnostics are run and the Self Test is selected.

Document the result of each step in case you need to contact Agilent Technologies for service assistance. General troubleshooting steps are illustrated in figure 3-2 on page 50.

#### **NOTE**

Periodic Adjustment Interval

The calibration programs, Periodic Calibration and IQ Calibration, should be performed after the replacement of any assembly referred to in table 7-1 on page 160, or at least every 24 months. See "Periodic Adjustments" on page 160 for details.

On power-up, the Test Set runs the Self-Test Diagnostics. Most of the Test Set's digital control functions are tested. The outcome of the test appears on the display (if operating) and on four LEDs seen through an access hole in the internal cover, see figure 3-1.

Figure 3-1 LEDs

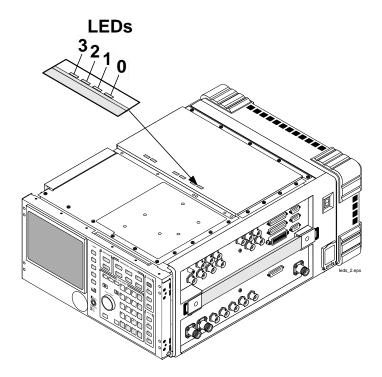
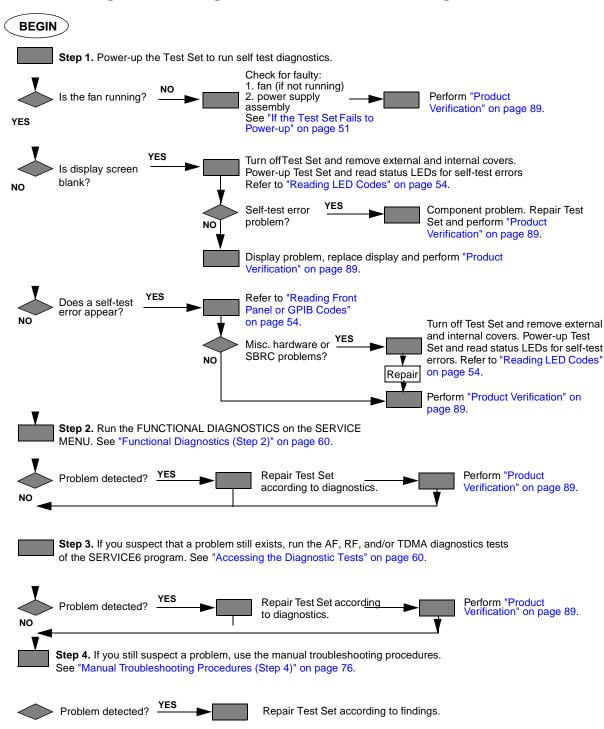


Figure 3-2 Agilent Technologies 8935 Test Set Troubleshooting Flowchart



# **Self-Test Diagnostics (Step 1)**

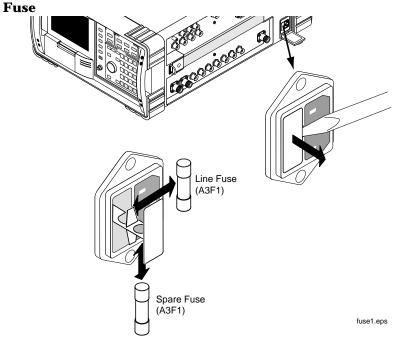
- **Step 1.** Turn on the Test Set to automatically run the self test diagnostics.
  - If the Test Set does not power up, see "If the Test Set Fails to Power-up" on page 51.
  - If all self-test diagnostics pass, and the front-panel keys and knob work, you can assume that the digital control assemblies work.
- **Step 2.** After power-up, the top line of the Test Set's display should show copyright information and the firmware revision code. The second line should display All self tests passed.
  - If the Test Set powers-up with "One or more self-tests failed. Error code:<error code>:", see "Reading Front Panel or GPIB Codes" on page 54.
  - See "Frequently Encountered Diagnostic Messages" on page 75 for other error messages that might appear on the second line of the display.
- **Step 3.** The software menu screen should be displayed. Two conditions cause a different screen to be displayed on power-up:
  - □ A SAVE/RECALL register named POWERON was saved to automatically power-up the Test Set in a different state. Press the **Preset** key before proceeding; this will restore the Test Set to the factory power-up condition.
  - ☐ The Autostart Test Procedure on Power-Up: field (of the TESTS (Execution Conditions) screen) is set to On to automatically run a loaded program. Press the Shift key, then press the Cancel key to stop the program. Press the Preset key to restore the Test Set to the factory power-up condition.

To turn the autostart function off, press the Menu key, then select Execution Cond (under the SET UP TEST SET: heading). The autostart function is at the bottom of the screen; turn it Off.

### If the Test Set Fails to Power-up

**Step 1.** Is the Test Set plugged in? Listen for fan operation. If you don't hear it, check the line fuse (see figure 3-3) and the GFI reset button, see "AA Batteries and Air Filter" on page 99.

Figure 3-3

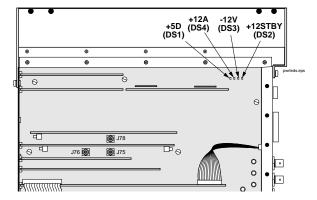


**Step 2.** If there is no image on the display, remove the Test Set's covers and check the power supply LEDs: +5V,

\_

12V, +12V (see figure 3-4). If one is out, the power supply or regulator board is faulty. If no LEDs are lit, confirm that the Test Set is connected to the main power source. (Also, see step 5 of this procedure.)

Figure 3-4 Power Supply LEDs



**Step 3.** Check the LEDs on the A2A31 Controller assembly, see figure 3-5. The LEDs should all light up immediately on power-up, and then go off several seconds after a beep is heard. If the LEDs do not light when the Test Set is powered-up, either the Controller or the Memory/SBRC (A2A30) assembly is faulty.

**Step 4.** If the Test Set does not power-up properly but the fan operates and the power supply voltage outputs are correct on the Power Supply Regulator (A3A1), the Controller

(A2A31) may be failing. Check TP2 on the Controller for +5V. If +5V is present, the Controller assembly is faulty.

**Step 5.** If there is no display and the VIDEO OUT port on the side-panel has the signal shown in figure 3-6, then the A1A1 Display assembly is faulty. If the signal is not present, then the A2A50 Display Drive assembly is faulty.

Figure 3-5 A2A31 Controller LEDs

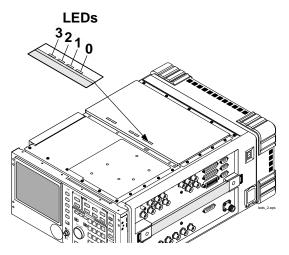
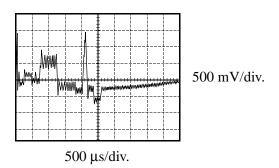


Figure 3-6 VIDEO OUT Signal



### **Reading Front Panel or GPIB Codes**

Failure codes are listed in the table below. If more than one failure occurs, the failure code will be the sum of the individual failure codes. The nature of the failure and the assembly most-likely at fault is also listed.

Table 3-1 Return Values for Self-Test Diagnostic

| Detected Failure             |  | Returned Error Code     |                |
|------------------------------|--|-------------------------|----------------|
| Failed Assembly              |  | Hexadecimal (displayed) | Decimal (GPIB) |
| Microprocessor               | A2A31 Controller                         | 0002                    | 2              |
| ROM                          | A2A31 Controller                         | 0004                    | 4              |
| RAM                          | A2A30 Memory/SBRC                        | 0008                    | 8              |
| RAM                          | A2A30 Memory/SBRC                        | 0010                    | 16             |
| Timer                        | A2A31 Controller                         | 0020                    | 32             |
| Real-Time Clock              | A2A30 Memory/SBRC                        | 0040                    | 64             |
| Keyboard (stuck key)         | A1A2 Keypanel <sup>a</sup>               | 0080                    | 128            |
| RS-232 I/O                   | A2A30 Memory/SBRC                        | 0100                    | 256            |
| Serial Bus<br>Communication  | Any non-optional assembly <sup>b</sup>   | 0200                    | 512            |
| Signaling Board<br>Self-Test | A2A32 Signal/Source                      | 0400                    | 1024           |
| Display Drive<br>Self-Test   | A2A50 Display Drive                      | 0800                    | 2048           |
| Miscellaneous<br>Hardware    | Several Possible Assemblies <sup>c</sup> | 1000                    | 4096           |

- a. Could also be the A2A31 Controller with a faulty key-down detector.
- b. This checks the ability of the Controller to communicate with any hardware on the bus.
- c. This message occurs if expected hardware is absent or not responding to the Controller.

### **Reading LED Codes**

When the self-test diagnostic reports a failure, more information about the failure may be available inside the Test Set. This additional information is output to the four LEDs on the top of the A2A31 Controller assembly. The failure codes are sent out as code sequences. Figure 3-7, "Reading the Self-Test Diagnostic Internal LEDs," on page 56 and the tables following it document some of the more useful code sequences. You may need to run the Self-Test Diagnostic several times to decode a particular LED sequence.

**NOTE** 

The LEDs output self-test diagnostic codes only when the Test Set is powering up. The LEDs remain off when the self-test diagnostic is initiated through programming or when running the functional diagnostics. To read the LED codes, the Test Set's cover must be

#### removed.

If the Test Set has no faults that can be detected by the self test diagnostic, the four LEDs on the Controller assembly will light and remain on for about ten seconds. During that period, a short beep will be heard. Then the LEDs will extinguish and remain off.

If a fault is detected during the test:

- **Step 1.** The four LEDs will go on for about four seconds.
- **Step 2.** The LEDs will blink a failure code which corresponds to the error listed in Table 3-1, on page 54. Figure 3-8, "First LED Patterns," on page 57 shows the blinking LED codes.
- **Step 3.** Two non-blinking LED codes will follow. The interpretation of these codes depends on the preceding blinking code. Two sets of the non-blinking codes are listed: see figure 3-9, "Non-blinking LED Codes For Serial Bus Communication Failure," on page 58 and figure 3-10, "Non-Blinking LED Codes for Miscellaneous Hardware Failure," on page 59.
- **Step 4.** If there is more than one failure, the test will loop back to step 2 and repeat until the last failure is reported.

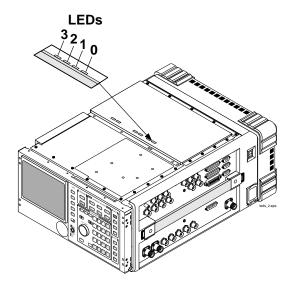
The pattern generated by the LEDs can be interpreted as a binary-weighting code. The LED (labeled 0) is the least-significant bit (see figure 3-7 on page 56). For example if the LEDs blinking pattern is Off, On, On, On (reading left-to-right or LEDs "3 2 1 0"), the binary number is 0111 or decimal 7.

Figure 3-7 Reading the Self-Test Diagnostic Internal LEDs

- 1. Remove the Test Set's external cover.
- 2. Turn on power.
- 3. Read the LED sequence (see illustration on right) and compare it with the patterns below.

#### NOTE

For multiple failures, the failure pattern described below will be shown for each failure detected.



### **LED Sequences**

### No Failures...

The LEDs will light for approximately 10 seconds, then all will turn off.



#### Failures... three patterns are displayed:

The first blinks rapidly and indicates the type of failure.

> 3 2 1 0 ★ • • ★

See the following tables. (This example indicates a serial bus communication problem.)

The second and third patterns blink slowly and indicate failure details.

3 2 1 0 3 2 1 0

(This example indicates a faulty A2A80 Audio Analyzer 1 assembly.)

### Figure 3-8 First LED Patterns

If the first LED pattern displayed is...

Then the failure is...

| ● ● ★ ● ROM Checksum (See note 1.)    ■ = off  ★ = rapid blink   | 3 2 1 0                       |                                      | LED Legend                |
|--|-------------------------------|--------------------------------------|---------------------------|
| RAM (See note 2.)  RAM (See note 3.)  RAM (See note 3.)  Real-Time Clock  Resl-Time Clock  Resl-Time Clock  Resl-Time Clock  Serial Bus Communication (see figure 3-9 on page 58)  | • • • 🛧                       | Microprocessor                       |                           |
| RAM (See note 3.)  RAM (See note 3.)  Real-Timer  Real-Time Clock  Keyboard (stuck key or faulty key-down detector)  RS-232 I/O  Serial Bus Communication (see figure 3-9 on page 58)  | • • * •                       | ROM Checksum (See note 1.)           |                           |
| Timer  Real-Time Clock  Keyboard (stuck key or faulty key-down detector)  RS-232 I/O  Serial Bus Communication (see figure 3-9 on page 58)   | • • <del>*</del> <del>*</del> | RAM (See note 2.)                    | = steady on or slow blink |
| Real-Time Clock  Keyboard (stuck key or faulty key-down detector)  RS-232 I/O  Serial Bus Communication (see figure 3-9 on page 58)  | • * • •                       | RAM (See note 3.)                    |                           |
| Keyboard (stuck key or faulty key-down detector)  RS-232 I/O  Serial Bus Communication (see figure 3-9 on page 58)   | • * • *                       | Timer                                |                           |
| RS-232 I/O  RS-232 I/O  Serial Bus Communication (see figure 3-9 on page 58)   | • * * •                       | Real-Time Clock                      |                           |
| Serial Bus Communication (see figure 3-9 on page 58)   | • * * *                       | Keyboard (stuck key or faulty key-do | own detector)             |
| The state of the s | * • • •                       | RS-232 I/O                           |                           |
|  | <b>* • • *</b>                | Serial Bus Communication (see figu   | re 3-9 on page 58)        |
|  | $* \bullet * \bullet$         | Signaling Board Self Test            |                           |
| → → → Display Drive Self Test  | *•**                          | Display Drive Self Test              |                           |
| ★ ★ ● Miscellaneous Hardware (see figure 3-10 on page 59)  | **•                           | Miscellaneous Hardware (see figure   | e 3-10 on page 59)        |

#### **NOTES**

1. Second and third LED failure patterns:

0001 and 0001 for any main ROM failure 0001 and 0002 for boot ROM failure

2. Second and third LED failure patterns:

0001 and 0001 for A2A30 Memory/SBRC board RAM failure 0001 and 0002 for A2A31 Controller board RAM failure

3. Second and third LED failure patterns:

0001 and 0001 for A2A30 Memory/SBRC board RAM failure 0001 and 0010 for A2A30 Memory/SBRC board RAM failure

Figure 3-9 Non-blinking LED Codes For Serial Bus Communication Failure

If the second and third LED patterns displayed are....

Then the failure is...

| 3 2 1 0   |                                       |
|---|---------------------------------------|
| • • • 🔆   | A2A44 Modulation Distribution         |
| $\bullet$ $\bullet$ $\Leftrightarrow$ $\bullet$ | A2A24 RF Output                       |
| • • <b>* *</b>                                  | A2A80 Audio Analyzer 1                |
| $\bullet \Leftrightarrow \bullet \bullet$       | A2A40 Audio Analyzer 2                |
| • <b>☆</b> • <b>☆</b>                           | A2A23 High Stability Reference        |
| • * * •   | A2A130 RF Input/Output                |
| • * * *   | A2A115 Downconverter                  |
| <b>☆ • • •</b>                                  | A2A21 Receiver                        |
| <b>☆ • • ☆</b>                                  | A2A20 Spectrum Analyzer               |
| <b>☆ • ☆ •</b>                                  | A2A25 Signal Generator Synthesizer    |
| <b>☆ • ☆ ☆</b>                                  | A2A22 Receiver Synthesizer            |
| * * * *   | A2A110 Upconverter                    |
| <b>☆☆</b> ◆ ☆                                   | A2A100 Premodulation Filter           |
| ***   | A2A120 Reference Receiver/IQ Modulato |
|   |                                       |

# **LED Legend**

● = off

= rapid blink

⇒ = steady on or slow blink

Figure 3-10 Non-Blinking LED Codes for Miscellaneous Hardware Failure

 patterns displayed are....

 3
 2
 1
 0

 ●
 ♦
 ●
 ♦
 A2A23 High Stability Reference

 ●
 ♦
 ●
 ♦
 A2A90A1 Audio Filter 1 - C-Message Filter

 ●
 ♦
 ♦
 ♦
 A2A90A2 Audio Filter 2 - 6 kHz BP Filter

 ●
 ♦
 ♦
 A2A36 Receive DSP

Then the failure is...

A2A34 Transmit DSP

### **LED Legend**

If the second and third LED

● = off

= rapid blink

⇒ = steady on or slow blink

⊗ = don't care

# **Functional Diagnostics (Step 2)**

The Functional Diagnostics (of the SERVICE MENU, shown in figure 3-11 on page 62) check whether or not major portions of the Test Set are functioning. They may pinpoint faults in the circuitry to the faulty assembly, or they may direct the use of any or all of the AF, RF, or TDMA diagnostics to more extensively test the circuitry.

### **Accessing the Diagnostic Tests**

#### **CAUTION**

A fifteen (15) minute warm up is required. The measurement limits of the SERVICE6 diagnostic tests are valid only at room temperature; that is, 20° to 25° C (65° to 75° F).

- **Step 1.** Press the **Preset** key.
- **Step 2.** Press the Menu key. The SOFTWARE MENU screen appears, see figure 3-11 on page 62.
- Step 3. Set the Select Procedure Location: field to ROM.
- Step 4. Set the Select Procedure Filename: field to SERVICE6.
- **Step 5.** To define test conditions, see "Define Test Conditions" on page 60. To configure the Test Set for a printer, see "Configuring a Printer" on page 61.
- **Step 6.** On the SOFTWARE MENU, select the Run Test field (or press k1), and wait for the SERVICE MENU screen.
- **Step 7.** Choose the diagnostic test (Functional, AF, RF, or TDMA) to run by turning the knob to move the pointer and then pressing the knob to select the test.
- **Step 8.** Follow the instructions on the screen.

As some of the tests run, you may be offered the option to alter test execution conditions by selecting:

- Loop to run the test continuously
- Pause to pause the tests
- Stp Fail (stop-failure) to stop on a failure
- Sgl Step (single-step) to pause the test after each measurement

For descriptions of the diagnostic options, refer to:

- "Functional Diagnostics Menu" on page 62.
- "AF Diagnostics" on page 65
- "RF Diagnostics" on page 66
- "TDMA Diagnostics" on page 67
- "CDPD Diagnostics" on page 90

#### **Define Test Conditions**

**Step 1.** On the SOFTWARE MENU screen (see figure 3-11), select Execution Cond to access the TESTS (Execution Conditions) screen.

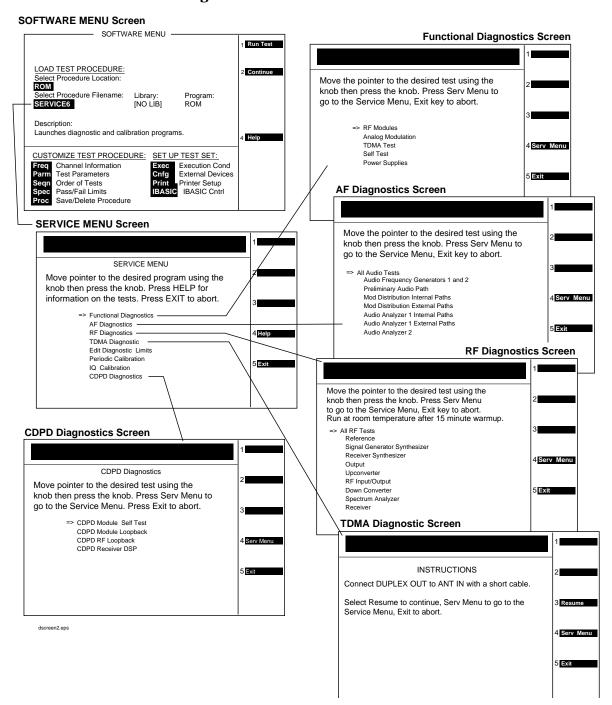
- Step 2. Set up the Output Results To: field. Select:
  - Crt to view measurements only on the display.
  - Select Printer to print the test results as well as display them on the CRT.
- Step 3. Set the Output Results For: field to All
- Step 4. Set up the If Unit-Under-Test Fails: field.
  - Select Continue to continue to the next test point.
  - Select Stop to pause testing at that point.
- Step 5. Set up the Test Procedure Run Mode: field.
  - Select Continuous to run the tests continuously.
  - Select Single Step to pause after each measurement.
- Step 6. Verify that the Autostart Test Procedure on Power-Up: setting is Off.

#### **Configuring a Printer**

Only perform the following steps if you want to print test results.

- 1. If you are not already at the SOFTWARE MENU screen, press the Menu key.
- 2. Under SET UP TEST SET:, select Print to access the "TESTS (Printer Setup)" screen.
- 3. Under PRINT SETUP:, select Model: and the printer of your choice.
- 4. Set the Printer Port: for the side-panel connector your printer is connected to (Parallel 15, Serial 9, or GPIB).
  - If an GPIB printer is used, you need to enter the printer's two-digit bus address when the Printer Adrs field appears (Example; enter 1 or 01 for bus address 701). Also, press the Shift key, then the Inst Config key to access the I\O CONFIGURE screen, and set the Mode field to Control.
- 5. Under PAGE CONTROL:, set the Lines/Page: and Form Feed (FF at Start:, and FF at End:) parameters if necessary.

Figure 3-11 SERVICE6 Program Screens



### **Functional Diagnostics Menu**

To run the functional diagnostics, see "Accessing the Diagnostic Tests" on page 60. These diagnostics are intended to help in locating the source of catastrophic failures. Occasionally, a test will fail with the test results being only slightly out of limits. Such failures do not necessarily indicate that the Test Set is operating outside of its published specifications or that it is otherwise faulty. Further testing (such as running the

performance tests) will be required in such cases.

Many of the internal diagnostic and calibration procedures use low-level latch commands to control the instrument settings. Many latch settings persist even through a preset. They can only be reset by an instrument power down or by explicitly resetting each latch. This phenomenon is the reason the message "Direct latch write occurred. Cycle power when done servicing" is displayed the first time a latch is written to. Because latch settings persist, problems can arise after running these programs.

For example, prematurely terminating a test in a diagnostic (using the **Pause** and **Exit** keys) and restarting another test may cause failures in that test because of improper latch settings. It is best to run tests to completion before starting another one. Also, be sure to cycle the power off and on when servicing the Test Set is complete.

Figure 3-12 Functional Diagnostics Screen

### SERVICE MENU Screen SERVICE MENU Move pointer to desired program using the knob then press the knob. Press Help for information on the tests. Press Exit to abort. => Functional Diagnostics AF Diagnostics RF Diagnostics Help TDMA Diagnosti Move the pointer to the desired test using the knob then press the knob. Press Serv Menu to go to the Service Menu, Exit key to abort. => RF Modules Analog Modulation **Functional** Sev Menu TDMA Test **Diagnostics** Self Test Screen Power Supplies Exit

#### **RF Modules**

The average and TX power meters, RF analyzer, IF analyzer, DSP analyzer, and spectrum analyzer are used to test the signal generator. Both the internal and external paths of the RF/IO assembly are used in the tests.

funcscrn.eps

### **Analog Modulation**

The demodulator in the RF analyzer, and the spectrum analyzer are used to check the accuracy, distortion, and residuals of the FM and AM frequencies. The counter is used to measure the audio frequency.

#### **TDMA Test**

The TDMA analyzer is used to measure EVM, origin offset spur, and frequency error on

### Troubleshooting

# **Functional Diagnostics (Step 2)**

a signal from the TDMA Generator.

Self Test

The power-up self test diagnostics are run. Refer to "Self-Test Diagnostics (Step 1)" on page 51.

**Power Supplies** 

The different levels of the power supply are measured with the internal voltmeter.

# AF, RF, TDMA and CDPD Diagnostics (Step 3)

These diagnostics are intended to help in locating the source of catastrophic failures. Occasionally, a test will fail with the test results being only slightly out of limits. Such failures do not necessarily indicate that the Test Set is operating outside of its published specifications or that it is otherwise faulty. Further testing (such as running the performance tests) will be required in such cases.

Also many of the internal diagnostic and calibration procedures use low-level latch commands to control the instrument settings. Many latch settings persist even through a preset. They can only be reset by an instrument power-down or by explicitly resetting each latch. This phenomenon is the reason the message "Direct latch write occurred. Cycle power when done servicing" is displayed the first time a latch is written to. Because latch settings persist, problems can arise in running these programs.

For example, prematurely terminating a test in a diagnostic (using the **Pause** and **Exit** keys) and restarting another test may cause failures in that test because of improper latch settings. It is best to run tests to completion before starting another one. Also, be sure to cycle the power off and on when servicing the Test Set is complete.

### **AF Diagnostics**

This program tests the audio functions of the following assemblies:

- A2A40 Audio Analyzer 2
- A2A80 Audio Analyzer 1
- A2A44 Modulation Distribution
- A2A32 Signaling/Source (AF Generators 1 and 2 only)
- A2A33 Measurement (only a few selected inputs)

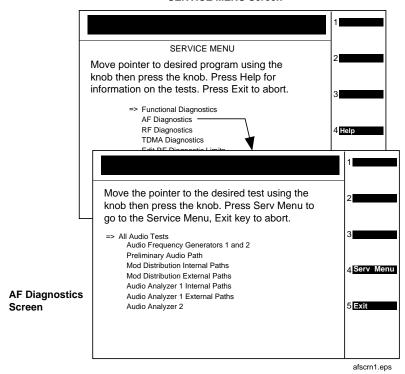
After initial cabling, all tests can be run in a loop mode without further intervention. This makes it easier to catch intermittent failures. To run the AF diagnostics, see "Accessing the Diagnostic Tests" on page 60.

#### **NOTE**

A fifteen minute warm up is required. The measurement limits of the SERVICE6 diagnostic tests are valid only at room temperature; that is,  $20^{\circ}$  to  $25^{\circ}$  C ( $65^{\circ}$  to  $75^{\circ}$  F).

Figure 3-13 AF Diagnostics Screen

#### SERVICE MENU Screen



When a test fails, a diagnosis is given in as:

- A diagnostic code.
- The name of the assembly or assemblies most likely to have failed.
- A rating of the confidence (high, medium, or low) of the diagnosis.

### **RF Diagnostics**

This program tests the RF functions of the following assemblies:

- A2A115 Downconverter
- A2A24 RF Output
- A2A25 Signal Generator Synthesizer
- A2A23 High Stability Reference
- A2A21 Receiver
- A2A22 Receiver Synthesizer
- A2A20 Spectrum Analyzer
- A2A130 RF Input/Output
- A2A110 Upconverter

Some tests require cabling before the RF Diagnostics can be run, but, all tests can be run in a loop mode without further intervention. Running in loop mode makes it easier to catch intermittent failures. To run these diagnostics, see "Accessing the Diagnostic

### Tests" on page 60.

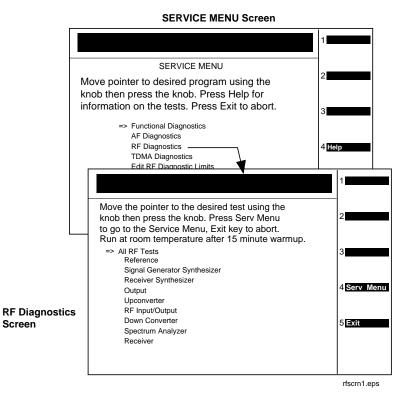
#### **NOTE**

A fifteen minute warm up is required. The measurement limits of the SERVICE6 diagnostic tests are valid only at room temperature; that is,  $20^{\circ}$  to 25 °C ( $65^{\circ}$  to 75 °F).

When a test fails, a diagnosis is given in two parts:

- · Sometimes a diagnostic code.
- The name of the assembly or assemblies most likely to have failed.
- Sometimes a rating (high, medium, or low) of the confidence of the diagnosis.

Figure 3-14 RF Diagnostics Screen



# **TDMA Diagnostics**

To run the TDMA diagnostic program, see "Accessing the Diagnostic Tests" on page 60. This program tests the functions of the following assemblies:

- · A2A100 Premodulation Filter
  - Reference detection and switching
  - 20 MHz VCO and PLL
  - Power supplies
  - Symbol and frame clock circuits
  - IQ modulator drive DACs
- A2A120 Reference Receiver/IQ Modulator

- 10 MHz TCXO
- Sine wave reference PLL
- Symbol clock PLL
- Symbol clock cleanup PLL
- Frame clock PLL
- 115 MHz LO and PLL
- Receiver IF downconverter

Figure 3-15 TDMA Diagnostics Screen

# **SERVICE MENU Screen** SERVICE MENU Move pointer to desired program using the knob then press the knob. Press Help for information on the tests. Press Exit to abort. => Functional Diagnostics AF Diagnostics RF Diagnostics TDMA Diagnostic Edit RF Diagnostic Limits Periodic Calibration **INSTRUCTIONS** Connect DUPLEX OUT to ANT IN with a short cable. Select Resume to continue. Serv Menu to go to the Service Menu, Exit to abort. Serv Menu **TDMA Diagnostic** Screen Exit

In summary, the presence of the two external sources (i.e. external to the assemblies being tested) is checked. Then the power supplies are checked followed by a check of the various frequencies present on the Premodulation Filter assembly (bit, symbol, and frame clocks and IQ modulator drive). Each bit of the four IQ modulator DACs is also checked.

The various oscillators and phase lock loops (PLLs) are also checked:

- 1. The 20 MHz VCO on the Premodulation Filter (part of the A2A120 assembly) is checked to see if it can be locked to:
- the 10 MHz OCXO,
- the rubidium timebase reference (if present),
- an external synthesizer reference (at the DUPLEX OUT), and,
- the 10 MHz TCXO on the Reference Receiver (part of the A2A120 assembly).

### **NOTE** The optional rubidium timebase has an expected life of 5-10 years. When it fails, it can continue to oscillate but the Test Set remains in an out-of-lock condition as indicated by the Unlock LED on the front panel always remaining lit. 2. The 10 MHz VCO on the Reference Receiver is checked to see if it can lock to the 20 MHz VCO via the sine wave reference PLL with and without the symbol clock cleanup loop and to an external TDMA reference (at the AUDIO OUTPUT) via the symbol clock PLL and via the frame clock PLL. 3. The 115 MHz LO on the Reference Receiver is checked to see if it can lock to the 20 MHz VCO. NOTE Before ordering a replacement assembly... Before ordering an assembly based on the results of the diagnostics, you should verify the diagnostics by other means if possible. This could include using manual troubleshooting procedures and descriptions of the AF, RF, and TDMA diagnostics in this chapter, and block diagrams in Chapter 10, "Block Diagrams," on page 273. If you still lack confidence in troubleshooting or diagnosing the problem or faulty assembly, call for methods of getting troubleshooting assistance ("Factory Support", see page 45,).

# **CDPD Diagnostics**

This program tests the CDPD functions of the Test Set with OPTION 003. The program specifically tests the following assemblies

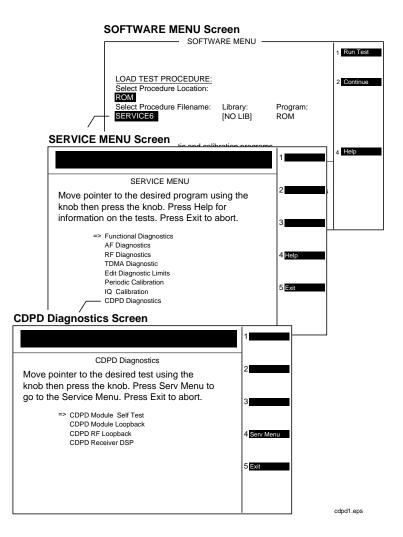
- A2A35 CDPD Module
- A2A36 Receiver DSP Assembly

After initial cabling, each test can be run individually in a loop without further intervention. This makes it easier to catch intermittent failures. To run the CDPD Diagnostics, see "Accessing the Diagnostic Tests" on page 60. The CDPD Diagnostics should be performed in the order listed on the screen, see figure 3-23.

**NOTE** 

A fifteen minute warm up is required. The measurement limits of the SERVICE6 diagnostic tests are valid only at room temperature; that is,  $20^{\circ}$  to  $25^{\circ}$  C ( $65^{\circ}$  to  $75^{\circ}$  F).

Figure 3-16



When a test fails, a diagnosis is given which attempts to indicate nature of the failure.

Use the following tables to aid you with the error messages of this diagnostic program.

Table 3-2 CDPD Module Self Test Error Messages and Causes

| Error Message  | Probable Cause                       |
|--|--------------------------------------|
| Attempt to begin Self Test has failed. (or no response or a communication timeout) | Check the serial communication path. |
| There is an error in the microprocessor's external SRAM.                           | Failure in the A2A35 CDPD module.    |
| DSP fails to respond to a microprocessor command.                                  | Failure in the A2A35 CDPD module.    |
| Failed in digital loopback test.   | Failure in the A2A35 CDPD module.    |
| Flash memory does not contain valid code.  | Failure in the A2A35 CDPD module.    |
| Synthesizer fails to lock across tuning range.                                     | Failure in the A2A35 CDPD module.    |

# Table 3-3 CDPD Module Loopback Test Error Messages and Causes

| Error Message<br>(if the previous test, CDPD Module Self Test,<br>passed) | Probable Cause                                      |
|---|---|
| Unable to put into digital loopback mode.                                 | Cycle power to clear the serial bus then try again. |
| Unable to transmit on the forward channel.                                | Failure in the A2A35 CDPD module.                   |
| CDPD Status NOT VALID for digital loopback test.                          | Failure in the A2A35 CDPD module.                   |

# Table 3-4 CDPD RF Loopback Test Error Messages and Causes

| Error Message<br>(if the previous test, CDPD Module Loopback,<br>passed) | Probable Cause  |
|--|---|
| Unable to put into normal mode.  | Cycle power to clear the serial bus then try again.   |
| Unable to tune CDPD module due to synthesizer failure.                   | Failure in the A2A35 CDPD module.   |
| Unable to transmit on the forward channel.                               | Failure in the A2A35 CDPD module.   |
| CDPD Status NOT VALID for RF loopback test.                              | Faulty RF path in Test Set or failure in the A2A35 CDPD module. Refer to "Block Diagrams" on page 273, to aid you in understanding and isolating the problem. |

### **CDPD Tests Description**

#### **CDPD Module Self Test**

This test verifies the base CDPD hardware. This hardware includes the communication link between the Test Set and the CDPD module, CDPD processors, memory, synthesizer, and loopback hardware. The diagnostics program will respond with TEST SUCCESSFUL or a failure message indicating which part of the diagnostic routing failed. See table 3-6 on page 91 for error messages and probable causes.

#### **CDPD Module Loopback Test**

This test goes one step further than the CDPD Module Self Test and verifies some of the functions of the CDPD module. The CDPD module is set to operate in a digital loopback mode when three predefined messages are sent and then received and checked for a valid CDPD signal. This is all done in the digital portion of the CDPD module. The RF circuits on the CDPD module and the RF path through the Test Set are checked in the CDPD RF LoopbackTest.

If all three messages are successfully looped back, the message CDPD Status VALID for all three digital loops is displayed. If any one of these messages is not successfully received or is corrupted, the program displays a failure message indicating which part of the test has failed. See table 3-6 on page 91 for error messages and probable causes.

#### **CDPD RF Loopback Test**

This test is similar to the CDPD Module Loopback test except that the CDPD module is used in its normal mode and the entire RF path through the Test Set is verified. Three predefined messages are sent then received and checked for a valid CDPD signal. This test checks the functioning of the CDPD module and the RF path through the Test Set.

If all three messages are successfully looped back, the message CDPD Status VALID for RF loopback test. is displayed. If any one of these messages is not successfully received or is corrupted, the program displays a failure message indicating which part of the test has failed. See table 3-6 on page 91 for error messages and probable causes. See figure 3-24, "CDPD RF Loopback Test Path," on page 94, for a diagram of the loopback test path.

#### **CDPD Receiver DSP Test**

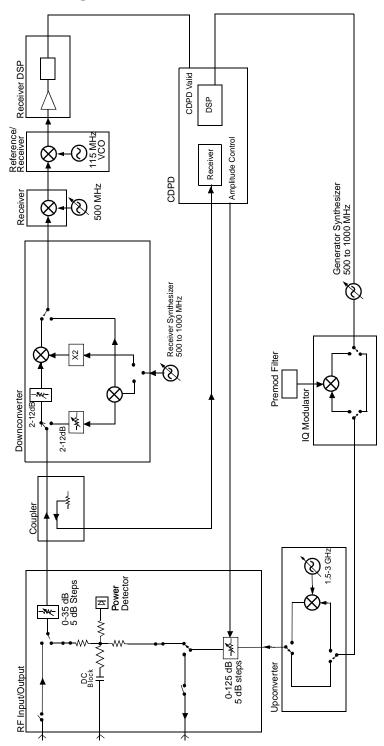
This test tests the parts of the Receiver DSP that are used for CDPD. The measurements are made using the internal source as a CDPD stimulus; therefore, it is possible that if a test fails, the source could be at fault. The tests are conducted in five groups:

- In the general check, the measurement mode is set to General and measurements are
  made continuously. Signal parameters such as frequency error and modulation index
  are checked as is the status. The status is not 0 because the modulation source does
  not conform to a specified CDPD source. (It is a square wave coming from the internal
  function generator).
- In the status check, the measurement mode is set to Scale and various measurements are made on the analog-to-digital converter (ADC) in the DSP.
- In the error-code check, the measurement mode is set to General and the validity check is set to Check. Status should be 1 and all other measurements should be 0 indicating no errors.

- In the variable gain amplifier (VGA) and auto gain function check, the amplitude of the RF input is varied and the DSP level is checked as the gain of the VGA is varied.
- In the alternate/adjacent channel power check, in-channel and out-of-channel signal levels are checked.

As the tests run, only failure information is displayed. At the conclusion of a group of tests a failure message is displayed which will usually indicate that the failure is most likely with the Receiver DSP module.

Figure 3-17 CDPD RF Loopback Test Path



# **Frequently Encountered Diagnostic Messages**

## Warning/Error Messages

Error messages frequently occur while any of the SERVICE6 program diagnostic tests are running. The most complete and general list of error messages is in the "Error Messages" chapter of the Test Set's *Reference Guide*. (Some messages relating specifically to troubleshooting can be found in Appendix 11, "Error Messages," on page 311.) Some of the messages you can expect to occur while running the SERVICE6 program diagnostic tests are as follows:

- Direct latch write occurred. Cycle power when done servicing. The SERVICE6 program commonly generates this message. This message appears the first time the diagnostic program directly addresses a latch. The message should be ignored and cleared when you make a normal (not a diagnostic) measurement with the Test Set. To clear this message the Test Set should be turned off and back on again.
- Change Ref Level, Input Port or Attenuator (if using "Hold"). This message, and similar messages, can be generally ignored.
- Printer does not respond. This usually indicates that one or more settings on the TESTS (Printer Setup) screen are set incorrectly for your printer. Also, check that the printer's power is on and that it is correctly cabled. For GPIB printers make sure the printer is correctly addressed. If a serial printer is used, you may have to change the serial communication settings on the I/O CONFIGURE screen (press Shift then Inst Config to get to this screen). The message times-out after a few seconds, and the output destination is changed to CRT by the program.
- ERROR 173 IN XXXX Active/system controller req'd (where "XXXX" represents a line number). Indicates that the Test Set's internal IBASIC computer must be set as a system controller for some reason. This usually indicates that the Printer Port field of the TESTS (Printer Setup) screen was set to GPIB but the Mode field on the I/O CONFIGURE screen is set to Talk&Lstn instead of Control. Change the mode setting to Control and run the diagnostic again.

#### Time outs

Certain failures may cause a frequency or voltage reading to time out, that is, the time required for the measurement will be unreasonably long. If a timeout occurs, measurement execution will stop and an error message will be displayed.

- If frequency or voltage readings have been successfully made before the timeout, the
  assembly currently being tested or a multiplexer on the A2A33 Measurement
  assembly may be at fault.
- If most measurements fail, the A2A23 High Stability Reference assembly may be supplying faulty clock signals to the A2A33 Measurement assembly.
- Re-run the test to see if the timeout is intermittent.

# **Manual Troubleshooting Procedures (Step 4)**

If you are not sure a problem exists, you should attempt to duplicate the suspected problem. This is especially important if the Test Set is being used in a new application where misapplication, or incorrect operation of the Test Set may be involved.

Refer to following table to determine which diagnostic tests, performance tests, and periodic self calibration adjustments apply to an assembly. Downloading calibration data is discussed in Chapter 7, "Periodic Adjustments" on page 159.

Table 3-5 Relating Assemblies to Troubleshooting Aids

| Ref.<br>Designator | Assembly Name               | SERVICE6 Program Diagnostic Test: Sub-Test | Performance<br>Test to<br>Perform <sup>a</sup> | Periodic<br>Calibration <sup>b</sup><br>Program | Calib<br>Data<br>Needed <sup>c</sup> |
|--------------------|-----------------------------|--|--|---|--------------------------------------|
| A1                 | Front Panel                 |  |  |   | No                                   |
| A1A1               | Display                     |  |  |   | No                                   |
| A1A2               | Keypanel                    | Functional<br>Diagnostics: Self<br>Test    |  |   | No                                   |
| A1A3               | RPG                         |  |  |   | No                                   |
| A2A1               | Motherboard                 |  |  |   | No                                   |
| A2A10              | PCMCIA Card<br>Reader       |  |  |   | No                                   |
| A2A15              | Rubidium<br>Reference       | TDMA<br>Diagnostic                         |  |   | No                                   |
| A2A20              | Spectrum<br>Analyzer        | RF Diagnostics:<br>Spectrum<br>Analyzer    | Spectrum<br>Analyzer                           |   | Yes                                  |
| A2A21              | Receiver                    | RF Diagnostics:<br>Receiver                | RF Analyzer:<br>FM Accuracy                    |   | Yes                                  |
| A2A22              | Receiver<br>Synthesizer     | RF Diagnostics:<br>Receiver<br>Synthesizer | RF Analyzer:<br>Residual FM                    |   | Yes                                  |
| A2A23              | High Stability<br>Reference | RF Diagnostics:<br>Reference               | RF Generator:<br>Residual FM                   |   | Yes                                  |
| A2A24              | RF Output                   | RF Diagnostics:<br>Output                  |  |   | Yes                                  |

Table 3-5 Relating Assemblies to Troubleshooting Aids

| Ref.<br>Designator | Assembly Name                   | SERVICE6 Program Diagnostic Test: Sub-Test                     | Performance<br>Test to<br>Perform <sup>a</sup>               | Periodic<br>Calibration <sup>b</sup><br>Program                               | Calib<br>Data<br>Needed <sup>c</sup> |
|--------------------|---------------------------------|--|--|---|--------------------------------------|
| A2A25              | Signal Generator<br>Synthesizer | RF Diagnostics:<br>Signal<br>Generator<br>Synthesizer          | RF Generator:<br>Harmonic and<br>Spurious<br>Spectral Purity |   | Yes                                  |
| A2A30              | Memory/SBRC                     | Functional<br>Diagnostics: Self<br>Test                        |  |   | No                                   |
| A2A31              | Controller                      | Functional<br>Diagnostics: Self<br>Test                        |  |   | Yes                                  |
| A2A32              | Signal/Source                   | AF Diagnostics:<br>Audio<br>Frequency<br>Generators 1<br>and 2 |  |   | No                                   |
| A2A33              | Measurement <sup>d</sup>        | Functional<br>Diagnostics: Self<br>Test                        | Oscilloscope   | SERVICE6: Periodic Calibration: Voltmeter Reference                           | Yes                                  |
| A2A34              | Transmit DSP                    | Functional<br>Diagnostics                                      |  | SERVICE6: IQ<br>Modulator   | Yes                                  |
| A2A35              | CDPD                            |  |  |   |                                      |
| A2A36              | Receive DSP                     | Functional<br>Diagnostics                                      |  |   | No                                   |
| A2A40              | Audio Analyzer 2                | AF Diagnostics:<br>Audio<br>Analyzer 2                         | AF Analyzer:<br>AC Voltage<br>Accuracy                       | SERVICE6:<br>Periodic<br>Calibration:<br>VFN                                  | Yes                                  |
| A2A44              | Modulation<br>Distribution      | AF Diagnostics:<br>Mod<br>Distribution<br>Internal Paths       | AF Generator:<br>AC Level<br>Accuracy                        | SERVICE6:<br>Periodic<br>Calibration:<br>AF Gen Gain,<br>EXT Mod Path<br>Gain | Yes                                  |
| A2A50              | Display Drive                   | Functional<br>Diagnostics: Self<br>Test                        |  |   | No                                   |

**Relating Assemblies to Troubleshooting Aids Table 3-5** 

| Ref.<br>Designator | Assembly Name                         | SERVICE6 Program Diagnostic Test: Sub-Test            | Performance<br>Test to<br>Perform <sup>a</sup> | Periodic<br>Calibration <sup>b</sup><br>Program                   | Calib<br>Data<br>Needed <sup>c</sup> |
|--------------------|---------------------------------------|---|--|---|--------------------------------------|
| A2A70              | Control Interface                     | Functional<br>Diagnostics: Self<br>Test               |  |   | No                                   |
| A2A80              | Audio Analyzer 1                      | AF Diagnostics:<br>Audio Analyzer<br>1 Internal Paths |  | SERVICE6:<br>Periodic<br>Calibration:<br>Audio Analyzer<br>Offset | Yes                                  |
| A2A100             | Premodulation<br>Filter               | Functional<br>Diagnostics:<br>TDMA Test               |  | SERVICE6:<br>IQ Modulator   | Yes                                  |
| A2A110             | Upconverter                           | RF Diagnostics:<br>Upconverter                        |  |   | Yes                                  |
| A2A115             | Downconverter                         | RF Diagnostics:<br>Downconverter                      |  |   | Yes                                  |
| A2A120             | Reference<br>Receiver/IQ<br>Modulator | Functional<br>Diagnostics:<br>TDMA Test               |  | SERVICE6:<br>IQ Modulator   | Yes                                  |
| A2A130             | RF Input/Output                       | RF Diagnostics:<br>RF<br>Input/Output                 | RF Generator:<br>Level Accuracy                | PCMCIA<br>Program<br>System Power<br>E6380-61811                  | Yes                                  |
| A2A200             | 100W Attenuator                       | Functional<br>Diagnostics:<br>RF Modules              |  | PCMCIA<br>Program<br>System Power<br>E6380-61811                  | Yes                                  |
| A3A1               | Power Supply<br>Regulator             | Functional<br>Diagnostics: Self<br>Test               |  |   | No                                   |
| A3A2               | Power Supply                          | Functional<br>Diagnostics: Self<br>Test               |  |   | No                                   |

a. See Chapter 4, "Preventative Maintenance" on page 95.

b. See Chapter 7, "Periodic Adjustments" on page 159.

c. See Table 7-1, on page 160.d. Measurement checked indirectly by all diagnostics.

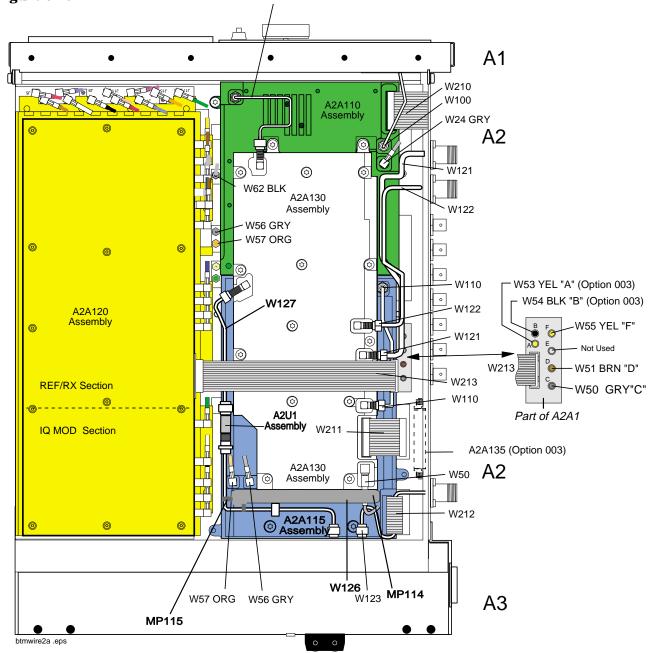
# **Verify Test Set's Reference Path**

### **Out-of-Lock (OOL) LEDs**

Out-of-lock (OOL) LEDs light when a phase-locked loop inside an assembly is failing. The Signal Generator Synthesizer, A2A25, and the Receiver Synthesizer, A2A22, assemblies have these LEDs mounted close to the top of the modules. The location of each LED is labeled on the assembly.

Verify that the Premodulation Filter (A2A100), the High Stability Reference (A2A23), and the Rubidium Reference (A2A15 - if present) are working before troubleshooting the Receiver Synthesizer or the Signal Generator Synthesizer assemblies.

Figure 3-18



High Stability Reference, A2A23, Verification

- **Step 1.** Turn the Test Set off and re-install the High Stability Reference assembly.
- **Step 2.** Remove the Receiver Synthesizer (A2A22) assembly.
- **Step 3.** Turn the Test Set on and verify that a 1 MHz signal of approximately –1 dBm is present on pin 3 of J21. This is the reference signal from the Reference assembly.
- **Step 4.** If the 1 MHz signal is not present, then the Reference assembly is probably faulty. It is also possible that an open or shorted trace on the motherboard assembly exists.

Check the motherboard for continuity between J21 pin 3 under the Receiver Synthesizer A2A22 assembly and J18 pin 2 under the Reference assembly, and verify that the trace is not shorted to ground.

### Receiver Synthesizer, A2A22, Unlocked

If the 1 MHz signal is present on pin 3 of J21, then the Receiver Synthesizer assembly is faulty.

#### Signal Generator Synthesizer, A2A25, Unlocked

- **Step 1.** Turn the Test Set off and remove the Signal Generator Synthesizer assembly.
- **Step 2.** If the signal is present, then the Signal Generator Synthesizer assembly is faulty.
- **Step 3.** Turn the Test Set on and verify that a 1 MHz signal of about –20 dBm is present on pin 3 of J12. This is the reference signal from the High Stability Reference (A2A23) assembly.

If the 1 MHz signal is not present, then the High Stability Reference (A2A23) assembly is probably faulty.

It is also possible that an open or shorted trace on the Motherboard (A2A1) assembly exists. Check the motherboard for continuity between J12 pin 3 (under the Signal Generator Synthesizer assembly) and J34 pin 1 (under the High Stability Reference, A2A23, assembly), and verify that the trace is not shorted to ground.

# **Swapping Known-Good Assemblies**

Most swapped assemblies which use calibration data will operate well enough with the original assembly's calibration data to troubleshoot and to run the diagnostics; do not expect the Test Set to meet its specifications. Some assemblies may appear to fail because of incorrect calibration data. It is also important to keep track of the original assemblies in the Test Set. If calibration data is lost, the assembly will have to be sent back to the factory.

Calibration data is generally stored in a socketed EEPROM on the A2A31 Controller. If the controller is replaced or swapped, the original EEPROM must be installed in the new Test Set's Controller. Should the EEPROM lose data, the entire instrument will need to be repaired at the factory.

The assemblies that require downloaded calibration data from a memory card are:

- A2A20 Spectrum Analyzer
- A2A33 Measurement
- A2A200 100W Attenuator

Swapping these assemblies may cause some performance specification failures if the swapped-in assembly's calibration data cannot be downloaded.

The assemblies that require on-board calibration loaded at the factory are:

- A2A115 Downconverter
- A2A110 Upconverter
- A2A130 RF Input/Output
- A2A24 RF Output

- A2A21 Receiver
- A2A25 Signal Generator Synthesizer
- A2A22 Receiver Synthesizer
- A2A23 High Stability Reference

Swapping these assemblies should not cause a performance problem, as their calibration data resides with the assembly.

The assemblies that require a periodic calibration procedure are:

- A2A100 Premodulation Filter
- A2A130 RF Input/Output
- A2A120 Reference Receiver/IQ Modulator
- A2A200 100W Attenuator
- A2A34 Transmit DSP
- A2A80 Audio Analyzer 1
- A2A40 Audio Analyzer 2
- · A2A33 Measurement
- A2A44 Modulation Distribution

Generally, these assemblies can be swapped without an immediate need of recalibration. In some cases though, a recalibration may be necessary to properly troubleshoot the instrument.

# **Further Isolating RF Failures**

Isolating failures in the RF assemblies of the Test Set can be difficult. One problem occurs when the diagnostics use the built-in RF analyzer to test the built-in RF source, and vice versa. This is necessary to make the diagnostics self-contained, that is, they run without external equipment.

Some general-purpose, RF test equipment will be needed:

- · RF signal generator
- · RF modulation analyzer or spectrum analyzer.

#### **Isolating the RF Analyzer**

The RF analyzer function uses the following assemblies. Refer to figure 3-19 and the block diagrams in chapter 10, "Block Diagrams".

- A2A115 Downconverter
- A2A21 Receiver
- A2A22 Receiver Synthesizer
- A2A20 Spectrum Analyzer

ĊDPD Input Demod (FM, AM, SSB) Down-conversion Receiver & OPP Attenuator Receiver Synthesizer Spectrum Analyzer Power RF Detector IN/OUT 100 W Attenuato Splitter **RF Analyzer** DUPLEX) OUT Output Reference Attenuator RF I/O

Figure 3-19 Isolating the RF Analyzer

To isolate an RF analyzer problem:

FROM RF SOURCE

#### **Step 1.** On the Test Set:

- a. Press Preset.
- **b.** Press the Inst Config to access the INSTRUMENT CONFIGURE screen.
  - Set the RF Display field to Freq.
  - · Set the RF Offset field to Off.
- **c.** Press the RF AnI key (to go to the analog RF ANALYZER screen).
  - Set the Tune Freq to 100 MHz.
  - Set the Input Port to RF IN.

#### **Step 2.** On the external RF signal generator:

- a. Set the frequency to 100 MHz CW.
- **b.** Set the amplitude to 0 dBm.
- **c.** Connect the output to the Test Set's RF IN/OUT connector.
- **Step 3.** Set the RF signal generator's frequency to 100, then 500, 900, and 1800 MHz. For each frequency, reset the RF analyzer's **Tune Freq** to that frequency. The Test Set's measurements should read as follows:
  - **a.** TX Power should read approximately 0.001 W for each frequency.
  - b. Frequency should read 100, 500, 900, and 1800 MHz respectively.

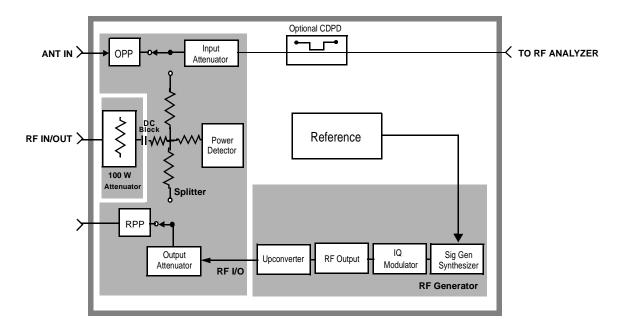
**c.** Press the **Spec Anl** key to access the spectrum analyzer. Observe the level and frequency of the signal.

#### **Isolating the RF Source**

The RF generator function uses the following assemblies. Refer to figure 3-20 and the block diagrams in chapter 10, "Block Diagrams".

- A2A120 Reference Receiver/IQ Modulator
- A2A25 Signal Generator Synthesizer
- A2A24 RF Output
- A2A110 Upconverter

Figure 3-20 Isolating the RF Source



To isolate the RF Source:

#### **Step 1.** On the Test Set:

- a. Press Preset.
- **b.** Press the Inst Config key to access the INSTRUMENT CONFIGURE screen.
  - Set the RF Display field to Freq.
  - · Set the RF Offset field to Off.
- **c.** Press the **RF Gen** key (to go to the analog RF GENERATOR screen).
- d. Set RF Gen Freq to 1800 MHz.
- e. Set Amplitude to 0 dBm.
- f. Set Output Port to Dupl.

- **Step 2.** On the external RF modulation analyzer or spectrum analyzer:
  - **a.** Set the tuning for the signal generated by the Test Set.
  - **b.** Connect the analyzer's input to the Test Set's DUPLEX OUT connector.
- **Step 3.** Set the Test Set's RF Gen Freq to 1800, then 600, 300, and 150 MHz. For each frequency, the external RF analyzer should read as follows:
  - $\boldsymbol{a.}\,$  Power should read approximately 0.001 W for each frequency.
  - b. Frequency should read 1800, 600, 300, and 150 MHz respectively.

## **SERVICE Screen**

A large number of latch and DAC settings used throughout the Test Set can also be read and/or set to alter standard operation. The SERVICE screen uses the internal voltmeter and frequency counter functions to monitor specific nodes in most assemblies. These functions are primarily intended to allow the automated internal diagnostic routines to verify proper instrument operation, and to allow the internal periodic adjustment routines to modify Test Set operation.

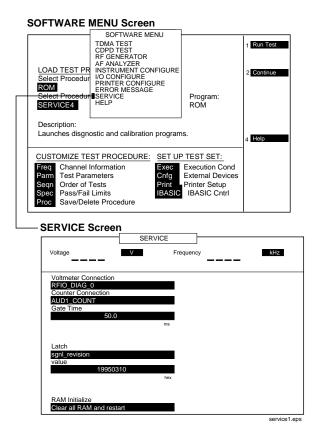
Use these functions for further troubleshooting when the diagnostics cannot isolate a failure to a specific assembly. To do this, you must understand how to operate the Test Set and, especially, understand how the assemblies in the Test Set work together.

#### How to Access the SERVICE Screen

- **Step 1.** Press the **Preset** key.
- **Step 2.** Rotate the knob to the screen's title bar and select it (press knob). A drop down menu appears, see figure 3-21.
- Step 3. Rotate the knob and select SERVICE.

The SERVICE screen appears. For field descriptions, see "Field Names and Descriptions" on page 87.

Figure 3-21 SERVICE Screen



# **Field Names and Descriptions**

#### **Voltmeter Connection**

This field selects the desired circuit node for voltage measurements. To change the voltmeter connection, use the knob to select the Voltmeter Connection field. A Choices menu will appear. Move the cursor to the desired circuit node in the list and push the cursor control knob. The reading is displayed in the Voltage measurement field at the top-left of the display.

Because the nodes being measured must be in the range of 0 to  $\pm 5$  volts, the measurement of some points are scaled to that measurement range. For example; the +12 Volt reference (MEAS\_12V\_REF) should measure about +5volts. The -12 Volt reference (MEAS\_NEG\_12V\_REF) should measure about -5 volts. Many of the voltage measurements are only valid after a number of instrument settings are changed.

When run, the diagnostic routines make the necessary circuit changes and measurements automatically, comparing the measurements to known limits for each node.

#### **Counter Connection**

This field selects the desired circuit node to connect to the Test Set's internal frequency counter. The reading is displayed in the **Frequency** measurement field at the top right of the display.

To change the counter connection, use the knob to select the Counter Connection field. A Choices menu will appear. Select the desired circuit node.

#### **Gate Time**

This field is used to adjust the Test Set's internal frequency counter's gate time. A shorter gate time may enable you to see frequency fluctuations that might not be seen using a longer gate time.

To change the gate time, use the knob to select the Gate Time field. When you select the field a flashing >> cursor is displayed. Rotate the cursor control knob until the desired gate time (10 to 1000 ms in 10 ms increments) is displayed, then press the cursor control knob.

#### Latch

This field is used to manually select the circuit latches that control switch, DAC, and gain settings within the Test Set. The value of the selected latch is displayed and changed in the Value field. Some settings are read-only.

To set a switch, DAC, or gain setting:

- Step 1. Use the knob to select the Latch field. A Choices menu will appear.
- **Step 2.** Move the cursor to the desired latch name and press the knob to select it.
- **Step 3.** Use the knob to select the Value field. A flashing >> cursor is displayed.
- **Step 4.** Rotate the cursor control knob to modify the value (hexadecimal).

NOTE

If any of the switches, DACs, or gain settings are changed with the Latch field, the Test Set will generate the message: Direct latch write occurred. Cycle power when

done servicing." To clear this message, cycle the Test Set's power. Upon power-up, the internal controller will return the Test Set to its default settings and values.

The first part of the names in the Choices menu relates to the assembly where the switch, DAC, or gain setting is located. Some latch names are not listed here.

- dstr: A2A44 Modulation Distribution
- aud1: A2A80 Audio Analyzer 1
- aud2: A2A40 Audio Analyzer 2
- · refs: A2A23 High Stability Reference
- rfio: A2A130 RF Input/Output
- dcvt: A2A115 Downconverter
- · ucvt: A2A110 Upconverter
- out: A2A24 RF Output
- rcvr: A2A21 Receiver
- gsyn: A2A25 Signal Generator Synthesizer
- rsyn: A2A22 Receiver Synthesizer
- spec: A2A20 Spectrum Analyzer
- pmf: A2A100 Premod Filter
- cdpd: A2A35 CDPD
- ref\_rx: A2A120 IQ MOD / REF RX
- meas: A2A33 Measurement
- metron: A2A33 Measurement
- afg1: A2A32 Signaling Source
- afg2: A2A32 Signaling Source

#### Value (hex)

This field displays and changes the hexadecimal value for the latch shown in the Latch field.

#### **RAM Initialize**

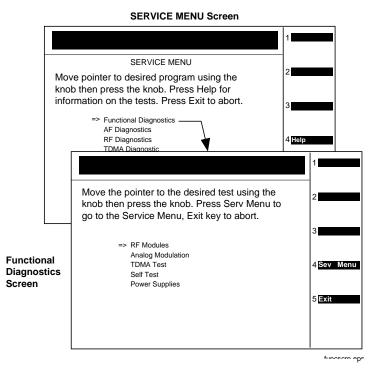
Selecting this field permanently clears all SAVE registers and test programs, and any initialized RAM disk(s), that may be in RAM. It also resets all latches to their factory power-up configuration.

## **Product Verification**

This section provides steps for verifying the Test Set's operation after a repair. Although in most cases these steps will be sufficient, they do not verify the ability of the instruments to meet published specifications. Only by performing all of the Performance Tests in chapter 8, "Performance Tests" can you verify the instrument's performance. The following steps are suggested, you may choose to do more.

**Step 1.** Run the Functional Diagnostics test of the SERVICE MENU (SERVICE6 program), see figure 3-22. The functional diagnostics tests verify the function of most of the assemblies in the Test Set.

Figure 3-22 Functional Diagnostics



**Step 2.** Perform a wideband sweep:

- a. Press Preset then press Spec Anal to get the SPECTRUM ANALYZER screen.
- **b.** Set the RF Gen controls to Track, and the Port/Sweep field to Dup1. This directs the tracking generator to the DUPLEX OUT port.
- **c.** Connect the DUPLEX OUT port to the ANT IN port.
- **d.** Set the Main control to Ant.
- e. Set the Center Freq to 501 MHz, and the Span to 1 GHz. You should see a (roughly) flat line across the screen, varying about 4 dB. "Generator sweep truncated" may appear, but does not indicate a problem.
- **Step 3.** Run the Performance Tests associated with the repair as indicated in table 3-5 on page 76, or run all the tests in Chapter 8, "Performance Tests" on page 173 to verify that the Test Set meets its overall performance specifications.

# **CDPD Diagnostics**

This program tests the CDPD functions of the Test Set with OPTION 003. The program specifically tests the following assemblies

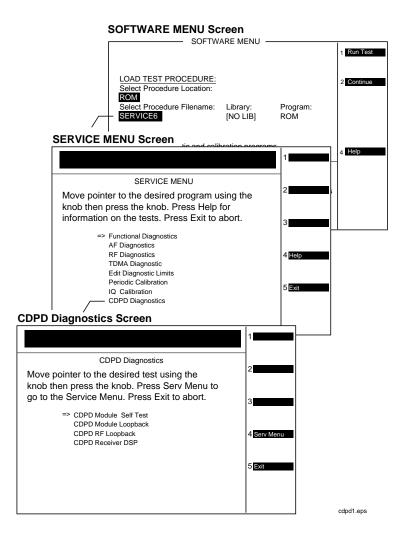
- A2A35 CDPD Module
- A2A36 Receiver DSP Assembly

After initial cabling, each test can be run individually in a loop without further intervention. This makes it easier to catch intermittent failures. To run the CDPD Diagnostics, see "Accessing the Diagnostic Tests" on page 60. The CDPD Diagnostics should be performed in the order listed on the screen, see figure 3-23.

**NOTE** 

A fifteen minute warm up is required. The measurement limits of the SERVICE6 diagnostic tests are valid only at room temperature; that is,  $20^{\circ}$  to  $25^{\circ}$  C ( $65^{\circ}$  to  $75^{\circ}$  F).

Figure 3-23



When a test fails, a diagnosis is given which attempts to indicate nature of the failure.

Use the following tables to aid you with the error messages of this diagnostic program.

Table 3-6 CDPD Module Self Test Error Messages and Causes

| Error Message  | Probable Cause                       |
|--|--------------------------------------|
| Attempt to begin Self Test has failed. (or no response or a communication timeout) | Check the serial communication path. |
| There is an error in the microprocessor's external SRAM.                           | Failure in the A2A35 CDPD module.    |
| DSP fails to respond to a microprocessor command.                                  | Failure in the A2A35 CDPD module.    |
| Failed in digital loopback test.   | Failure in the A2A35 CDPD module.    |
| Flash memory does not contain valid code.  | Failure in the A2A35 CDPD module.    |
| Synthesizer fails to lock across tuning range.                                     | Failure in the A2A35 CDPD module.    |

# Table 3-7 CDPD Module Loopback Test Error Messages and Causes

| Error Message<br>(if the previous test, CDPD Module Self Test,<br>passed) | Probable Cause                                      |  |
|---|---|--|
| Unable to put into digital loopback mode.                                 | Cycle power to clear the serial bus then try again. |  |
| Unable to transmit on the forward channel.                                | Failure in the A2A35 CDPD module.                   |  |
| CDPD Status NOT VALID for digital loopback test.                          | Failure in the A2A35 CDPD module.                   |  |

# Table 3-8 CDPD RF LoopbackTest Error Messages and Causes

| Error Message<br>(if the previous test, CDPD Module Loopback,<br>passed) | Probable Cause  |
|--|---|
| Unable to put into normal mode.  | Cycle power to clear the serial bus then try again.   |
| Unable to tune CDPD module due to synthesizer failure.                   | Failure in the A2A35 CDPD module.   |
| Unable to transmit on the forward channel.                               | Failure in the A2A35 CDPD module.   |
| CDPD Status NOT VALID for RF loopback test.                              | Faulty RF path in Test Set or failure in the A2A35 CDPD module. Refer to "Block Diagrams" on page 273, to aid you in understanding and isolating the problem. |

# **CDPD Tests Description**

#### **CDPD Module Self Test**

This test verifies the base CDPD hardware. This hardware includes the communication link between the Test Set and the CDPD module, CDPD processors, memory, synthesizer, and loopback hardware. The diagnostics program will respond with TEST SUCCESSFUL or a failure message indicating which part of the diagnostic routing failed. See table 3-6 on page 91 for error messages and probable causes.

#### **CDPD Module Loopback Test**

This test goes one step further than the CDPD Module Self Test and verifies some of the functions of the CDPD module. The CDPD module is set to operate in a digital loopback mode when three predefined messages are sent and then received and checked for a valid CDPD signal. This is all done in the digital portion of the CDPD module. The RF circuits on the CDPD module and the RF path through the Test Set are checked in the CDPD RF Loopback Test.

If all three messages are successfully looped back, the message CDPD Status VALID for all three digital loops is displayed. If any one of these messages is not successfully received or is corrupted, the program displays a failure message indicating which part of the test has failed. See table 3-6 on page 91 for error messages and probable causes.

#### **CDPD RF Loopback Test**

This test is similar to the CDPD Module Loopback test except that the CDPD module is used in its normal mode and the entire RF path through the Test Set is verified. Three predefined messages are sent then received and checked for a valid CDPD signal. This test checks the functioning of the CDPD module and the RF path through the Test Set.

If all three messages are successfully looped back, the message CDPD Status VALID for RF loopback test. is displayed. If any one of these messages is not successfully received or is corrupted, the program displays a failure message indicating which part of the test has failed. See table 3-6 on page 91 for error messages and probable causes. See figure 3-24, "CDPD RF Loopback Test Path," on page 94, for a diagram of the loopback test path.

#### **CDPD Receiver DSP Test**

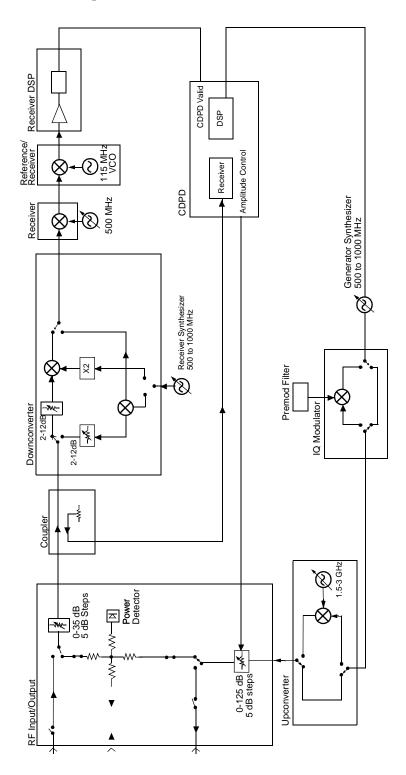
This test tests the parts of the Receiver DSP that are used for CDPD. The measurements are made using the internal source as a CDPD stimulus; therefore, it is possible that if a test fails, the source could be at fault. The tests are conducted in five groups:

- In the general check, the measurement mode is set to General and measurements are
  made continuously. Signal parameters such as frequency error and modulation index
  are checked as is the status. The status is not 0 because the modulation source does
  not conform to a specified CDPD source. (It is a square wave coming from the internal
  function generator).
- In the status check, the measurement mode is set to Scale and various measurements are made on the analog-to-digital converter (ADC) in the DSP.
- In the error-code check, the measurement mode is set to General and the validity check is set to Check. Status should be 1 and all other measurements should be 0 indicating no errors.

- In the variable gain amplifier (VGA) and auto gain function check, the amplitude of the RF input is varied and the DSP level is checked as the gain of the VGA is varied.
- In the alternate/adjacent channel power check, in-channel and out-of-channel signal levels are checked.

As the tests run, only failure information is displayed. At the conclusion of a group of tests a failure message is displayed which will usually indicate that the failure is most likely with the Receiver DSP module.

Figure 3-24 CDPD RF Loopback Test Path



# 4 Preventative Maintenance

This chapter describes the preventative maintenance procedures recommended for the Test Set.

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### **Hardware Maintenance**

The following procedures should be performed on a regular basis to insure that your Test Set maintains optimum performance.

#### **NOTE**

#### Periodic Adjustment Interval

The adjustment programs Periodic Calibration, IQ Calibration, and Eb/No Calibration should be performed after any assembly referred to in table on page 160 is replaced, or at least every 24 months. These program can be run anytime to optimize the performance of the Test Set. See Chapter 7, "Periodic Adjustments," on page 159 for details.

#### NOTE

#### **Performance Test Interval**

The performance tests in Chapter 8, "Performance Tests" on page 173 should be performed when certain assemblies are repaired or replaced, or at least every 24 months. See table 3-5 on page 76 for those assemblies requiring performance testing/calibration.

# **Adjustments**

Periodic Adjustments

Adjustments for calibration are part of the automated routines: Periodic Calibration and IQ Calibration. To run these routines see "Running the Periodic or IQ Calibration Programs" on page 166. Running these routines will adjust internal calibration and circuit paths for optimum performance. These routines can be run on any interval from six months to two years, depending on the severity of the application environment. These routines should also be run whenever a significant change to instrument's hardware configuration is made. For instructions on running the periodic adjustment routines see Chapter 7, "Periodic Adjustments," on page 159.

Real Time Clock

The Test Set operates with a real-time clock that is user set. The real-time clock consists of both a numerical date and a time-of-day setting which may require changing due to repair (such as a battery or hardware repair) or shipping to a different time zone. The clock and date should be checked as part of routine maintenance. Incorrect settings may be an indication of faulty battery backup.

The date and time settings are entered by using the INSTRUMENT CONFIGURE screen. The Date field is a numerical number using the MMDDYY format. The Time field is a numerical number using a 24-hour military standard (example: 3:00 pm is 15.00 in military time). The date and time are maintained as part of RAM memory with battery backup.

# **Cleaning**

- The Test Set contains an internal air filter. The filter requires periodic cleaning to remove dust and debris. Refer to "Cleaning the Air Filter" on page 98.
- RF assemblies A2A20 through A2A25 (see "Module and PC Board Assemblies" on page 111) should be removed and the bottom edges of the metal case cleaned with

isopropyl alcohol or a mild cleaner. Cleaning the metal edges will insure that RF leakage protection is maintained.

# **Functionality**

The Test Set has the capability to perform self tests for hardware failure and functionality. The self test diagnostics should be run whenever preventive maintenance, calibration, or repair has been performed. Self test diagnostics will help to insure that the instrument is performing reliably.

There are three diagnostic routines located in ROM of the Test Set: Functional Diagnostics, AF Diagnostics, and RF Diagnostics. Run these programs and follow the instructions listed on the screen. For instructions on running these diagnostics routines, see "Accessing the Diagnostic Tests" on page 60.

## **Integrity**

The Test Set has been designed for rugged conditions, however parts can become loose or damaged over time and may require repair or maintenance.

Module Insertion and Alignment

The Test set contains circuit assemblies and RF modules that are mounted in sockets and board guides. It is extremely important that these assemblies be firmly seated and aligned in their guides. Remove the Test Set's cover and check that boards align with the printed guides on the internal sheet metal covers. Ensure that each of the six RF module cases are firmly seated and locked in with their module bracket(s).

Type-N Connectors

The Test Set's RF IN/OUT, ANT IN, and DUPLEX OUT connectors should be checked for damage or looseness. Damage can occur to the center conductor pin or the connector itself might become loosened. If damaged, the connector should be replaced. A loose connector can be re-tightened with the nut on the back side of the side panel. Refer to Chapter 5, "Disassembly," on page 101 for information on the side-panel connectors.

Internal Cables and RF Connectors

The Test Set contains numerous cables and connectors that should be periodically checked for proper insertion and tightness. Remove the Test Set's cover and visually check for any cables that may not be properly inserted. Check each RF cable connection for tightness, tighten where needed. Refer Chapter 5, "Disassembly," on page 101 for information on the various cables and assemblies.

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#### **Maintenance Procedures**

# **Cleaning the Air Filter**

#### NOTE

The cleaning interval is dependent on the environmental conditions and application, it can be as often as six months in extremely dusty or dirty environments or as long as two years in a clean, well maintained facility.

The Test Set's internal air filter requires periodic cleaning. Failure to periodically clean this filter may result in decreased internal airflow, increased internal operating temperature, and early failure of the Test Set.

- 1. Remove the front frame and external cover to access the air filter, see figure 4-1 on page 99. It is not necessary to remove the rear frame. Refer to Chapter 5, "Disassembly," on page 101 for removing the front frame and external cover.
- 2. Lift the filter from the Test Set's chassis. Use a vacuum to clean the filter. Use only a static-free vacuum cleaner or ionized air for the removal of dust and debris.

# **Memory Backup AA Battery**

Two battery sources are used to maintain the contents of the Test Set's memory when power is disrupted. One source is a set of two AA batteries mounted behind the rear frame of the Test Set. You must periodically change these batteries. The second battery source acts as a backup to the AA batteries. It is internally mounted and is not user serviceable.

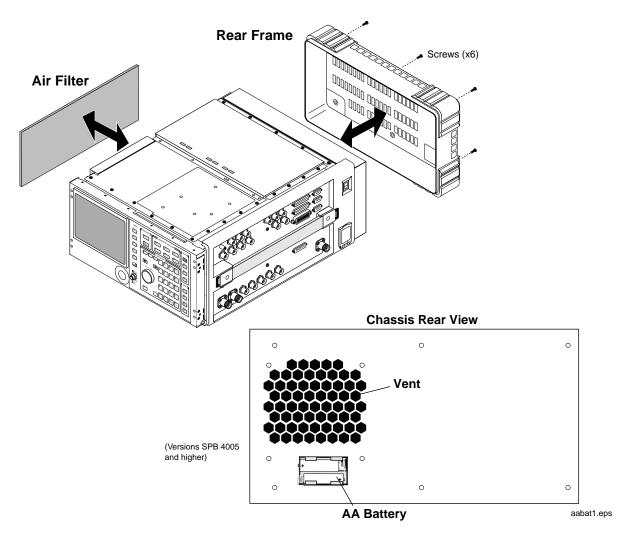
#### **CAUTION**

Replace these batteries every 2-3 years. Failure to take prompt action may result in loss of RAM data including IBASIC programs and SAVE/RECALL states stored in the RAM.

To change the AA batteries, use the following procedure:

- 1. Switch power off and unplug the Test Set.
- 2. Remove the six TX-15 torx screws in the rear frame, see figure 4-1 on page 99. It is not necessary to remove the front frame or external cover.
- 3. Remove the rear frame.
- 4. Replace the AA batteries. Do not use rechargeable batteries, and dispose the used batteries properly.
- 5. Re-install the rear frame.

Figure 4-1 AA Batteries and Air Filter



# **PC Card Battery**

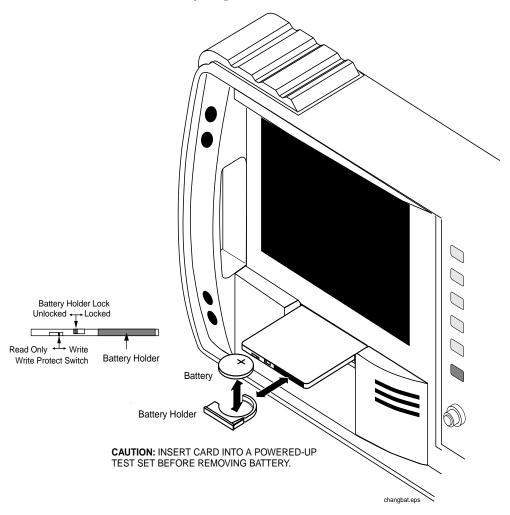
#### **CAUTION**

BEFORE REMOVING THE BATTERY from the PC card, insert the card into a powered-up Test Set. Removing the battery without an alternate power source will destroy the data in the card.

External PC card (PCMCIA) contain batteries which require replacement. These batteries should be replaced every 12 months or whenever signs of lost data are noted. See figure 4-2 for battery replacement.

Chapter 4 99

Figure 4-2 PCMCIA Card Battery Replacement



# 5 Disassembly

This chapter explains how to disassemble the Test Set for major assembly replacement.

Chapter 5 101

# **Service Tools**

#### **Tools**

One or more of the following tools may be required to access and/or remove various internal assemblies in the Test Set:

- TX-10 torx screwdriver
- TX-15 torx screwdriver
- Flat blade screwdriver
- 1/16-inch allen wrench
- 3/16-inch socket wrench
- 5/16-inch open-end wrench (for SMC connectors)
- 15/64-inch open-end wrench (for SMA connectors)
- 9/16-inch open-end wrench (for BNC connectors)
- 3/4-inch open-end wrench (for Type-N connectors)

# **Recommended Torque**

- · Tighten screws until snug. Overtightening can strip screws.
- SMA (RF) connectors: 9.0 lb-in. (102 N-cm)
- SMC (RF) connectors: 6.0 lb-in. (68 N-cm)
- Nuts holding semi-rigid coax to motherboard: 6.0 lb-in. (68 N-cm)

# **Assembly Replacements**

With some assemblies you will receive a memory card that contains factory-generated calibration data for that assembly. For new replacements, there will also be an instruction sheet for loading the calibration data into your Test Set.

Table on page 76 and table on page 160 show which assemblies need calibration data as well as which performance tests and periodic self-calibration adjustments are recommended after replacing an assembly.

#### NOTE

# Periodic Adjustment Intervals

The adjustment programs Periodic Calibration and IQ Calibration should be performed after any assembly referred to in table on page 160 is replaced, or at least every 24 months. These calibration programs can be run anytime to optimize the performance of the Test Set. See Chapter 7, "Periodic Adjustments," on page 159 for details.

#### **NOTE**

#### **Performance Test Intervals**

The performance tests in Chapter 8, "Performance Tests" on page 173 should be performed when certain assemblies are repaired or replaced, or at least every 24 months. See table on page 76 for those assemblies requiring performance testing/calibration.

# **Replacement Parts**

For replacement part numbers, see Chapter 6, "Replaceable Parts" on page 135. For cable routing information refer to table 5-2 on page 130.

Chapter 5 103

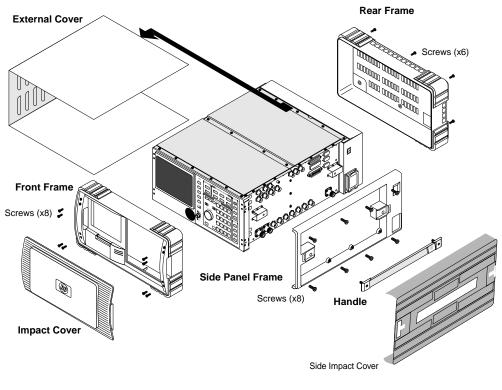
# **Removing the External and Internal Covers**

To access most of the components inside the Test Set, you must remove the front frame, external cover, and internal covers (see figure 5-1 and figure 5-2). It is not necessary to remove the side panel or rear frames in most cases. You must remove the rear frame to access the memory-backup AA-batteries, power supply assemblies.

#### **External Covers**

- **Step 1.** To remove the front frame, remove the eight screws securing it and pull it away from the chassis, see figure 5-1.
- **Step 2.** After removing the front frame, remove the external cover by sliding it slightly forward and away from the chassis.
- **Step 3.** To access the backup batteries, power supply, or GFI, remove the rear frame by removing the 6 screws securing it to the chassis. Pull the rear frame away from the chassis.
- **Step 4.** To remove the side panel frame, remove the handle and eight screws securing this frame to the chassis.

Figure 5-1 External Cover Removal



extcvrs3.eps

#### **Internal Covers**

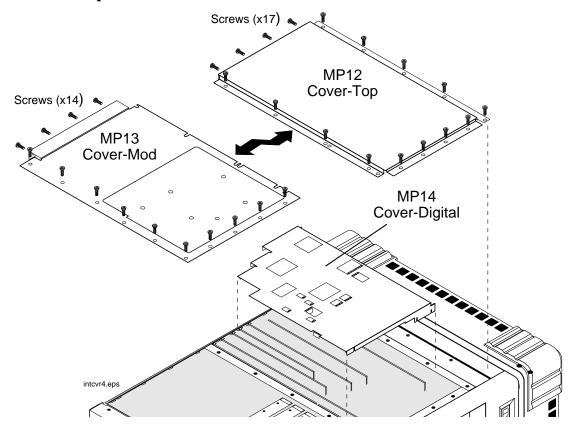
There are internal covers protecting the top- and bottom-side assemblies of the Test Set.

To remove the top covers, see "Top Internal Covers" below. To remove the bottom cover, see "Bottom Internal Cover" on page 107.

### **Top Internal Covers**

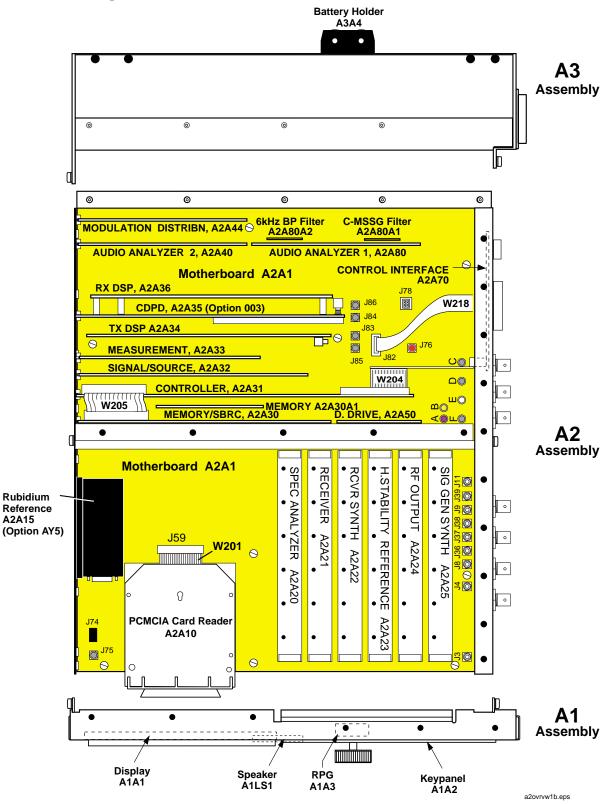
- **Step 1.** Remove the front frame and external cover, see "External Covers" on page 104. Side panel and rear frame removal is not necessary.
- **Step 2.** To access the top-side assemblies, remove the MP13 and MP12 internal covers by removing the screws securing these covers to the chassis, see figure 5-2.
- Step 3. Lift the MP14 cover to access the printed circuit assemblies.Refer to figure 5-3 on page 106 to help you identify the assemblies and components in the Test Set.

Figure 5-2 Top Internal Covers



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Figure 5-3 Top View of Test Set



#### **Bottom Internal Cover**

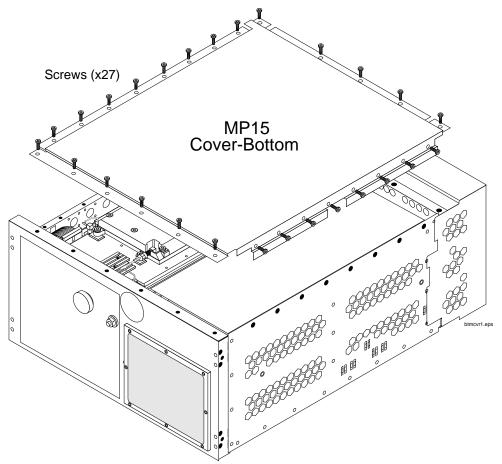
To access the assemblies on the bottom side of the Test Set, turn the Test Set over, remove the screws shown in figure 5-4, and lift the bottom internal cover from the chassis.

#### **CAUTION**

If the external and internal covers have been removed, be careful not to damage any PC (Printed Circuit) assemblies. Some of these assemblies have pull rings that can get hooked and pull the assemblies from their motherboard connections.

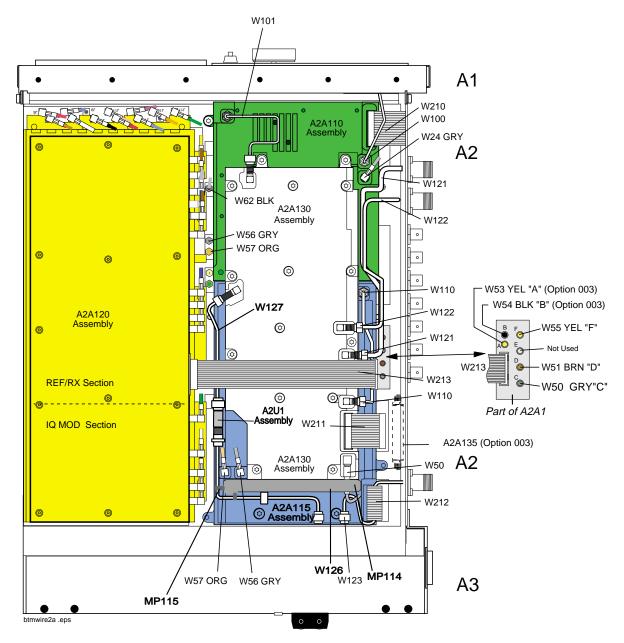
Use figure 5-5 on page 108 to identify the assemblies on the bottom side of the Test Set.

Figure 5-4 Bottom Internal Cover



Chapter 5 107

Figure 5-5 Bottom View of Test Set (without Bottom Cover)

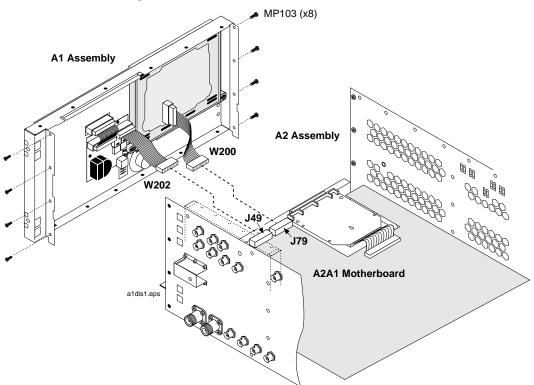


# **A1 Front Panel Disassembly**

- **Step 1.** Remove the front frame, external cover, and internal top and bottom covers, see "Removing the External and Internal Covers" on page 104.
- **Step 2.** Remove the eight screws securing the A1 assembly to the A2 assembly, see figure 5-6.
- **Step 3.** Disconnect cables W200 and W202 from connectors J79 and J49 on the A2A1 motherboard.

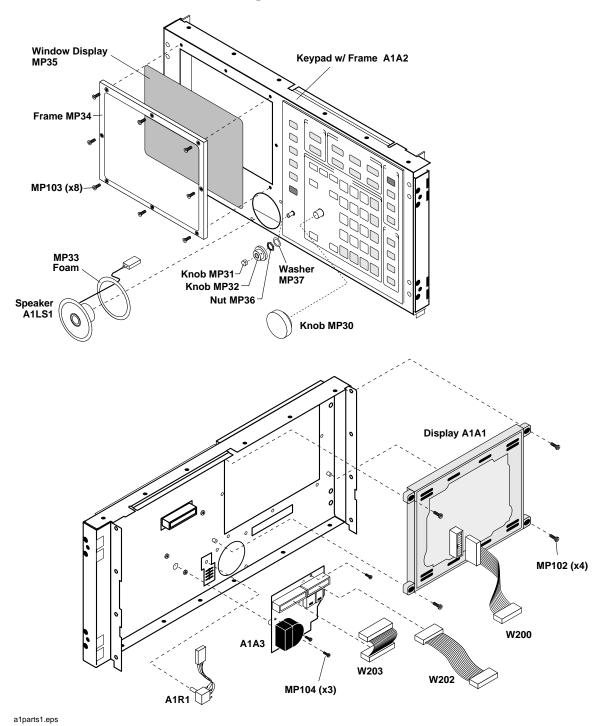
To replace a component or subassembly on the A1 assembly, see figure 5-7 on page 110.

Figure 5-6 A1 Assembly



Chapter 5 109

Figure 5-7 A1 Assemblies and Components



# **A2 Chassis Disassembly**

This section describes how to disassemble the A2 assembly. Use table 5-1 below to see which assemblies are replaceable.

### NOTE

### Periodic Adjustment Intervals

The adjustment programs Periodic Calibration, IQ Calibration, and Eb/No Calibration should be performed after any assembly referred to in table 7-1 on page 160 is replaced, or at least every 24 months. These program can be run anytime to optimize the performance of the Test Set. See Chapter 7, "Periodic Adjustments," on page 159 for details.

#### NOTE

### **Performance Test Intervals**

The performance tests in Chapter 8, "Performance Tests" on page 173 should be performed when certain assemblies are repaired or replaced, or at least every 24 months. See table 3-5 on page 76 for those assemblies requiring performance testing/calibration.

Table 5-1 A2 Assemblies

| Module Description   | Page Number  |
|--|--------------|
| Module and PC Board Assemblies                             | see page 111 |
| RX DSP and A2A35 CDPD (Option 003) Assemblies              | see page 114 |
| PCMCIA Card Reader Assembly                                | see page 115 |
| Control Interface Assembly                                 | see page 116 |
| RF I/O, Upconverter, & Downconverter Assemblies            | see page 117 |
| REF RX/IQ Modulator and Premodulation Filter<br>Assemblies | see page 120 |
| Attenuator Assembly  | see page 122 |
| Motherboard Assembly                                       | see page 122 |
| Rubidium Reference Assembly (Option AY5)                   | see page 124 |
| CDPD Directional Coupler and Switch (Option 003)           | see page 124 |

### **Module and PC Board Assemblies**

For cable routing information see table 5-2 "Wire/Cable List" on page 130.

- **Step 1.** Remove the Test Set's external and top internal covers, see "Removing the External and Internal Covers" on page 104.
- **Step 2.** Remove modules using a flat-blade screwdriver to pry them upward from the chassis, see

figure 5-9 on page 113.

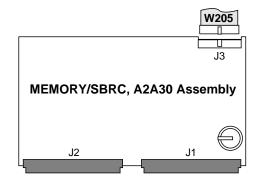
**Step 3.** Remove PC board assemblies by lifting them from the chassis (some assemblies have pull rings) and then disconnect any cables that may be attached to it.

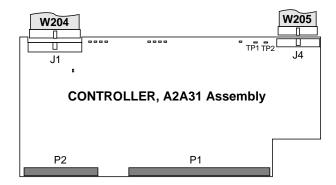
See figure 5-8 for the cable connections on the Memory/SBRC and Controller assemblies.

For removing the filter assemblies from the Audio Analyzer 1assembly see "A2A80A1 and A2A80A2 Filter Assembly Removal" on page 114.

For removing the RX DSP and/or A2A35 CDPD (Option 003) assemblies see "RX DSP and A2A35 CDPD (Option 003) Assemblies" on page 114.

Figure 5-8 Memory/SBRC and Controller Assemblies

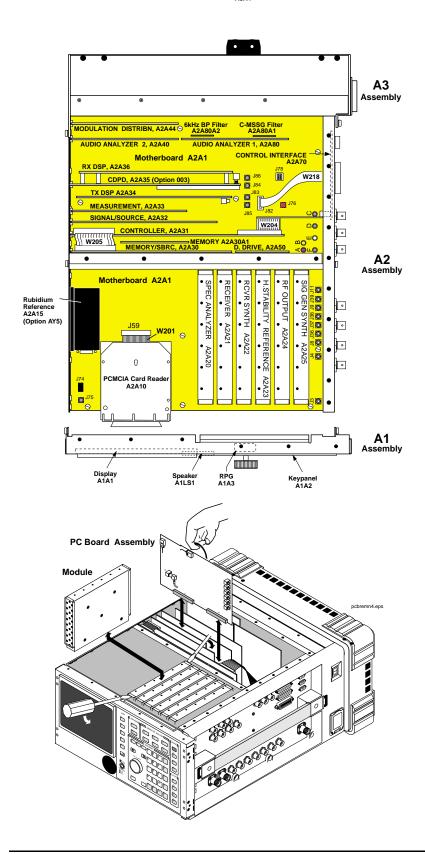




a2\_pcbs3.eps

Figure 5-9 Module and PC Board Assemblies

Battery Holder
A3A4

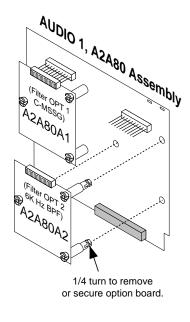


### A2A80A1 and A2A80A2 Filter Assembly Removal

To remove either of the Audio filter assemblies on the A2A80 Audio Analyzer 1 assembly:

- **Step 1.** Remove the A2A80 assembly from the Test Set.
- **Step 2.** Turn the plastic hex nut on each standoff a quarter turn and push the standoffs through their holes to release the filter board from the host board, see figure 5-10. It may be necessary to compress or squeeze the expandable flanges to slide them through the mounting holes.

Figure 5-10 A2A80 Audio Analyzer 1 Assembly

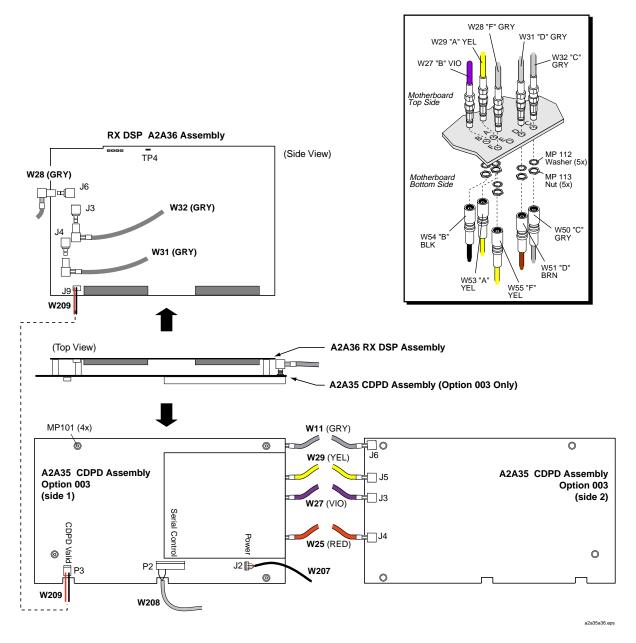


### RX DSP and A2A35 CDPD (Option 003) Assemblies

a2a80.eps

- **Step 1.** Pull the RX DSP A2A36 assembly from the Test Set and disconnect all cables, see figure 5-9 on page 113 and figure 5-11 below. If the Test Set includes Option 003, the CDPD A2A35 assembly is attached to the RX DSP assembly.
- **Step 2.** To remove the CDPD assembly, remove the four screws securing it to RX DSP assembly.

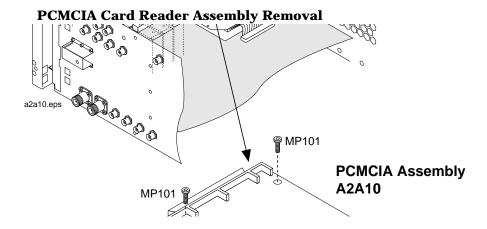
Figure 5-11 RX DSP and CDPD (Option 003) Assembly Removal



# **PCMCIA Card Reader Assembly**

- **Step 1.** Remove the front frame, external cover, and the front internal cover from the Test Set, see "Top Internal Covers" on page 105.
- **Step 2.** Remove the memory card from the card slot.
- **Step 3.** See figure 5-12. Remove the two screws and disconnect ribbon cable W201 from the PCMCIA assembly. Lift the assembly from the chassis.

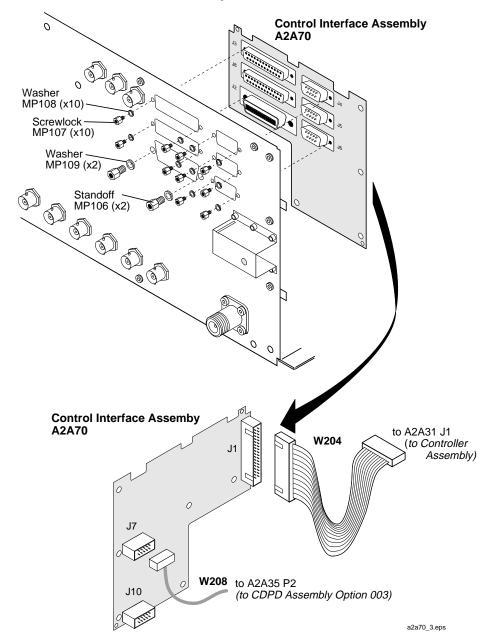
Figure 5-12



# **Control Interface Assembly**

- **Step 1.** Remove the standoffs and screwlocks from the connector panel as shown in figure 5-13 from the Test Set.
- **Step 2.** Disconnect cables W204 and W208 from the A2A70 assembly.

Figure 5-13 Control Interface Assembly Removal



## RF I/O, Upconverter, & Downconverter Assemblies

The RF Input/Output A2A130, Upconverter A2A110, and Downconverter A2A115 assemblies are secured in an interlocking manner and are disassembled in the following order:

RF Input/Out Assembly Removal

- **Step 1.** Remove the bottom cover of the Test Set. See "Removing the External and Internal Covers" on page 104.
- **Step 2.** Disconnect all wires and cables shown figure 5-14 on page 119.

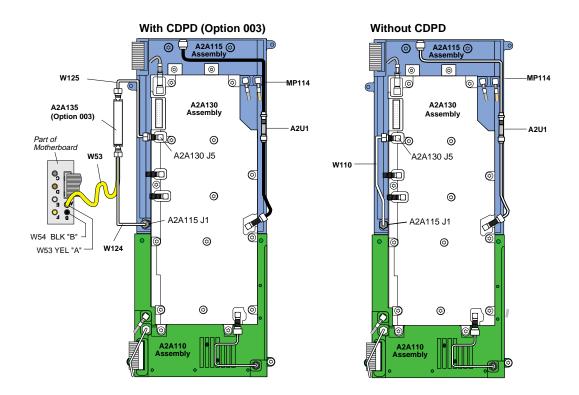
- **Step 3.** Remove the four torx screws (MP101) securing the RF Input/Output assembly to the other assemblies.
- **Step 4.** Slide the RF Input/Output assembly away from the Downconverter assembly's slot to remove the assembly.
  - **Upconverter Assembly Removal**
- **Step 1.** Remove the RF Input/Output as previously instructed.
- **Step 2.** Disconnect wires and cables shown figure 5-14 on page 119.
- **Step 3.** Remove the four torx screws securing this assembly and lift it away from the chassis.

  Downconverter Assembly Removal
- **Step 1.** Remove the RF Input/Output and Upconverter assemblies as previously instructed.
- **Step 2.** Disconnect all wires and cables shown in figure 5-14.
- **Step 3.** Remove the four torx screws securing this assembly and lift it away from the chassis.

When reassembling, reverse the order of disassembly, that is, install the Downconverter assembly first, the Upconverter second, and the RF Input/Output assembly last. For wire/cable routing information, see table 5-2 "Wire/Cable List" on page 130.

to A2A1 J34 RF Input/Output W110 or W125 see below Assembly A2A130 W121 MP101<sup>₽</sup> W100 W125 MP105 @ MP101 to A2A1 J32 MP111 ₩P105 MP101 MP101 MP100 Upconverter W57 Assembly A2A110 MP110 W110 or W124 see below MP105 MP105 partmod1a.eps Downconverter Assembly A2A115

Figure 5-14 RF Input/Output, Upconverter, & Downconverter Removal



## **REF RX/IQ Modulator and Premodulation Filter Assemblies**

The Reference Receiver/IQ Modulator and Generator Reference assemblies need to be removed in the following order. See figure 5-16 on page 121.

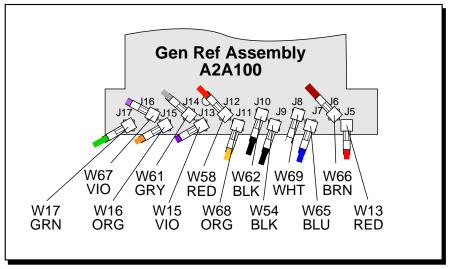
### Removing the REF RX/IQ Modulator Assembly

- **Step 1.** Remove the bottom cover, see "Bottom Internal Cover" on page 107.
- **Step 2.** Disconnect all wires and cables shown in figure 5-16 on page 121.
- **Step 3.** Remove the nine torx screws that secure this assembly to the chassis.

## **Removing the Premodulation Filter Assembly**

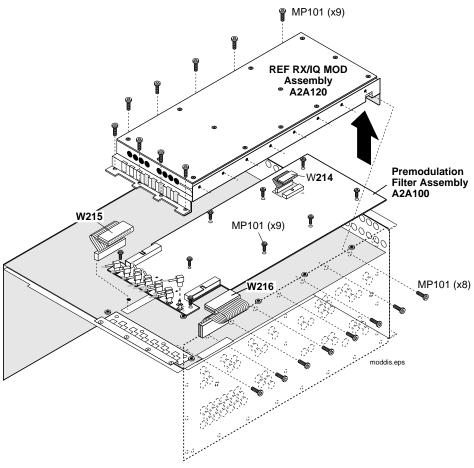
- **Step 1.** Remove the REF RX/IQ Modulator assembly.
- **Step 2.** Disconnect the cables shown in figure 5-15.
- **Step 3.** Remove the nine torx screws securing the assembly to the chassis and lift the assembly, see figure 5-16 on page 121.

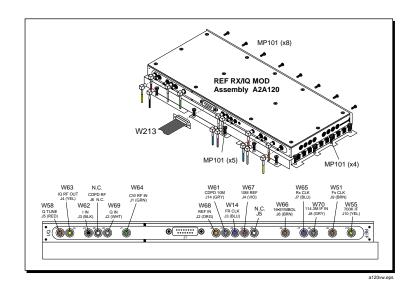
Figure 5-15 Premodulation Filter Assembly Wiring



a100vw.eps

Figure 5-16 REF RX/IQ Modulator & Premodulation Filter Removal

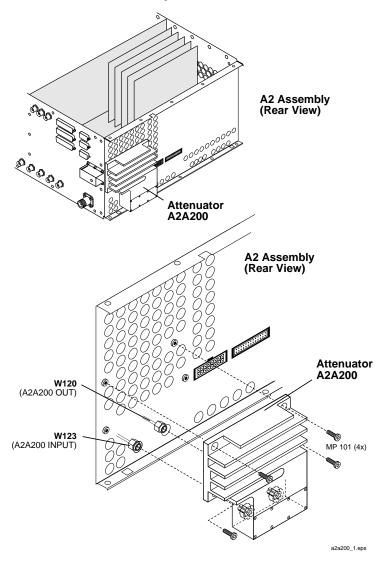




## **Attenuator Assembly**

- **Step 1.** Remove the front, side, and rear external covers, and the top and bottom internal covers, see "Removing the External and Internal Covers" on page 104.
- **Step 2.** Remove the power supply assembly, see "A3 Power Supply Disassembly" on page 126.
- **Step 3.** Turn the Test Set over and disconnect cables W120 and W123 from the attenuator, see figure 5-17.
- **Step 4.** Remove the four screws that secure the attenuator to the chassis, see figure 5-17.

Figure 5-17 100W Attenuator Assembly Removal



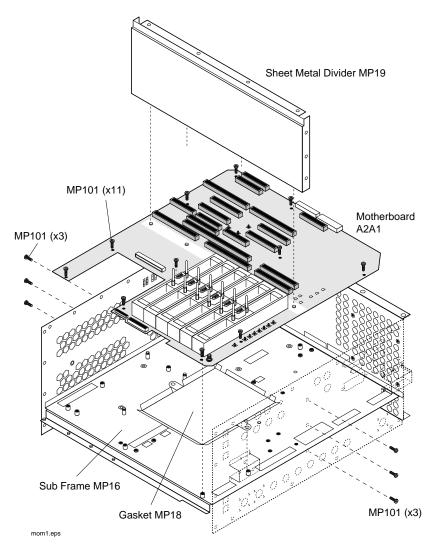
# **Motherboard Assembly**

**Step 1.** Remove the all external and internal (top and bottom) covers from the Test Set, see "Removing the External and Internal Covers" on page 104.

- **Step 2.** Remove all the modules and PC board assemblies. See "Module and PC Board Assemblies".
- **Step 3.** Remove the A1 front panel and A3 rear panel assemblies. See "A1 Front Panel Disassembly" on page 109 and "A3 Power Supply Disassembly".
- **Step 4.** Remove the six torx screws securing the sheet metal divider and then remove the divider, see figure 5-18 on page 123
- **Step 5.** Disconnect all the connectors on the top side of the motherboard.
- **Step 6.** Disconnect all the connectors on the bottom side of the motherboard.
- **Step 7.** Remove the 11 torx screws securing the motherboard to the chassis and lift it up to remove it.

To reassemble the Test Set, perform the previous steps in reverse order. For wire/cable routing information, see table 5-2 "Wire/Cable List" on page 130.

Figure 5-18 Motherboard Removal



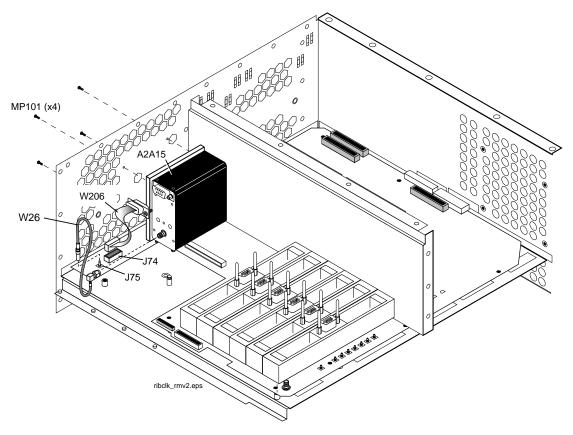
## **Rubidium Reference Assembly (Option AY5)**

This assembly is an option. To remove this assembly, remove the cables and screws shown in the figure 5-19 below.

### WARNING

The optional Rubidium Reference assembly, A2A15, (OPTION AY5) of the Agilent Technologies 8935 Series E6381A TDMA Base Station Test Set contains the radioactive isotope Rubidium 87. DO NOT attempt to repair this assembly. This assembly contains no user serviceable parts. The Rubidium 87 is isolated inside a vacuum tube which is enclosed within a metal housing, and as a result, there is no measurable external radiation. The Rubidium Reference assembly does not present any safety hazards. For disposal purposes, this assembly is regulated as a hazardous waste and must be disposed of in accordance with local, state, and federal laws. For important shipping information, see "RUBIDIUM REFERENCE ASSEMBLY" on page 16.

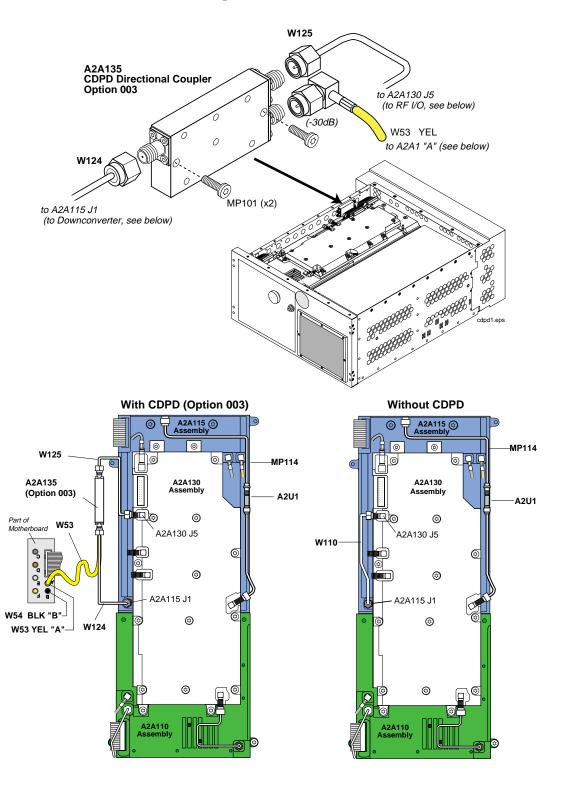
Figure 5-19 Rubidium Reference Assembly, A2A15



## CDPD Directional Coupler and Switch (Option 003)

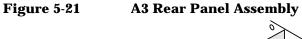
Remove the screws and cables shown in figure 5-20. Note that in non-CDPDTest Sets, the directional coupler A2A135 and cables W53, W124, and W125 are not included and are replaced with one cable, W110.

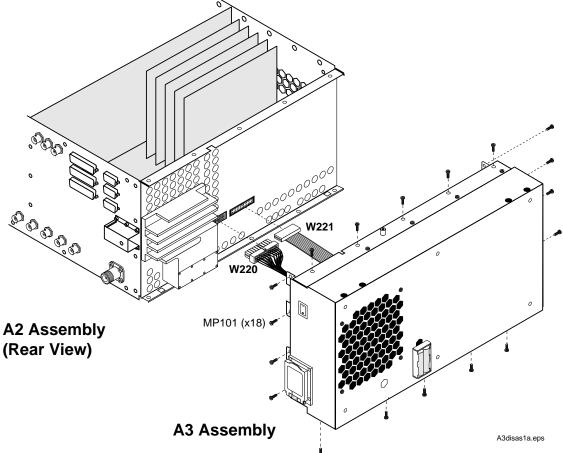
Figure 5-20 CDPD Directional Coupler



# **A3 Power Supply Disassembly**

- **Step 1.** Remove the Test Set's external and internal covers, see "Removing the External and Internal Covers" on page 104.
- **Step 2.** Remove the eighteen torx screws securing the A3 assembly to the A2 assembly, see figure 5-21.
- **Step 3.** Move the A3 assembly away from the A2 assembly and disconnect cables W220 and W221.

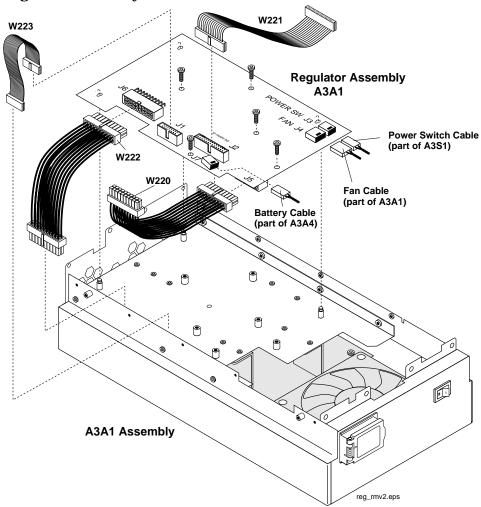




## **Removing the Power Supply Regulator Assembly**

To remove the A3A1 regulator assembly, disconnect the cables and the four torx screws shown in figure 5-22.

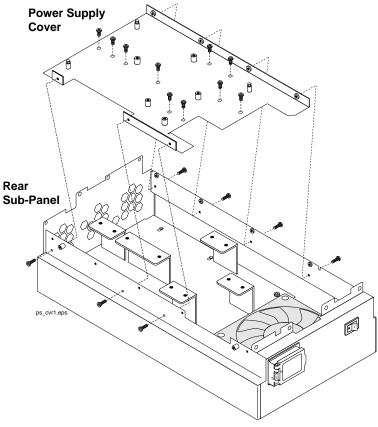
Figure 5-22 A3A1 Regulator Assembly

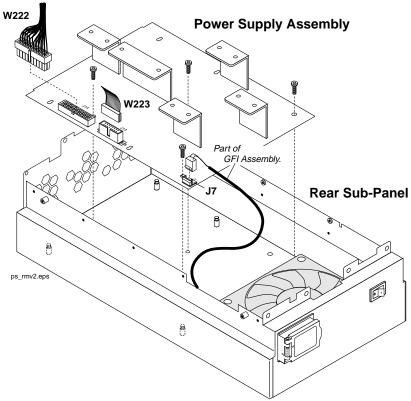


# **Removing the Power Supply Assembly**

- **Step 1.** Remove the regulator assembly.
- **Step 2.** Remove the power supply cover from the A3 assembly, see figure 5-23 on page 128.
- **Step 3.** Disconnect cables W222, W223, and GFI-assembly cable at J7.
- **Step 4.** Remove the four screws securing the power supply to the rear sub panel.

Figure 5-23 Power Supply Removal

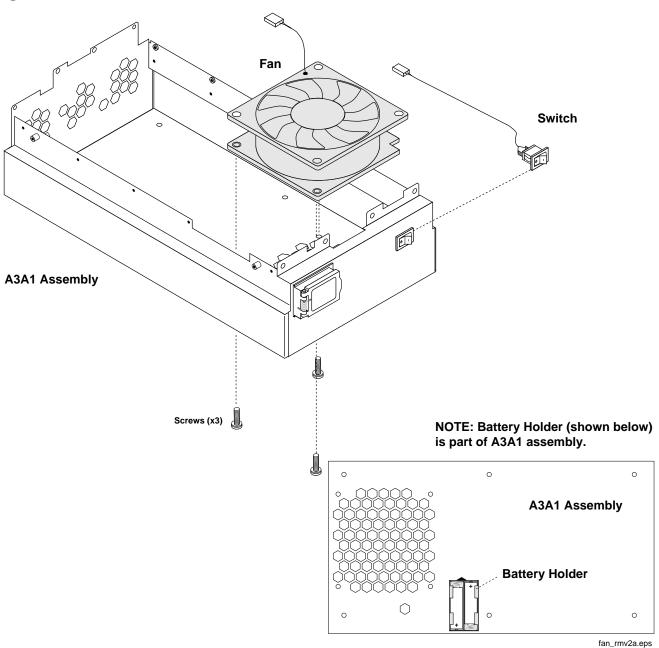




## Power Supply Switch, Fan, & Battery Holder Assemblies

- **Step 1.** Remove the regulator assembly, see "Removing the Power Supply Regulator Assembly" on page 127, and power-supply cover and subassemblies, see "Removing the Power Supply Assembly" on page 127.
- **Step 2.** To remove the fan, remove the three screws shown in figure 5-24.
- **Step 3.** The A3S1 power switch assembly is normally riveted in place. However this assembly is replaceable and screws can be used to replace the rivets, see figure 5-24.

Figure 5-24 Fan and Power Switch Assemblies



# **Wire/Cable Information**

Table 5-2 Wire/Cable List

| Wire #  | From   | То                                   | Part Number |
|---------|--|--------------------------------------|-------------|
| W1      | "AUDIO OUT" (Side Panel)                         | A2A1 J8                              | E6380-61039 |
| W2      | "AUDIO IN - HI" (Side Panel)                     | A2A1 J9                              | E6380-61039 |
| W3      | "AUDIO IN - LO" (Side Panel)                     | A2A1 J11                             | E6380-61039 |
| W4      | "TDMA ANALYZER INPUTS -<br>TRIGGER" (Side Panel) | A2A1 J86                             | E6381-61007 |
| W5      | "TDMA ANALYZER INPUTS -<br>DATA" (Side Panel)    | A2A1 J84                             | E6381-61007 |
| W6      | "TDMA ANALYZER INPUTS -<br>CLOCK" (Side Panel)   | A2A1 J85                             | E6381-61007 |
| W7      | "AUDIO MONITOR OUTPUT"<br>(Side Panel)           | A2A1 J37                             | E6380-61039 |
| W8      | "EXT SCOPE TRIG IN" (Side Panel)                 | A2A1 J38                             | E6380-61039 |
| W9      | "VIDEO OUT" (Side Panel)                         | A2A1 J39                             | E6380-61039 |
| W10     | "MODULATION INPUT" (Side Panel)                  | A2A1 J36                             | E6380-61039 |
| W11     | "OPTIONAL CDPD MOD OUT"<br>(Side Panel)          | A2A35 J6 "FM MODE OUT"<br>(GRY)      | E6381-61008 |
| W12     | "GENERATOR DATA IN" (Side Panel)                 | A2A1 J83                             | E6381-61007 |
| W13     | "DIGITAL MUX OUT" (Side Panel)<br>(RED)          | A2A100 J5 "DIGITAL MUX"<br>(RED)     | E6380-61073 |
| W14     | "FRAME CLK OUT" (Side Panel)<br>(BLU)            | A2A120 J3 "FR CLK" (BLU)             | E6381-61005 |
| W15     | "TDMA REF IN" (Side Panel) (VIO)                 | A2A100 J13 "TDMA REF<br>IN" (VIO)    | E6380-61075 |
| W16     | "10 MHz REF OUT" (Side Panel)<br>(ORG)           | A2A100 J15 "10 MHz REF<br>OUT" (ORG) | E6380-61076 |
| W17     | "SYNTH REF IN" (Side Panel)<br>(GRN)             | A2A100 J17 "SYNTH REF<br>IN" (GRN)   | E6380-61077 |
| W18-W23 | NOT USED   | NOT USED                             |             |
| W24     | A2A1 J4 (GRY)                                    | A2A110 J3<br>"MEAS_20M_REF"          | E6380-61047 |

Table 5-2 Wire/Cable List

| Wire #           | From                           | То                               | Part Number |
|------------------|--------------------------------|----------------------------------|-------------|
| W25 (Opt 003)    | A2A1 J76                       | A2A35 J4 (RED)                   | E6381-61020 |
| W26 (Opt<br>AY5) | A2A1 J75                       | A2A15 SMA                        | E6381-61017 |
| W27 (Opt<br>003) | A2A1 "B" (VIO)                 | A2A35 J3                         | E6381-61021 |
| W28              | A2A1 "F" (GRY)                 | A2A36 J6 "RX DSP IF"             | E6381-61028 |
| W29 (Opt<br>003) | A2A1 "A" (YEL)                 | A2A35 J5                         | E6381-61027 |
| W30              | NOT USED - A2A1 "E"            |                                  |             |
| W31              | A2A1 "D" (GRY)                 | A2A36 J4 "EXT PS"                | E6381-61028 |
| W32              | A2A1 "C" (GRY)                 | A2A36 J3 "EXT IN"                | E6381-61028 |
| W33-W49          | NOT USED                       |                                  | N/A         |
| W50              | A2A1 "C" (GRY)                 | A2A130 J7 (GRY )                 | E6380-61051 |
| W51              | A2A1 "D" (BRN )                | A2A120 J9 "Fs CLK"<br>(BRN)      | E6380-61066 |
| W52              | NOT USED                       | NOT USED                         |             |
| W53 (Opt<br>003) | A2A1 "A" (YEL)                 | A2A135 J4 "-30dB" (YEL)          | E6381-61017 |
| W54 (Opt<br>003) | A2A1 "B" (BLK)                 | A2A100 J9 (BLK)                  | E6380-61046 |
| W55              | A2A1 "F" (YEL)                 | A2A120 J10 "700K IF"<br>(YEL)    | E6381-61016 |
| W56              | A2A115 J3 (GRY)                | A2A1 J2                          | E6380-61064 |
| W57              | A2A115 J2 (ORG)                | A2A1 J1                          | E6380-61050 |
| W58              | A2A120 J5 "QUAD TUNE" (RED)    | A2A100 J12 "QUAD ADJ"<br>(RED)   | E6380-61063 |
| W59-W60          | NOT USED                       |                                  | N/A         |
| W61              | A2A100 J14 "115/118 REF" (GRY) | A2A120 J14 "CDPD 10M"<br>(GRY)   | E6381-61015 |
| W62              | A2A120 J3 "I IN" (BLK)         | A2A100 J10 "I CHAN MOD"<br>(BLK) | E6381-61010 |
| W63              | A2A120 J4 "IQ RF OUT" (YEL)    | A2A1 J7 (YEL)                    | E6380-61059 |
| W64              | A2A120 J1 "CW RF IN" (GRN)     | A2A1 J6 (GRN)                    | E6380-61058 |

Table 5-2 Wire/Cable List

| Wire #            | From                           | То   | Part Number |
|-------------------|--------------------------------|--|-------------|
| W65               | A2A120 J7 "RX CLK" (BLU)       | A2A100 J7 "ANALYZER<br>DATA CLK OUT" (BLU) | E6380-61061 |
| W66               | A2A120 J6 "16* SYMBOL" (BRN)   | A2A100 J6 "16* SYMBOL<br>CLK" (BRN)        | E6381-61014 |
| W67               | A2A120 J4 "10M REF" (VIO)      | A2A100 J16 "TDMA 10 MHz<br>IN" (VIO)       | E6381-61013 |
| W68               | A2A120 J2 "REF IN" (ORG)       | A2A120 J11 "TDMA REF<br>OUT" (ORG)         | E6381-61012 |
| W69               | A2A120 J2 "Q IN" (WHT)         | A2A100 J8 "Q CHAN MOD"<br>(WHT)            | E6381-61011 |
| W70               | A2A120 J8 "114.3M IF IN" (GRY) | A2A1 J5 (GRY)                              | E6380-61060 |
| W71-W99           | NOT USED                       |  |             |
| W100              | A2A1 J3                        | A2A110 J1<br>"MAIN_RF_OUT"                 | E6380-61021 |
| W101              | A2A110 J2 "UPCNV_OUT"          | A2A130 J2                                  | E6380-61020 |
| W102-W109         | NOT USED                       |  | N/A         |
| W110              | A2A115 J1 "DNCNV_IN"           | A2A130 J5                                  | E6380-61034 |
| W121              | A2A130 J4                      | A2 J2 "ANT IN" (Panel)                     | E6380-61019 |
| W122              | A2A130 J6                      | A2 J3 "DUPLEX OUT"<br>(Panel)              | E6380-61018 |
| W123              | A2 J4 "RF IN/OUT" (Panel)      | A2A200 "INPUT"                             | E6380-61016 |
| W126              | A2U1 "DC BLOCK"                | A2A200 "OUT"                               | E6380-61111 |
| W127              | A2A130 J3                      | A2U1 "DC BLOCK"                            | E6380-61112 |
| W128-W199         | NOT USED                       |  | N/A         |
| W200              | A2A1 J79                       | A1A1 J2                                    | E6380-61062 |
| W201              | A2A1 J59                       | A2A10 J1                                   | E6380-61015 |
| W202              | A2A1 J49                       | A1A3 J1                                    | E6380-61022 |
| W203              | A1A3 J2                        | A1A2 (keypad assembly)                     | E6380-61068 |
| W204              | A2A31 J1                       | A2A70 J1                                   | E6380-61023 |
| W205              | A2A31 J4                       | A2A30 J3                                   | E6380-61052 |
| W206 (Opt<br>AY5) | A2A1 J74                       | A2A15 S-MIN-D                              | E6381-61024 |
| W207              | A2A1 J78                       | A2A35 J2                                   | E6381-61022 |
|                   |                                | 1  | 1           |

Table 5-2 Wire/Cable List

| Wire #                              | From                             | То                                    | Part Number |
|-------------------------------------|----------------------------------|---------------------------------------|-------------|
| W208                                | A2A70 J7                         | A2A35 P2 "SERIAL"                     | E6381-61009 |
| W209                                | A2A35 P3 (CDPD VALID)            | A2A36 J9 (CDPD VALID)                 | 83203-61049 |
| W210                                | A2A110 J4                        | A2A1 J32                              | E6380-61029 |
| W211                                | A2A130 J1                        | A2A1 J34                              | E6380-61029 |
| W212                                | A2A115 J4                        | A2A1 J31                              | E6380-61029 |
| W213                                | A2A120 J1                        | A2A1 J35                              | E6380-61028 |
| W214                                | A2A1 J64                         | A2A100 J3                             | E6380-61027 |
| W215                                | A2A1 J63                         | A2A100 J1 "POWER_REF"                 | E6380-61026 |
| W216                                | A2A1 J62                         | A2A100 J2 "GATED_BUS"                 | E6380-61026 |
| W217                                | NOT USED                         |                                       | N/A         |
| W218                                | "TDMA OUTPUTS" (Side Panel)      | A2A1 J82                              | E6381-61006 |
| W219                                | NOT USED                         |                                       | N/A         |
| W220                                | A3A1 J5                          | A2A1 J54                              | E6380-61036 |
| W221                                | A3A1 J2                          | A2A1 J73 (multiconductor power cable) | E6380-61049 |
| W222                                | A3A1 J6                          | POWER SUPPLY, A3A2 J14                | E6380-61049 |
| W223                                | A3A1 J1                          | POWER SUPPLY, A3A2 J13                | E6380-61035 |
| (cable part of<br>A3A4<br>assembly) | BATTERY HOLDER ASSEMBLY,<br>A3A4 | A3A1 J7                               | N/A         |
| (cable part of<br>A3S1<br>assembly) | POWER SWITCH, A3S1               | A3A1 J3                               | N/A         |
| (cable part of<br>A3B1<br>assembly) | FAN ASSEMBLY, A3B1               | A3A1 J4                               | N/A         |
| (cable part of<br>A3A3<br>assembly) | LINE MODULE ASSEMBLY, A3A3       | POWER SUPPLY, J7                      | N/A         |

# **6** Replaceable Parts

This chapter contains the replaceable assembly and component information for the Test Set. Use the illustrations in this chapter to identify the replaceable parts and the "Parts List" on page 153 for part numbers.

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# **Replacement & Ordering Parts**

## **Direct Parts Ordering**

See "Ordering Parts" on page 45. The Agilent Technologies Support Materials Organization can help identify parts for ordering.

## **Assembly Replacements**

With some assemblies you will receive a PCMCIA memory card that contains factory-generated calibration data for that assembly. There will also be an instruction sheet for loading the calibration data into your Test Set after you've replaced the assembly.

## NOTE Periodic Adjustment Interval

The adjustment programs Periodic Calibration and IQ Calibration should be performed after any assembly referred to in table 7-1 on page 160 is replaced, or at least every 24 months. These program can be run anytime to optimize the performance of the Test Set. See Chapter 7, "Periodic Adjustments" on page 159 for details.

### **NOTE** Performance Test Interval

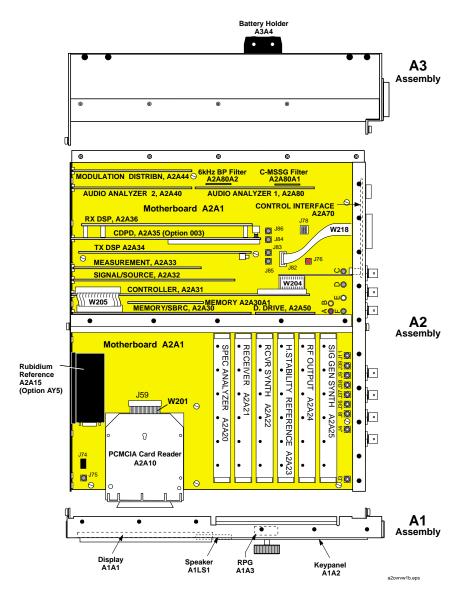
The performance tests in Chapter 8, "Performance Tests" on page 173 should be performed when certain assemblies are repaired or replaced, or at least every 24 months. See table 3-5 on page 76 for those assemblies requiring performance testing/calibration.

## **Parts Identification**

## **Major Assembly Overview**

Shown below is a top view of the Test Set with external and internal covers removed. The Test Set can be separated into three major assemblies designated: A1, A2, and A3. Throughout this chapter the reference designator for each sub-assembly is prefixed with its major assembly's designator. Take for example the PCMCIA assembly's reference designator A2A10: "A2" refers to the A2 major assembly and "A10" refers to the PCMCIA sub-assembly which is part of A2.

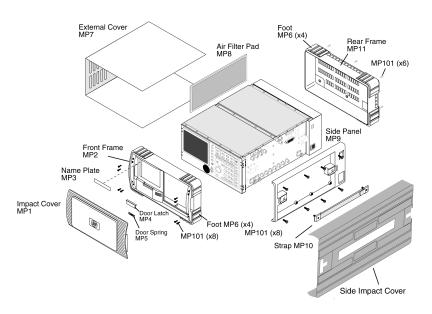
Figure 6-1 Major Assemblies

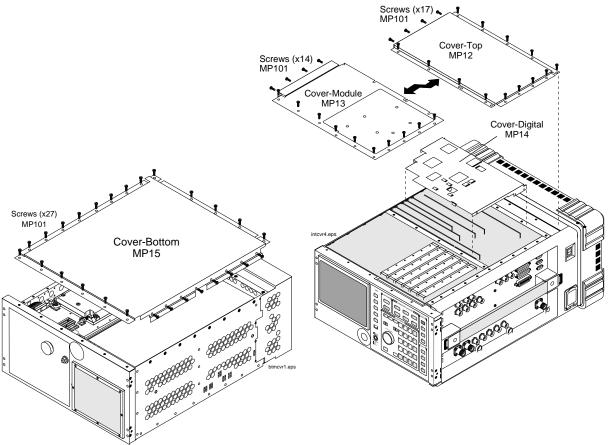


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# **Covers and Chassis Parts**

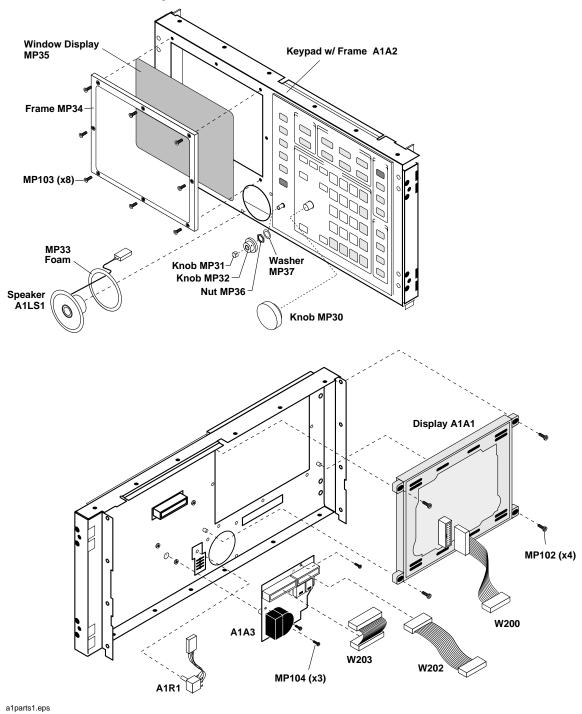
Figure 6-2 External and Internal Covers





## **A1 Assemblies**

Figure 6-3 A1 Assembly - Front Panel

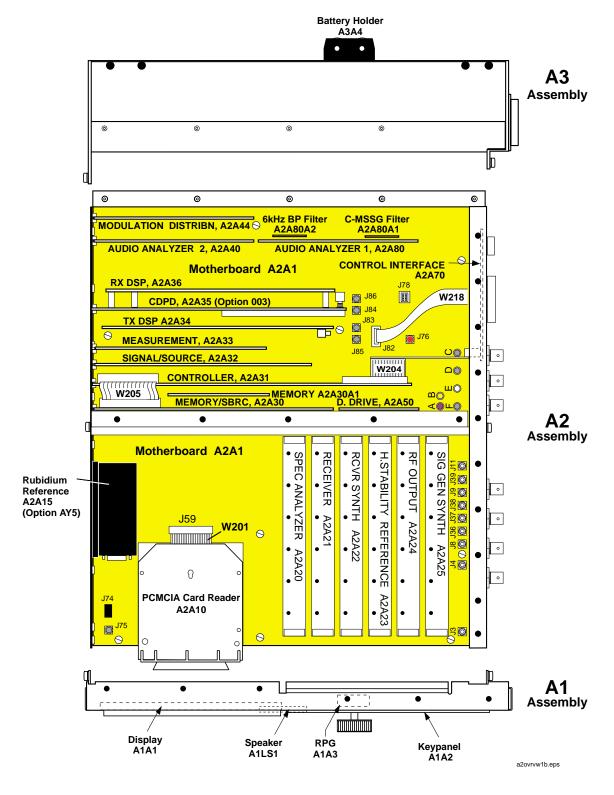


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## **A2 Assemblies**

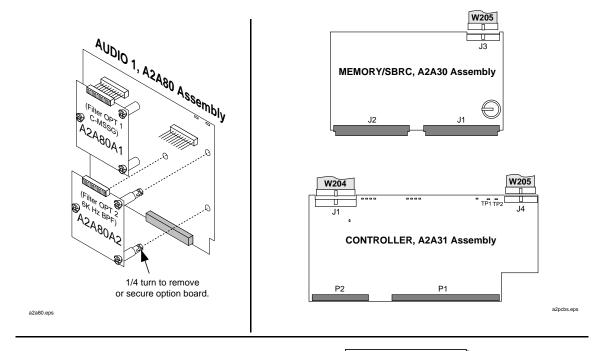
### **Module and PCB Board Assemblies**

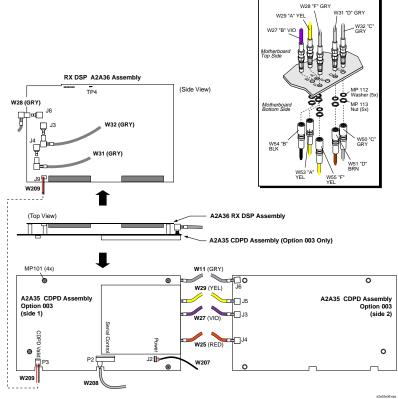
Figure 6-4



# A2A30, A2A31, A2A35 (OPTION 003), A2A36, A2A80, A2A80A1 & A2A80A1 Assemblies

Figure 6-5

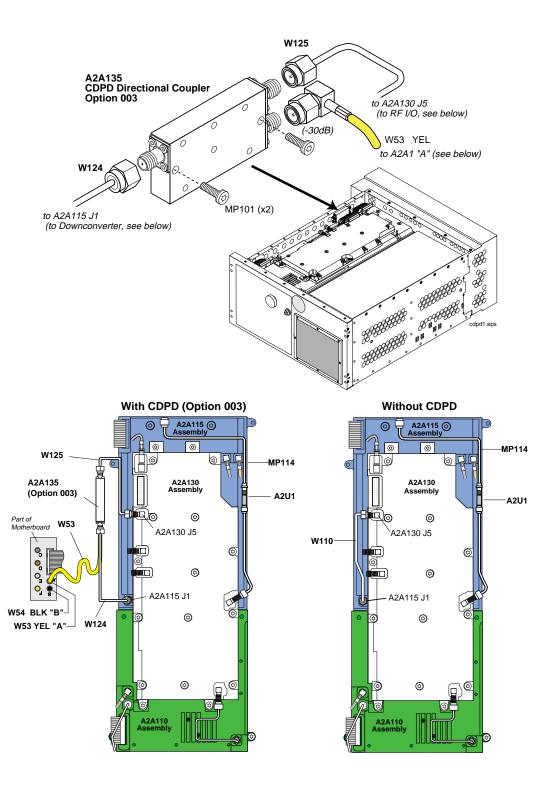




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## **CDPD Directional Coupler (Option 003)**

Figure 6-6

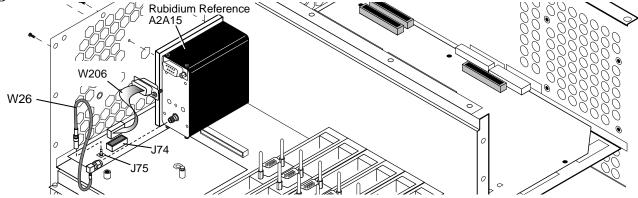


### **Rubidium Reference Assembly (Option AY5)**

### WARNING

The optional Rubidium Reference assembly of the Test Set contains the radioactive isotope Rubidium 87. This assembly contains no user serviceable parts. DO NOT attempt to repair it. There is no measurable external radiation. This assembly does not present a safety hazard. This assembly is regulated as a hazardous waste and must be disposed of in accordance with local, state, and federal regulations. For important shipping information, see "RUBIDIUM REFERENCE ASSEMBLY" on page 16.

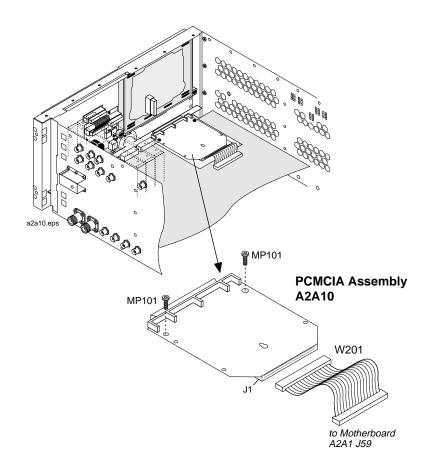
Figure 6-7



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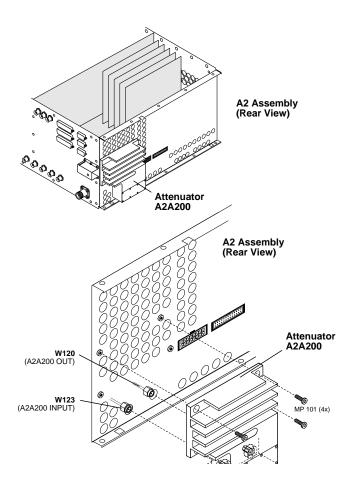
# **PCMCIA Assembly**

Figure 6-8



# **Attenuator Assembly**

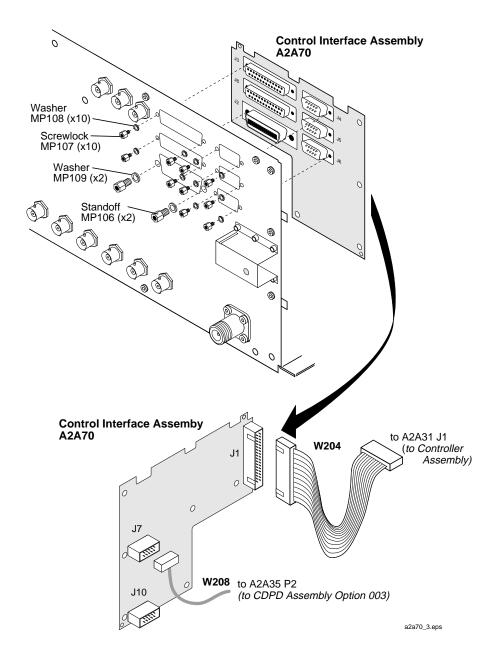
Figure 6-9



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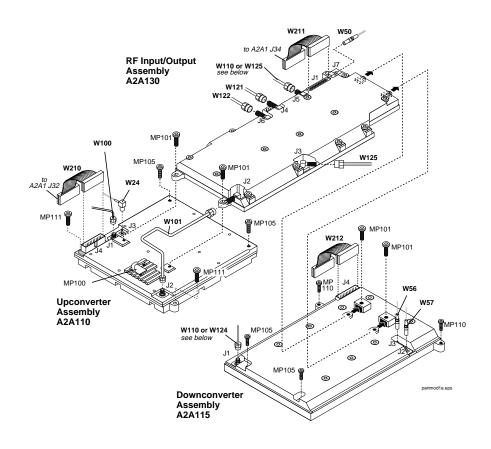
## **Control Interface Assembly & Connectors**

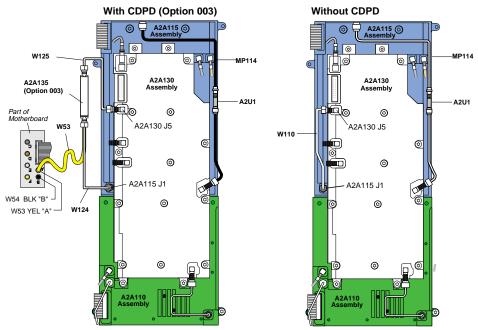
Figure 6-10



## RF Input/Output, Upconverter, and Downconverter Assemblies

Figure 6-11

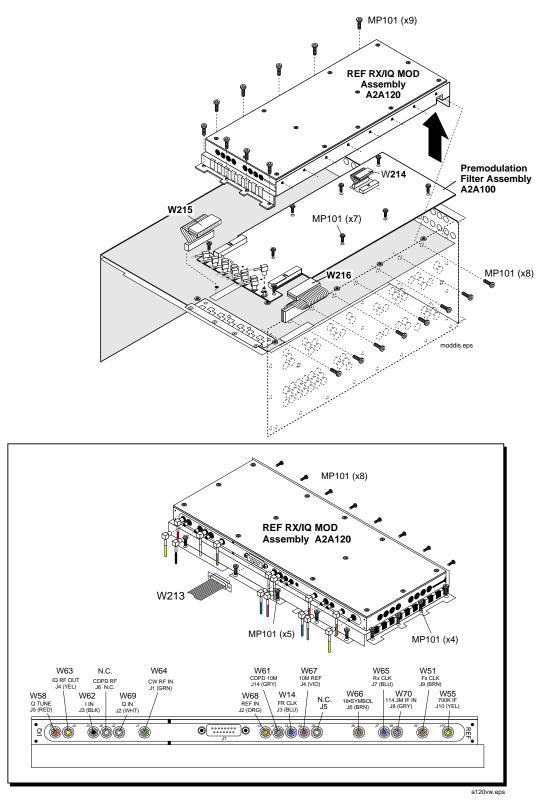




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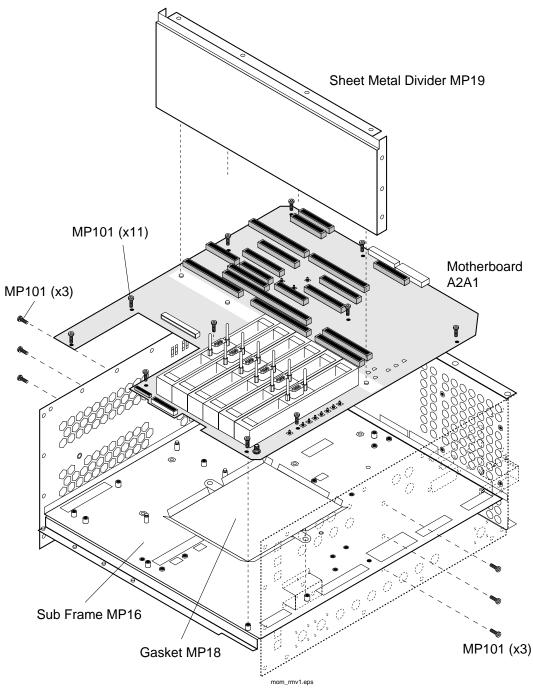
## **REF RX/IQ MOD and GEN REF Assemblies**

Figure 6-12



## **Motherboard and Sub Frame**

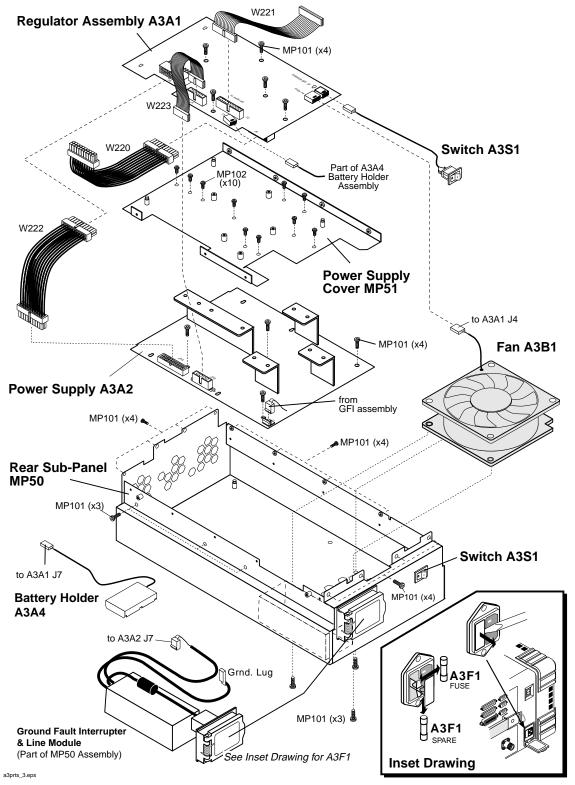
Figure 6-13



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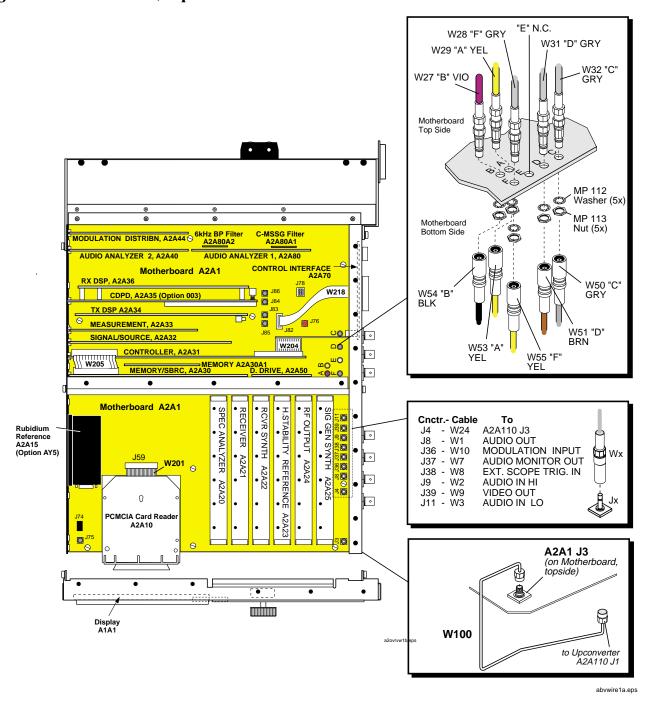
## **A3 Rear Panel Assembly**

Figure 6-14



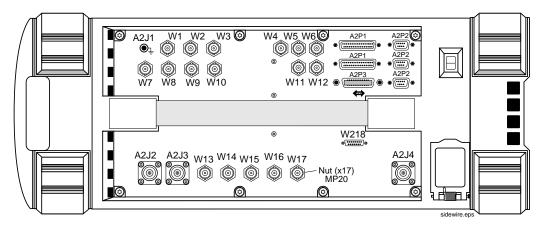
#### **Cable Assemblies**

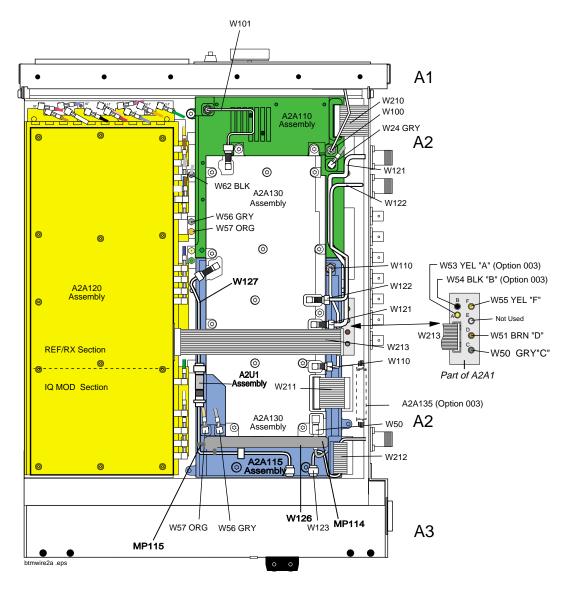
Figure 6-15 Cables, Top View



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Figure 6-16 Cables, Side Panel and Bottom Side Views





# **Parts List**

## Table 6-1

| Reference<br>Designator | Description            | Part Number |
|-------------------------|------------------------|-------------|
| A1                      | FRONT PNL KIT          | E6381-61807 |
| A1A1                    | EL DISPLAY 6.5IN       | 2090-0573   |
| A1A2                    | KEYPD W/FRAME KIT      | E6381-61804 |
| A1A3                    | RPG BD KIT             | E6380-61805 |
| A1LS1                   | SPEAKER ASSEMBLY       | E6380-61037 |
| A1R1                    | HARN SPKR ASSY         | E6380-61057 |
| A2A1                    | MOTHERBOARD KIT        | E6381-61801 |
| A2A10                   | PCMCIA CARD READER KIT | E6380-61803 |
| A2A15                   | FREQ STD-RUBIDIUM      | 1813-1318   |
| A2A20                   | SPECTRUM ANALYZER KIT  | 08920-61852 |
| A2A21                   | RECEIVER KIT           | E6380-61866 |
| A2A22                   | RCVR SYNTH KIT         | 08921-61820 |
| A2A23                   | HI STB REFERENCE KT    | 08920-61835 |
| A2A24                   | RF OUTPUT KIT          | E6380-61832 |
| A2A25                   | SIGGEN SYNTH KIT       | 08921-61819 |
| A2A30                   | MEMORY (SBRC) KIT      | E6380-61801 |
| A2A30A1                 | RAM DAUGHTER BD        | E6380-60114 |
| A2A31                   | CONTROLLER KIT         | E6381-61809 |
| A2A32                   | SIGNAL SOURCE KIT      | 08920-61850 |
| A2A33                   | MEASUREMENT KIT        | 08920-61836 |
| A2A34                   | TX/DSP KIT             | E6381-61806 |
| A2A35                   | CDPD KIT               | E6381-61810 |
| A2A36                   | RX/DSP KIT             | E6381-61805 |
| A2A40                   | AUDIO ANALYZER 2 KIT   | 08920-61853 |
| A2A44                   | MOD DISTRIBUTION KIT   | 08920-61809 |
| A2A50                   | DISPLAY DRIVER KIT     | E6380-61816 |

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# Table 6-1

| Reference<br>Designator | Description              | Part Number |
|-------------------------|--------------------------|-------------|
| A2A70                   | CONTROL INTERFACE KIT    | E6380-61815 |
| A2A80                   | AUDIO ANALYZER #1 KIT    | 08920-61811 |
| A2A80A1                 | C-MESS FLTR              | 08920-61056 |
| A2A80A2                 | 6KHZ BP FLT              | 08920-61063 |
| A2A100                  | PREMODULATION FILTER KIT | E6381-61803 |
| A2A110                  | UPCONV KIT               | E6380-61809 |
| A2A115                  | DNCONV KIT               | E6380-61808 |
| A2A120                  | REF RX/IQ KIT            | E6381-61802 |
| A2A130                  | RF/IO KIT                | E6380-61810 |
| A2A135                  | CPLR 30dB 0.8GHZ         | 0955-0999   |
| A2A200                  | 100W ATTEN KIT           | E6380-61892 |
| A2J1                    | BDG POST ASSY            | 1510-0038   |
| A2J2, A2J3,             | ADPTR-COAX SMA-N         | 1250-2621   |
| A2J4                    |                          |             |
| A2U1                    | DC BLOCK ASSEMBLY        | 0955-1125   |
|                         |                          |             |
| A3                      | REAR PANEL KIT           | E6380-61899 |
| A3A1                    | POWER SUPPLY REG KIT     | E6380-61804 |
| A3A2                    | POWER SUPPLY             | 0950-3690   |
| A3A4                    | CA AY-HARN,BTRY          | E6380-61025 |
| A3B1                    | FAN AY                   | E6380-61091 |
| A3F1                    | FUSE, T 5.0A             | 2110-0882   |
| A3S1                    | HRN PWR SWITCH           | E6380-61014 |
|                         |                          |             |
| ACC1                    | MANUALS CD-ROM           | E6381-90020 |
| ACC2                    | ALR                      | E6381-90015 |
| ACC3                    | GPIB SYNTAX              | E6381-90014 |
| ACC4                    | REFERENCE GUIDE          | E6381-90019 |

Table 6-1

| Reference<br>Designator | Description      | Part Number |
|-------------------------|------------------|-------------|
| ACC5                    | AMPS APP GUIDE   | E6381-90017 |
| ACC6                    | CA CXAY 50Z 1FT  | 8120-1838   |
| ACC7                    | FW REPL KIT      | E6381-61858 |
| ACC8                    | KIT-SYS PWR CAL  | E6380-61811 |
| ACC9                    | AC COUPLED KIT   | E6381-61820 |
|                         |                  |             |
| MP1                     | AY-IMPACT COVER  | E6380-61099 |
| MP2                     | AY FRONT FRAME   | E6380-61080 |
| MP3                     | NAMEPLATE        | E6381-00001 |
| MP4                     | CARD DOOR        | E6380-40006 |
| MP5                     | SPRING-COVER     | E6380-21028 |
| MP6                     | FOOT             | E6380-40009 |
| MP7                     | COVER-EXT        | E6380-00019 |
| MP8                     | FILTER-AIR       | E6380-00042 |
| MP9                     | AY-SIDE FRAME    | E6380-61098 |
| MP10                    | AY-STRAP HANDLE  | E6380-61110 |
| MP11                    | REAR FRAME AY    | E6380-61097 |
| MP12                    | COVER-TOP        | E6380-00014 |
| MP13                    | COVER AY-MODULE  | E6380-61095 |
| MP14                    | COVER-DIGITAL    | E6381-00012 |
| MP15                    | COVER-BOTTOM     | E6380-00015 |
| MP16                    | AY-SUB FRAME     | E6381-61004 |
| MP18                    | GASKET-MOTHER BD | E6380-00034 |
| MP19                    | DIVIDER          | E6380-00009 |
| MP20                    | NUT-HEX-DBL-CHAM | 0590-2332   |
| MP30                    | KNOB BASE.250 JG | 0370-2110   |
| MP31                    | KNOB-06.5        | E6380-40012 |
| MP32                    | KNOB-016.3       | E6380-40011 |
| MP33                    | FOAM SPACER-SPKR | E6380-00038 |

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# Table 6-1

| Reference<br>Designator     | Description           | Part Number |
|-----------------------------|-----------------------|-------------|
| MP34                        | FRAME-WINDOW          | E6380-21011 |
| MP35                        | WINDOW-DISPLAY        | E6380-21009 |
| MP36                        | NUT HEX 1/4-36        | 2950-0196   |
| MP37                        | WSHR LK .256ID        | 2190-0027   |
| MP50                        | SUBPANEL-REAR         | E6380-61107 |
| MP51                        | COVER-POWER SUPPLY    | E6380-00064 |
| MP100                       | CLAMP-CABLE           | 1400-1391   |
| MP101                       | SMM4.0 10SEMPNTX      | 0515-0380   |
| MP102                       | SMM3.0 8SEMPNTX       | 0515-0372   |
| MP103                       | SMM3.0 6 FL TX        | 0515-1227   |
| MP104                       | SMM3.0 6SEMPNTX       | 0515-2126   |
| MP105                       | SMM4.0 20MML          | 0515-0456   |
| MP106                       | STDF .327L 6-32       | 0380-0644   |
| MP107                       | CONN SCREWLOCK F      | 0380-2079   |
|                             |                       |             |
| MP108                       |                       |             |
| MP109                       | WSHR LK .1941D        | 2190-0577   |
| MP110                       | SMM4.0 12SEMPNTX      | 0515-2243   |
| MP111                       | SMM4.0 16SEMPNTX      | 0515-2245   |
| MP112                       | WSHR-LK IN T #10      | 2190-0124   |
| MP113                       | NUT-HEX 10-32         | 2950-0078   |
| MP114                       | DC BLOCK BRKT         | E6380-00069 |
| MP115                       | TIE WRAP              | 1400-0249   |
| MP116                       | MODULE COVER ASSEMBLY | E6380-61086 |
| W1,W2,W3,W7,<br>W8, W9, W10 | CX F BNC-SMB 150      | E6381-61039 |
| W4,W5,W6,W12                | CX F BNC-SMB 250      | E6381-61007 |
| W11                         | CX F BNC-SMB 230      | E6381-61008 |
| W13                         | CA F SMB-BNC 525      | E6380-61073 |

Table 6-1

| Reference<br>Designator | Description      | Part Number |
|-------------------------|------------------|-------------|
| W14                     | CX F BNC-SMB 560 | E6381-61005 |
| W15                     | CA F SMB-BNC 525 | E6380-61075 |
| W16                     | CA AY-BNC-SMB    | E6380-61076 |
| W17                     | CA F SMB-BNC 525 | E6380-61077 |
| W24                     | CX F SMB-SMB 250 | E6380-61047 |
| W25                     | CX F SMC-SMB 160 | E6381-61020 |
| W26                     | CX F SMB-SMA 150 | E6381-61017 |
| W27                     | CX F SMC-SMB 250 | E6381-61021 |
| W28,W31,W32             | CX F SMB-SMB 505 | E6381-61028 |
| W29                     | CX F SMC-SMB 250 | E6381-61027 |
| W50                     | CX F SMC-SMB     | E6380-61051 |
| W51                     | CX F SMB-SMB 550 | E6380-61066 |
| W53                     | CX F SMB-SMA 150 | E6381-61017 |
| W54                     | CX F SMB-SMB 400 | E6380-61046 |
| W55                     | CX F SMB-SMB 515 | E6381-61016 |
| W56                     | CX F SMB-SMB 280 | E6380-61064 |
| W57                     | CX F SMB-SMB 275 | E6380-61050 |
| W58                     | CX F SMB-SMC 440 | E6380-61063 |
| W61                     | CX F SMB-SMB 220 | E6381-61015 |
| W62                     | CX F SMB-SMB 420 | E6381-61010 |
| W63                     | CX F SMC-SMB 250 | E6380-61059 |
| W64                     | CX F SMC-SMB 165 | E6380-61058 |
| W65                     | CX F SMB-SMB 240 | E6380-61061 |
| W66                     | CX F SMB-SMB 240 | E6381-61014 |
| W67                     | CX F SMB-SMB 190 | E6381-61013 |
| W68                     | CX F SMB-SMB 260 | E6381-61012 |
| W69                     | CX F SMB-SMB 420 | E6381-61011 |
| W70                     | CX F SMB-SMB M80 | E6380-61060 |
| W100                    | SR 2.18 SMA-SMA  | E6380-61021 |

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Table 6-1

| Reference<br>Designator | Description        | Part Number |
|-------------------------|--------------------|-------------|
| W101                    | SR 2.18 SMA-SMA    | E6380-61020 |
| W110                    | SR 3.58 SMA-SMA    | E6380-61034 |
| W121                    | SR 3.58 SMA-SMA    | E6380-61019 |
| W122                    | SR 3.58 SMA-SMA    | E6380-61018 |
| W123                    | SR 3.58 SMA-SMA    | E6380-61016 |
| W124                    | CA AY DIRC-CONV    | E6381-61019 |
| W125                    | CA AY RF/IO-DIRC   | E6381-61018 |
| W126                    | DC BLOCK           | E6381-61111 |
| W127                    | DC BLOCK           | E6381-61112 |
| W200                    | RBN 20CNDCT28AWG   | E6380-61062 |
| W201                    | RBN 68CNDCT30AWG   | E6380-61015 |
| W202                    | RBN 40CNDCT28AWG   | E6380-61022 |
| W203                    | CA AY-RIBBON       | E6380-61068 |
| W204                    | CA AY-RBN,HPIB/DCU | E6380-61023 |
| W205                    | CA AY-RBN          | E6380-61052 |
| W206                    | CA-10C-10F-09F     | E6381-61024 |
| W207                    | CA AY-POWER        | E6381-61022 |
| W208                    | CA-03C-10F-12F     | E6381-61009 |
| W209                    | CBL RCV/CDPD       | 83203-61049 |
| W210,W211,              | RBN 20CNDCT28AWG   | E6380-61029 |
| W212                    |                    |             |
| W213                    | RBN 15CNDCT28AWG   | E6380-61028 |
| W214                    | RBN 20CNDCT28AWG   | E6380-61027 |
| W215,W216               | RBN 40CNDCT28AWG   | E6380-61026 |
| W218                    | CA-15C-16F-15F     | E6381-61006 |
| W220                    | CA AY-RBN,26COND   | E6380-61036 |
| W221,W222               | CA AY-HARN 20 COND | E6380-61049 |
| W223                    | RBN 16CNDCT 28AWG  | E6380-61035 |

# 7 Periodic Adjustments

This chapter contains the periodic adjustment procedures for the Test Set.

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# **Periodic Adjustments**

The adjustment programs Periodic Calibration and IQ Calibration should be performed:

- after any assembly referred to in table 7-1 on page 160 is replaced, or
- · at least every 24 months.

Some assemblies or combinations of assemblies require periodic adjustments to compensate for variations in circuit performance due to age or environment. These program can be run anytime to optimize the performance of the Test Set.

There are two types of calibration data:

- Factory-generated digital data either on memory cards, or on ROMs (which are on the assemblies themselves)
- Data generated internally by running calibration programs

In either case calibration data is loaded into non-volatile memory on the A2A31 Controller.

#### **NOTE**

Because calibration data resides on the A2A31 Controller assembly, it is important that whenever the assembly is replaced that the data be transferred from the original assembly to the new one. The calibration data resides in a socketed EEPROM which can be moved with little danger of losing its contents. Refer to the instructions accompanying the replacement assembly for details.

To download calibration data supplied on a memory card, follow the instructions that come with the replacement assembly. To create and download calibration data for assemblies requiring a periodic adjustment, follow the steps later in this chapter. For a summary of assemblies and their calibration requirements, see table 7-1, "Assembly Calibration Information" on page 160.

**Table 7-1 Assembly Calibration Information** 

| Assembly                         | Where calibration data is located. |                | Calibration Program:<br>Sub Program  |  |
|----------------------------------|------------------------------------|----------------|--|--|
|                                  | Memory<br>Card or<br>RAM           | on<br>Assembly |  |  |
| A2A80 Audio Analyzer 1           |                                    |                | Periodic Calibration:<br>Audio Analyzer 1 Offset                               |  |
| A2A44 Modulation<br>Distribution |                                    |                | Periodic Calibration:<br>External Modulation<br>Path Gain, and, AF<br>GEN Gain |  |
| A2A110 Upconverter               |                                    | X              |  |  |
| A2A24 RF Output                  |                                    | X              |  |  |

**Table 7-1 Assembly Calibration Information** 

| Assembly                                  | Where calibration data is located. |                | Calibration Program:<br>Sub Program                         |
|---|------------------------------------|----------------|---|
|   | Memory<br>Card or<br>RAM           | on<br>Assembly |   |
| A2A25 Signal Generator<br>Synthesizer     |                                    | X              |   |
| A2A23 High Stability<br>Reference         |                                    | X              | Periodic Calibration:<br>Timebase Reference                 |
| A2A21 Receiver                            |                                    | X              |   |
| A2A22 Receiver<br>Synthesizer             |                                    | X              |   |
| A2A20 Spectrum Analyzer                   | X                                  |                |   |
| A2A115 Downconverter                      |                                    | X              |   |
| A2A33 Measurement                         | X                                  |                | Periodic Calibration:<br>Voltmeter References               |
| A2A130 RF Input/Output                    |                                    | X              | System Power<br>Calibration                                 |
| A2A200 100W Attenuator                    | X                                  |                | System Power<br>Calibration                                 |
| A2A100 Premodulation<br>Filter            |                                    |                | IQ Calibration  |
| A2A31 Controller                          |                                    | X              |   |
| A2A120 Reference<br>Receiver/IQ Modulator |                                    |                | IQ Calibration  |
| A2A34 Transmit DSP                        |                                    |                | IQ Calibration  |
| A2A40 Audio Analyzer 2                    |                                    |                | Periodic Calibration:<br>Variable Frequency<br>Notch Filter |

## **Equipment**

## **Equipment for the Periodic Adjustments Programs**

- For the Timebase Reference Using a Counter calibration you will need to connect a frequency counter to the side panel 10 MHz REF OUTPUT connector. The accuracy of the counter will determine the accuracy of the Test Set's internal reference. You will use the counter to set the timebase reference DACs.
- For the Timebase Reference Using a Source calibration you will need to connect a

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signal generator to the side panel ANT IN connector.

For the Voltmeter References calibration you will need a DC voltmeter that can measure  $\pm 5$  V with  $\pm 0.015\%$  accuracy.

Figure 7-1 **Periodic Adjustments Menu** 

Menu

#### **SERVICE MENU Screen** SERVICE MENU Move pointer to desired program using the knob then press the knob. Press Help for information on the tests. Press Exit to abort. => Functional Diagnostics AF Diagnostics RF Diagnostics Help TDMA Diagnostics Edit Diagnostic Limits Periodic Calibration IQ Calibration **CDPD** Diagnostics Move the pointer to the desired test using the knob then press the knob. Press Exit key to abort. Periodic Calibration Menu => Timebase Reference Using a Counter Timebase Reference Using a Source Periodic Voltmeter References Calibration Audio Frequency Generator Gain External Modulation Path Gain Audio Analyzer 1 Offset 5 Exit Variable Frequency Notch Filter

### **Equipment Needed for the System Power Calibration Program**

For the System Power Calibration program you will need the equipment listed in table 7-2. Because this calibration program is written specifically for this equipment, no substitutions are possible.

percal.eps

Table 7-2 Equipment List for System Power Calibration Program

| Equipment Type  | Model  |
|---|--|
| Signal Generator  | 8648B Option 1EA   |
| Power Meter   | 436A<br>437B<br>438A<br>EPM-441A<br>EPM-442A<br>8901B<br>8902A |
| Power Sensor  | 8482A<br>ECP-E18A<br>11722A                                    |
| Power Splitter  | 11667A   |
| HP-IB Cables<br>(2 cables required, 3 if HP-IB printer is<br>used.) | Any HP-IB cable  |
| Printer (optional)  | Any serial, parallel, or<br>HP-IB printer                      |

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## **Storing Calibration Factors**

You should understand the calibration-factor-storage process before running any of the following programs: Periodic Calibration, IQ Calibration, or System Power Calibration.

As a program runs, calibration factors are computed and applied. When all the calibration factors have been acquired, the program stops and asks if the user wants the calibration factors to be stored. At this point, it should be emphasized that the new calibration factors are now being used by the Test Set. If you do not store them at this point, they will be used by the Test Set until the power is switched off even though they have not been stored.

If you do not store the calibration factors but run another calibration program and then store the calibration factors, the calibration factors from the previous program will be stored along with the calibration factors just acquired unless the power is cycled between the tests. Storing calibration factors copies the calibration factors from volatile to non-volatile memory (that is, memory that is not erased when the power is turned off).

Also, when storing calibration factors, be sure to wait for the message Updating Flash Calibration Files... DO NOT Interrupt Power! to disappear from the display before continuing. Depending on the number of calibration factors being stored, this may take several minutes.

# **Running the System Power Calibration Program**

This adjustment program is not found in ROM of the Test Set. This program resides on a PCMCIA memory card, part-number E6380-61811. It has to be downloaded from the memory card.

This program generates system power calibration factors for the Test Set including the RF Input/Output Section, high power attenuator, and cables. This assures that the Test Set will meet its power measurement accuracy specifications after repair.

An RF signal generator and a power splitter produce two signals with the same power level. One signal is measured by the power meter, the other is applied to the input of the Test Set. The program measures these levels at selected frequencies and then generates calibration factors so the Test Set readings match the power meter readings. These calibration factors are stored in the Test Set.

Communication between the active instrument(s) is through the Test Set's HP-IB port. An optional printer can be connected to the Test Set's HP-IB, serial, or parallel port. Typically this is done from the Printer Setup field of the SOFTWARE menu screen. See "Configuring a Printer" on page 61

To run the System Power Calibration program:

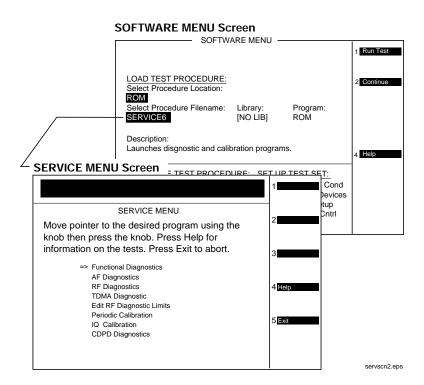
- **Step 1.** Connect HP-IB cables from the Test Set to the signal generator and power meter.
- **Step 2.** Insert the PCMCIA Memory Card, P/N E6380-61811, into the Test Set's memory card slot.
- **Step 3.** Press Menu to access the SOFTWARE MENU screen.
- Step 4. Select the field under Select Procedure Location:
- Step 5. Select Card under the Choices: menu.
- Step 6. Select the field under Select Procedure Filename:
- Step 7. Select SYSPWR0
- Step 8. Select Run Test (key k1).
- **Step 9.** Follow the instructions on the screen.

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# **Running the Periodic or IQ Calibration Programs**

- **Step 1.** Press Menu to access the SOFTWARE MENU screen.
- Step 2. Select the field under Select Procedure Location:.
- Step 3. Select ROM under the Choices: menu.
- Step 4. Select the field under Select Procedure Filename:.
- **Step 5.** Select **SERVICE6**, see figure 7-2.
- Step 6. Select Run Test (key k1).
- **Step 7.** From the SERVICE MENU, select the desired calibration program to perform.
  - Periodic Calibration for more detailed information, see "Periodic Calibration Menu Descriptions" on page 167.
  - IQ Calibration for more detailed information, see "IQ Calibration Program Description" on page 172
- **Step 8.** Follow the instructions on the screen.

Figure 7-2 SERVICE MENU Screen

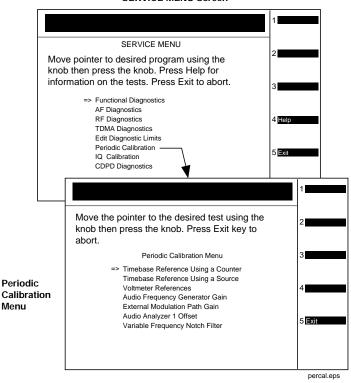


## **Periodic Calibration Menu Descriptions**

This section describes the adjustment programs listed under the Periodic Calibration menu.

### Figure 7-3 Periodic Calibration

#### **SERVICE MENU Screen**



## **Timebase Reference Using a Counter**

#### NOTE

It is not necessary to adjust the high stability reference (A2A24) if Option AY5 (rubidium reference) is installed in the Test Set. The rubidium reference takes the place of the high stability reference.

This program is used to manually tune the timebase reference using a frequency counter as the time standard. This procedure has two basic steps:

- **Step 1.** Manual adjustment of the two (coarse and fine) timebase tuning DACs.
- **Step 2.** Downloading the DAC settings into the Test Set.

If you have not already adjusted the two timebase tuning DACs, exit the program if needed (by selecting the Adj user key), and follow the instructions in "Setting the Timebase Latches" on page 171.

If you have adjusted the timebase DACs, run this program and select the Cal user key to make the setting permanent.

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As an alternate method, you can select the option Timebase Reference Using a Source (see following section) and adjust the timebase to a time standard connect to the front-panel ANT IN connector.

## **Timebase Reference Using a Source**

#### **NOTE**

It is not necessary to adjust the high stability reference (A2A24) if Option AY5 (rubidium reference) is installed in the Test Set. The rubidium reference takes the place of the high stability reference.

This program automatically tunes the timebase tuning DACs to the signal at the side panel ANT IN connector, which is input at the frequency that is keyed in from the front-panel keypad. If an external 10 MHz reference is being used, it must be disconnected.

In order for the calibration to be valid, the signal applied to the side panel ANT IN connector must have the following characteristics.

- **Step 1.** The level should be between -30 and +20 dBm (0.001 and 100 mW).
- **Step 2.** The frequency should be between 0.4 and 1000 MHz.
- **Step 3.** The frequency must be as accurate as the application of the Test Set requires.
- **Step 4.** The Test Set must be able to tune to within 10 or 100 kHz of the reference signal with the Test Set's current timebase reference settings. If this condition is not met, either the keyed-in frequency is incorrect or the Test Set is faulty.
- **Step 5.** The signal must be a CW signal. Specifically, any FM must be less than 100 Hz peak as measured by the Test Set.
- **Step 6.** The coarse tune DAC must be between 3 and 250 (decimal); otherwise, the frequency of the source is out of reach by the tuning DAC.

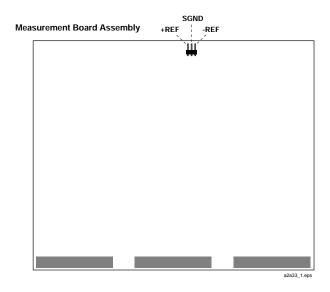
After the coarse and fine tune DAC settings have been determined, the values are downloaded into the Test Set's memory.

#### **Voltmeter References**

When you select the Voltmeter References calibration, instructions are displayed explaining how to measure the negative and positive references with an external voltmeter. The user is required to key in the readings. If the readings are within range, the two keyed-in values are automatically downloaded.

For the Test Set to meet published specifications, the external DC voltmeter must be accurate to  $\pm 0.015\%$  when measuring  $\pm 5$  V. The voltmeter is connected to the test points on the Measurement board, A2A33 assembly, see figure 7-4.

Figure 7-4 Measurement (A2A33) Assembly Test Points



## **Audio Frequency Generator Gain**

The gain of the following paths is calibrated:

- The internal paths that run from Audio Frequency Generators 1 and 2 (individually) through the Modulation Distribution assembly, to the monitor select output, then onto Audio Analyzer 1 to the DVM.
- The paths that run from Audio Frequency Generators 1 and 2 (individually) through the Modulation Distribution assembly to the side-panel AUDIO OUT connector, externally to the side-panel MODULATION IN connector, then again through the Modulation Distribution assembly to the monitor select output and to the DVM.

The above-measured levels are used to adjust the output level of the audio generators so that they produce a calibrated level to the modulation inputs of the RF generator. These measurements are made at DC. Both positive and negative levels are measured to produce an optimum calibration factor.

#### **External Modulation Path Gain**

The Audio Frequency Generator Gain program should be performed before running the External Modulation Path Gain program.

The "path" in this program runs from the external MODULATION IN connector through the Modulation Distribution assembly, through the Monitor Select Switch, and then through Audio Analyzer 1 to the Test Set's internal DVM. The dc source is Audio Frequency Generator 1 through the AUDIO IN connector and an external cable.

The goal of this procedure is to set the External Level Amplifier gain DAC (on the Modulation Distribution assembly) to produce a gain of exactly 4 between the MODULATION IN connector and output of the Monitor Select Switch. This requires measuring the input and output levels, calculating the gain, changing the DAC setting, and then repeating the process until the calculated gain equals 4.

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## **Audio Analyzer 1 Offset**

Two DC offsets are measured and downloaded as calibration factors to the Audio Analyzer 1 assembly. These measurements are determined under the following conditions:

- · Input-select switch grounded
- · AUDIO IN selected with return conductor grounded

## **Variable Frequency Notch Filter**

The calibration factors for tuning the variable-frequency notch filter are determined as follows:

The input to the filter is set to 10 evenly-spaced frequencies between 300 and 10,000 Hz. The DAC that tunes the notch filter is adjusted for best null of the tune error voltage. From this data, three coefficients of a parabola which best fit the tuning data are calculated using a least-squares curve fit. The coefficients are then automatically downloaded into the Test Set's non-volatile memory.

# **Setting the Timebase Latches**

The refs\_DAC\_coarse and ref\_DAC\_fine values adjust the frequency of the Test Set's internal 10 MHz reference. They are stored in memory. The controller reads the values and sends the appropriate adjustment to the A2A23 Reference assembly.

The following procedure is to be used when running the program "Timebase Reference Using a Counter" on page 167.

- **Step 1.** Select the titlebar at the top of the display.
- **Step 2.** Select **SERVICE** from the list.
- **Step 3.** Connect a frequency counter to the rear-panel 10 MHz REF OUTPUT connector.
- Step 4. Select the Latch field.
- Step 5. Select refs\_DAC\_coarse under the Choices: menu.
- Step 6. Select the Value field.
- **Step 7.** Rotate the knob until the counter reads as close to 10 MHz as possible.
- **Step 8.** Select the Latch field.
- Step 9. Select refs\_DAC\_fine under the Choices: menu.
- Step 10. Select the Value field.
- **Step 11.** Rotate the knob until the counter reads as close to 10 MHz as possible.
- **Step 12.** Store the new DAC values (timebase calibration data) in non-volatile memory by selecting and running the Timebase Reference Using a Counterroutine from the Periodic Calibration Menu. See "Timebase Reference Using a Counter" on page 167.

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# **IQ Calibration Program Description**

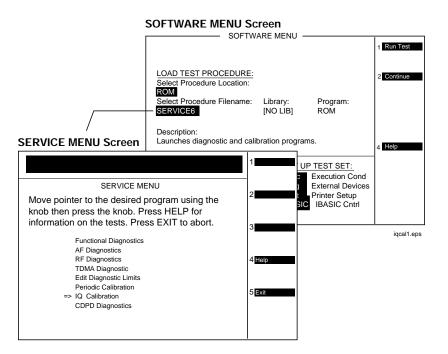
The goal of IQ Calibration is to minimize the carrier feedthrough while maximizing the rho of the IQ signal. Four DACs on the Premodulation Filter assembly are adjusted:

- IQ Quadrature DAC (latch: pmf\_IQ\_quad\_DAC)
- I Offset DAC (latch: pmf\_I\_DAC)
- Q Offset DAC (latch: pmf\_Q\_DAC)
- Gain DAC (latch: pmf\_Gain\_DAC)

The Test Set is configured as a digital generator driving a digital receiver (a loopback setup). The digital generator generates a p/4 DQPSK phase-modulated signal and outputs a continuous sequence of 0s (actually 0,0 symbol pairs) to the phase modulator. The constantly increasing phase generates a signal at the carrier frequency shifted up by 3.0375 kHz (24.3 k symbols/s [8 symbols/cycle]). The effect of I and Q Offset DAC misadjustment creates carrier feedthrough creating a signal at the carrier frequency. The effect of IQ Quadrature DAC and Gain DAC misadjustment generates a lower sideband at 3.0375 kHz below the carrier. Internal self-adjustment of the four DACs nulls the carrier and its lower sideband which are measured directly by the digital receiver.

The adjustments are made at 21 frequencies from 800 to 1000 MHz in 10 MHz steps. After the calibration factors are acquired, the carrier feedthrough is checked at each frequency with the calibration factor applied. The carrier feedthrough must remain below –45 dB for the calibration to be considered valid.

Figure 7-5 IQ Calibration



# 8 Performance Tests

This chapter contains the performance test procedures for the Test Set. The tests in this chapter verify that the Test Set performs to its published specifications.

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# **Procedure and Equipment**

#### **Performance Tests Interval**

The performance tests in this chapter should be performed:

- · at a recommended interval of 24 months, or
- when any of the assemblies referred to in table 3-5 on page 76 require calibration, repair, and/or replacement.

#### **How to Use the Performance Tests**

- Run the Performance Tests in table 8-2, "Performance Test and Record Location" on page 176 using the specified Test Equipment from table 8-1, "Test Equipment by Model" on page 175.
- Compare and record the data for each test onto the applicable Performance Test Record (PTR). Table 8-2 on page 176 shows the page number of the PTR associated with each performance test.

### **Test Set Operation**

To perform the following performance test procedures you need to know basicTest Set operation. You should be familiar with the front panel, the various display screens, and knob operation (cursor control). You should be able to operate the Test Set's RF generator, RF analyzer, AF generators, AF analyzer, spectrum analyzer, and oscilloscope.

NOTE

Press Preset on the Test Set before beginning each test.

## **Test Equipment and Operation**

The test equipment shown in table 8-1, "Test Equipment by Model" on page 175 is needed to do all of the performance tests. Usually, a setup drawing at the beginning of each test procedure shows the equipment and hook-up needed for that particular test. Generic names are used for the test equipment shown in the setup drawings.

To find alternatives to the equipment listed in table 8-1, look up their specifications in the Agilent Technologies Test and Measurement Catalog and use the specifications to find equivalent instruments.

The test procedures give critical instrument settings and connections, but they don't tell how to operate the instruments. Refer to each instrument's operating manual.

Table 8-1 Test Equipment by Model

| Model Number  | Model Name                                       | Test Number                 |
|---|--|-----------------------------|
| Mini-Circuits<br>ZFL-2000 or<br>equivalent <sup>a</sup> | Amplifier 1                                      | 5                           |
| E4433B  | Digital Signal Generator                         | 1-5, 24, 26                 |
| 3458A   | Multimeter                                       | 8-9, 12, 15, 18             |
| 5316A   | Counter  | 11, 16                      |
| 8903B   | Audio Analyzer                                   | 4, 10, 12, 16, 18,<br>20-22 |
| E6380-61811 <sup>b</sup>                                | System Power Calibration Program<br>Software Kit | 19                          |
| 8902A   | Measuring Receiver                               | 1-5, 17, 19-22,<br>28       |
| 11667A  | Power Splitter                                   | 19, 28                      |
| 11715A  | AM/FM Test Source                                | 20-23                       |
| 11722A  | Sensor Module                                    | 5, 19, 28                   |
| 11793A  | Microwave Converter                              | 1-5                         |
| 8663A   | Signal Generator (High<br>Performance)           | 4, 28                       |
| 8562A or 8566B  | Spectrum Analyzer                                | 6-7                         |
| 8648B Option 1EA  | Signal Generator                                 | 19                          |
| 89441A with options<br>AYA, AY9, UFG                    | Vector Signal Analyzer                           | 25, 26                      |

a. Required amplifier specifications are frequency range 1.7 to 2.0 GHz, gain >18 dB, noise figure <5 dB. For more information about Mini-Circuits, contact them at (718) 934-4500 or http://www.minicircuits.com.

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b. To order this kit, see "Ordering Parts" on page 38.

**Table 8-2 Performance Test and Record Location** 

| Performance Test<br>(in this chapter)  | Test Record in<br>Chapter 9,<br>"Performance<br>Test Records." |
|--|--|
| "RF Generator FM Distortion Performance Test 1" on page 178                    | page 224   |
| "RF Generator FM Accuracy Performance Test 2" on page 180                      | page 226   |
| "RF Generator FM Flatness Performance Test 3" on page 182                      | page 228   |
| "RF Generator Residual FM Performance Test 4" on page 184                      | page 230   |
| "RF Generator Level Accuracy Performance Test 5" on page 187                   | page 232   |
| "RF Generator Harmonics Spectral Purity Performance Test 6" on page 191        | page 245   |
| "RF Generator Spurious Spectral Purity Performance Test 7" on page 192         | page 248   |
| "AF Generator AC Level Accuracy Performance Test 8" on page 193                | page 250   |
| "AF Generator DC Level Accuracy Performance Test 9" on page 194                | page 251   |
| "AF Generator Residual Distortion Performance Test 10" on<br>page 195          | page 252   |
| "AF Generator Frequency Accuracy Performance Test 11" on<br>page 196           | page 253   |
| "AF Analyzer AC Level Accuracy Performance Test 12" on page 197                | page 254   |
| "AF Analyzer Residual Noise Performance Test 13" on page<br>198                | page 255   |
| "AF Analyzer Distortion and SINAD Accuracy Performance<br>Test 14" on page 199 | page 256   |
| "AF Analyzer DC Level Accuracy Performance Test 15" on page 200                | page 257   |
| "AF Analyzer Frequency Accuracy to 100 kHz Performance Test<br>16" on page 201 | page 258   |
| "AF Analyzer Frequency Accuracy at 400 kHz Performance<br>Test 17" on page 202 | page 259   |
| "Oscilloscope Amplitude Accuracy Performance Test 18" on<br>page 203           | page 260   |
| "RF Analyzer Level Accuracy Performance Test 19" on page 205                   | page 261   |

**Table 8-2 Performance Test and Record Location** 

| Performance Test<br>(in this chapter)   | Test Record in<br>Chapter 9,<br>"Performance<br>Test Records." |
|---|--|
| "RF Analyzer FM Accuracy Performance Test 20" on page 206                       | page 263   |
| "RF Analyzer FM Distortion Performance Test 21" on page 208                     | page 264   |
| "RF Analyzer FM Bandwidth Performance Test 22" on page 210                      | page 265   |
| "RF Analyzer Residual FM Performance Test 23" on page 212                       | page 266   |
| "Spectrum Analyzer Image Rejection Performance Test 24" on page 213             | page 267   |
| "TDMA Generator Modulation Accuracy Performance Test 25" on page 215            | page 268   |
| "TDMA Analyzer Modulation Accuracy Performance Test 26" on page 217             | page 269   |
| "CDPD Performance Test 28" on page 221  | page 271   |
| "TDMA Analyzer Channel Power Level Accuracy Performance<br>Test 27" on page 219 | page 270   |

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#### **RF Generator FM Distortion Performance Test 1**

The purpose of this test is to verify that the Test Set's RF generator FM distortion performance meets the specification limits in PTR (Performance Test Record) table 9-1, "Generator FM Distortion Test 1 Record" on page 224. The FM distortion of the RF generator is measured directly by the measuring receiver. The Test Set's internal audio generator provides the modulation source.

#### **NOTE**

Two setups are shown below. The first setup can measure signals to 1 GHz. Since the FM generator in the Test Set translates FM in the lower band directly into the 1.7 to 2 GHz range, testing to 1 GHz is adequate when verifying a repair. The second setup has a microwave converter which covers the full measurement range of FM signals to 2 GHz.

## **Initial Setup**

Figure 8-1 Setup for Measurements to 1 GHz

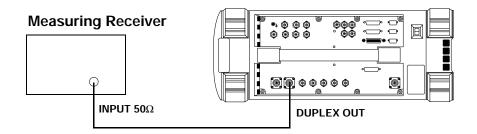
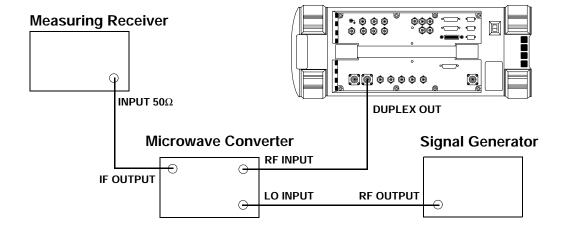


Figure 8-2 Setup for Measurements to 2 GHz Using a Microwave Converter



#### **Procedure**

Steps 1, 2, and 3 in the following procedure apply to both of the setups (shown in figure 8-1 and figure 8-2 on page 178).

- **Step 1.** On the measuring receiver:
  - **a.** Reset the instrument.
  - **b.** Set the high-pass filter to 300 Hz.
  - **c.** Set the low-pass filter to 3 kHz.
  - **d.** Set the measurement mode to FM.
  - **e.** If the microwave converter is being used, set the frequency offset mode to exit the mode (27.0 Special).
  - **f.** Set the measurement mode to audio distortion.
- **Step 2.** On the Test Set:
- Step 1. Press Preset.
- **Step 2.** Press the RF Gen key.
- Step 3. Set the Output Port field to Dupl.
- Step 4. Set the RF Gen Freq to 10 MHz.
- Step 5. Set the Amplitude to -10 dBm.
- Step 6. Set the AFGen1 To field to FM at 99 kHz deviation with the FM set to On.
- **Step 7.** For frequencies up to 1000 MHz measure the FM distortion (audio distortion) at the RF frequencies and deviations shown in the Performance Test Record (PTR) and compare the measured distortion to the limits.

The following steps are for measurements to 2 GHz.

- **Step 8.** On the signal generator:
  - **a.** Set the frequency to 1500 MHz CW.
  - **b.** Set the level to +8 dBm or whatever level is suitable for the microwave converter's LO input.
- **Step 9.** On the measuring receiver:
  - **a.** Set the frequency offset mode to enable the LO frequency (27.3 Special).
  - **b.** Key in the LO frequency (in MHz) which is 1500.
- **Step 10.** On the Test Set, for frequencies of 1700 and 2000 MHz, measure the FM distortion at the deviations shown in the PTR and compare the measured distortion to the limits.

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# RF Generator FM Accuracy Performance Test 2

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-2, "RF Generator FM Accuracy Test 2 Record" on page 226. The FM accuracy of the RF generator is measured directly by the measuring receiver. The Test Set's internal audio generator provides the modulation source.

**NOTE** 

Two setups are shown below. The first setup can measure signals to 1 GHz. Since the FM generator in the Test Set translates FM in the lower band directly into the 1.7 to 2 GHz range, testing to 1 GHz is adequate when verifying a repair. The second setup has a microwave converter which covers the full measurement range of FM signals to 2 GHz.

## **Initial Setup**

#### Figure 8-3 Setup for Measurements to 1 GHz

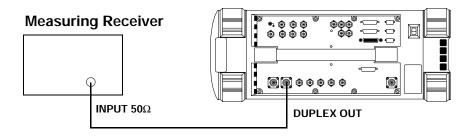
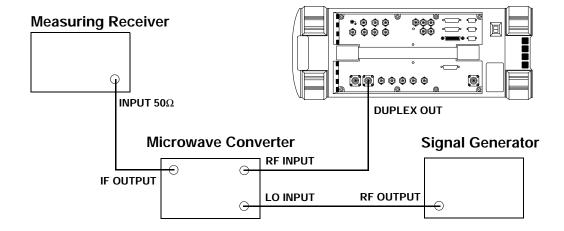


Figure 8-4 Setup for Measurements to 2 GHz Using a Microwave Converter



#### **Procedure**

Steps 1, 2, and 3 in the following procedure apply to both of the setups (shown in figure 8-3 and figure 8-4 on page 180).

### **Step 1.** On the measuring receiver:

- a. Reset the instrument.
- **b.** Set the high-pass filter to 300 Hz.
- **c.** Set the low-pass filter to 3 kHz.
- **d.** Set the measurement mode to FM.
- e. Set the FM de-emphasis off.
- **f.** If the microwave converter is being used, set the frequency offset mode to exit the mode (27.0 Special).

#### **Step 2.** On the Test Set:

- a. Press Preset.
- **b.** Press the RF Gen key.
- c. Set the Output Port field to Dupl.
- d. Set the RF Gen Freq to 10 MHz.
- e. Set the Amplitude to -10 dBm.
- f. Set the AFGen1 To field to FM at 99 kHz deviation with the FM set to On.
- **Step 3.** For frequencies up to 1000 MHz measure the FM deviation at the RF frequencies and deviations shown in the Performance Test Record (PTR) and compare the measured deviation to the limits.

The following steps are for measurements to 2 GHz.

#### **Step 4.** On the signal generator:

- a. Set the frequency to 1500 MHz CW.
- b. Set the level to +8 dBm or whatever level is suitable for the microwave converter's LO input.
- **Step 5.** On the measuring receiver:
  - a. Set the frequency offset mode to enable the LO frequency (27.3 Special).
  - b. Key in the LO frequency (in MHz) which is 1500.
- **Step 6.** On the Test Set, for frequencies of 1700 and 2000 MHz, measure the FM at the deviations shown in the PTR and compare the measured deviation to the limits.

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# **RF Generator FM Flatness Performance Test 3**

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-3, "RF Generator FM Flatness Test 3 Record" on page 228. The FM flatness of the RF generator is measured directly by the measuring receiver. The Test Set's internal audio generator provides the modulation source.

NOTE

Two setups are shown below. The first setup can measure signals to 1 GHz. Since the FM generator in the Test Set translates FM in the lower band directly into the 1.7 to 2 GHz range, testing to 1 GHz is adequate when verifying a repair. The second setup has a microwave converter which covers the full measurement range of FM signals to 2 GHz.

## **Initial Setup**

Figure 8-5 Setup for Measurements to 1 GHz

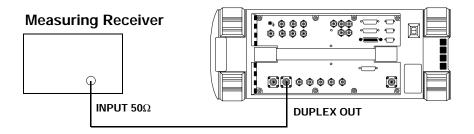
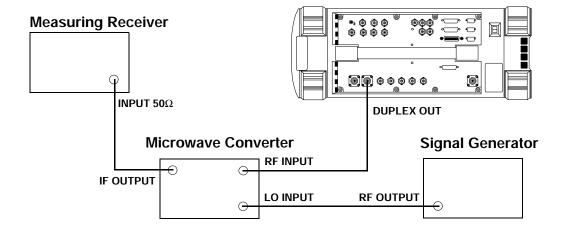


Figure 8-6 Setup for Measurements to 2 GHz Using a Microwave Converter



#### **Procedure**

Steps 1, 2, and 3 in the following procedure apply to both of the setups (shown in figure 8-5 and figure 8-6 on page 182).

- **Step 1.** On the measuring receiver:
  - a. Reset the instrument.
  - **b.** Set the measurement mode to FM.
  - **c.** If the microwave converter is being used, set the frequency offset mode to exit the mode (27.0 Special).
- **Step 2.** On the Test Set:
  - a. Press Preset.
  - **b.** Press the RF Gen key.
  - c. Set the Output Port field to Dupl.
  - d. Set the RF Gen Freq to 521 MHz.
  - e. Set the Amplitude to -10 dBm.
  - f. Set the AFGen1 To field to FM at 50 kHz deviation with the FM set to On.
- **Step 3.** For frequencies up to 1000 MHz measure the FM deviation at the RF frequencies and rates shown in the Performance Test Record (PTR). Convert the measurement results to dB referenced to the deviation measured at 1 kHz using the following formula and compare the calculated deviation to the limits in the PTR.

6.

$$dB = 20 \bullet \log \left( \frac{\text{Deviation}}{\text{Deviation at 1 kHz}} \right)$$

The following steps are for measurements to 2 GHz.

- **Step 4.** On the signal generator:
  - a. Set the frequency to 1500 MHz CW.
  - **b.** Set the level to +8 dBm or whatever level is suitable for the microwave converter's LO input.
- **Step 5.** On the measuring receiver:
  - **a.** Set the frequency offset mode to enable the LO frequency (27.3 Special).
  - **b.** Key in the LO frequency (in MHz) which is 1500.
- **Step 6.** On the Test Set, for frequencies of 1700 and 2000 MHz, measure the FM deviation at the rates shown in the PTR. Convert the measurement results as was done in step 3 and compare the calculated deviation to the limits.

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# RF Generator Residual FM Performance Test 4

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-4, "RF Generator Residual FM Test 4 Record" on page 230. The residual FM of the RF generator is measured directly by the measuring receiver. An external LO is used to improve the residual FM of the measuring receiver. An audio analyzer with a CCITT psophometric filter is required to measure the demodulated FM.

#### **NOTE**

Two setups are shown below and on the following page. The first setup is capable of measuring signals to 1 GHz. The second setup has a microwave converter which covers the full measurement range of FM signals to 2 GHz. The microwave converter's LO must be a low residual FM synthesizer.

## **Initial Setup**

#### Figure 8-7 Setup for Measurements to 1 GHz

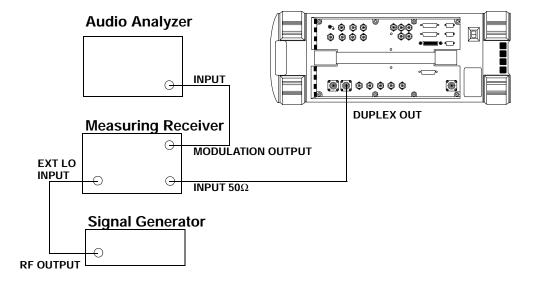
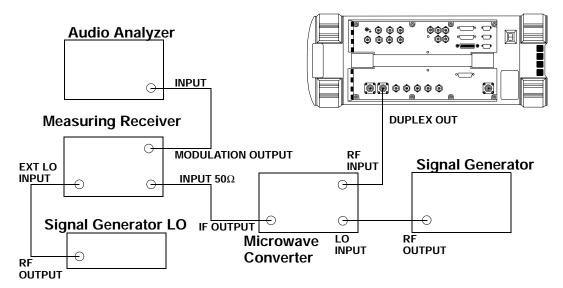


Figure 8-8 Setup for Measurements to 2 GHz Using a Microwave Converter



## **Procedure**

Steps 1 to 5 in the following procedure apply to both setups (shown in figure 8-7 and figure 8-8 on page 185).

- **Step 1.** On the signal generator (to be used as the measuring receiver's LO):
  - **a.** Set the frequency to 11.5 MHz.
  - **b.** Set the level to 0 dBm.
- **Step 2.** On the measuring receiver:
  - a. Reset the instrument.
  - **b.** Set the IF to 1.5 MHz (3.2 Special).
  - **c.** Set the high-pass filter to 50 Hz.
  - **d.** Set the low-pass filter to 15 kHz.
  - e. Set the measurement mode to FM.
  - **f.** If the instrument has an external LO switch, enable the external LO mode (23.1 Special).
  - **g.** If the microwave converter is being used, set the frequency offset mode to exit the mode (27.0 Special).

#### **Step 3.** On the audio analyzer:

- **a.** Reset the instrument.
- **b.** Set the measurement mode to AC level.
- **c.** Select the CCITT Weighting filter.
- **d.** Set the low-pass filter to 30 kHz.

#### **Step 4.** On the Test Set:

- a. Press Preset.
- **b.** Press the RF Gen key.
- c. Set the Output Port to Dupl.
- d. Set the RF Gen Freq to 10 MHz.
- e. Set the Amplitude to -10 dBm.
- **Step 5.** For frequencies up to 1000 MHz and for each line in the Performance Test Record (PTR) do the following:
  - **a.** Set the signal generator (used as an LO for the measuring receiver) to the LO frequency shown in the PTR.
  - **b.** Set the Test Set to the RF frequencies shown in the PTR.
  - c. Measure the ac level (in mV) on the audio analyzer.
  - **d.** Multiply the measured ac levels by 1000 to convert them to FM deviation in Hz and compare the computed results to the limits shown in the PTR.

The following steps are for measurements to 2 GHz.

#### **Step 6.** On the signal generator:

- a. Set the frequency to 1500 MHz CW for 1700 MHz, 1800 MHz CW for 2000 MHz.
- **b.** Set the level to +8 dBm or whatever level is suitable for the microwave converter's LO input.

#### **Step 7.** On the measuring receiver:

- **a.** Set the frequency offset mode to enable the LO frequency (27.3 Special).
- **b.** Key in the LO frequency (in MHz) which is 1500 MHz.
- **Step 8.** On the Test Set, for frequencies of 1700 and 2000 MHz, continue on as in ste p5.

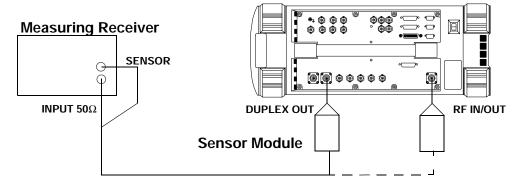
# RF Generator Level Accuracy Performance Test 5

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table , "RF Generator Level Accuracy Performance Test 5 Record" on page 232. Using a measuring receiver and sensor module, at several frequencies up to 1 GHz the Test Set is set to generate levels between -10 and 125 dBm (in 5 dB steps) at it's DUPLEX OUT connector. The level is measured with the tuned RF level feature of the measuring receiver. At each frequency the measuring receiver connection is moved to the RF IN/OUT and the level measured from -40 to -125 dBm. As the test proceeds you may be required to recalibrate the measuring receiver.

To extend the measurement frequency to 2 GHz the second method uses a microwave converter and amplifier to extend the measurement range (see figure 8-10 on page 188).

## Setup 1

Figure 8-9 Setup 1 for Measurements to 1 GHz



#### **Procedure 1**

Steps 1 to 5 in the following procedure apply to Setup 1 shown in figure 8-9 on page 187.

- **Step 1.** Before connecting the test set to the measuring receiver:
  - a. Reset the instrument.
  - **b.** Zero and calibrate the sensor module.

#### **NOTE**

Make sure the sensor module's calibration data is entered into the measuring receiver.

- **Step 2.** Connect the equipment as shown in Setup 1 whether intending to measure frequencies to 1 GHz or 2 GHz.
- **Step 3.** On the measuring receiver:
  - a. Set the measurement mode to RF Power.
  - **b.** Set the display to log.

#### **Step 4.** On the Test Set:

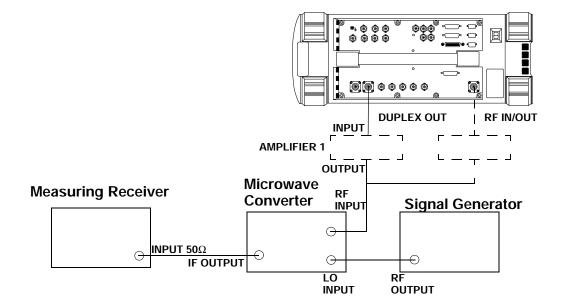
- a. Press Preset.
- **b.** Press the RF Gen key.
- c. Set the Output Port field to Dupl.
- d. Set the RF Gen Freq to 3 MHz.
- e. Set the Amplitude to -10 dBm.

**Step 5.** For each frequency in the Performance Test Record (PTR) do the following:

- **a.** Set the measuring receiver to measure frequency.
- **b.** Set the Test Set level to –10 dBm.
- **c.** After the measuring receiver has acquired the signal, set the measuring receiver to measure the tuned RF level.
- **d.** Measure the RF level at the levels shown in the PTR at the Test Set's DUPLEX OUT port and compare the measured RF level to the limits. If the measuring receiver displays the need to recalibrate, press the CALIBRATE key and wait for calibration to be completed.
- **e.** Move the sensor module to the Test Set's RF IN/OUT port.
- **f.** On the Test Set set the Output Port field to RF Out and repeat the measurements for the levels shown in the PTR and compare the measured RF level to the limits.
- **g.** Move the sensor module back to the Test Set's DUPLEX OUT port and set the Output Port field to Dupl.

### Setup 2

Figure 8-10 Setup 2 for Measurements of 1700 and 2000 MHz



#### **Procedure 2**

Steps 1 to 5 in the following procedure apply to Setup 1 shown in figure 8-9 on page 187.

- **Step 1.** Connect the sensor module on the measuring receiver to the DUPLEX OUT port of the Test Set.
- **Step 2.** On the Test Set:
  - a. Set the Amplitude to -10 dBm.
  - b. Set the RF Gen Freq to 1700 MHz.
- **Step 3.** On the measuring receiver:
  - **a.** Set the measurement mode to RF power.
  - **b.** Key in 1700 MHz.
  - **c.** Measure and record the RF power at the DUPLEX OUT port.
- **Step 4.** On the Test Set set the RF Gen Freq to 2000 MHz.
- **Step 5.** On the measuring receiver:
  - **a.** Key in 2000 MHz.
  - **b.** Measure and record the RF power at the DUPLEX OUT port.

Steps 6 to 8 apply to Setup 2 shown in figure 8-10 on page 188.

- **Step 6.** Make the connections shown in Setup 2. Connect the DUPLEX OUT of the Test Set directly to the microwave converter, do not use an amplifier.
- **Step 7.** On the signal generator set the level to +8 dBm or whatever level is suitable for the microwave converter's LO input.
- **Step 8.** For frequencies of 1700 and 2000 MHz perform the following:
  - **a.** On the signal generator set the frequency to 1900 MHz CW and 2200 MHz CW respectively.
  - **b.** Reset the measuring receiver.
  - **c.** On the measuring receiver set the frequency offset mode to enter and enable the LO frequency (27.3 Special).
  - **d.** On the measuring receiver key in the signal generator (LO) frequency (in MHz) which is 1900 or 2200 MHz respectively.
  - **e.** On the measuring receiver set the measurement mode to tuned RF level and the measurement units to dBm then press SET REF.
  - **f.** Measure and record the RF level at the levels down to and including -80 dBm shown in the PTR at the Test Set's DUPLEX OUT port. If the measuring receiver displays the need to recalibrate, press the CALIBRATE key and wait for calibration to be completed.
  - **g.** After recording the reading at -80 dBm insert an RF amplifier into the output of the Test Set.
  - **h.** Record the new measured level at -80 dBm.
  - **i.** Continue measuring the level down to -125 dBm.

- **j.** Move the input to the microwave converter to the RF IN/OUT port without the amplifier inserted.
- **k.** Measure and record the RF level at the levels down to and including -80 dBm shown in the PTR at the Test Set's RF IN/OUT port.
- **l.** After recording the reading at -80 dBm insert an RF amplifier into the output of the Test Set.
- **m.** Record the new measured level at -80 dBm.
- n. Continue measuring the level down to -125 dBm.
- o. Correct the measured reading for each level measured without the amplifier as follows: Add the RF power measured in step 3c or 5b to the measured level. (For example, if the level in step 3c is -10.2 dBm and the level at -55 dBm is -45.1 dB, record a level of -10.2 + (-45.1) = 55.3 dBm.) Compare the corrected values with the limits in the PTR.
- **p.** Correct the measured reading for each level measured with the amplifier by summing the following values:
  - + RF power measured at -10 dBm in step 3c or 5b
  - + RF level measured at -80 dBm in step 8i
  - RF level measured at -80 dBm in step 8j
  - + RF level measured in step 8k

For example, if:

RF power measured at -10 dBm in step 3b or 5b = -10.2 dBm

RF level measured at -80 dBm in step 8i = -70.1 dB

RF level measured at -80 dBm in step 8j = -52.6 dB

RF level measured at -100 dBm in step 8k = -73.2 dB

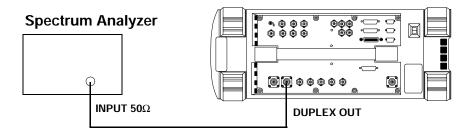
the corrected level at -100 dBm is -10.2 + (-70.1) - (-52.6) + (-73.2) = 100.9 dBm. Compare the corrected values with the limits in the PTR.

# **RF Generator Harmonics Spectral Purity Performance Test 6**

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table, "For test procedure, see "RF Generator Harmonics Spectral Purity Performance Test 6" on page 191." on page 245. Harmonic signals with the carrier set to several frequencies and two different levels (maximum output and minimum level vernier) are searched for by an RF spectrum analyzer.

# **Setup**

Figure 8-11



#### **Procedure**

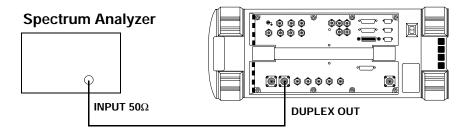
- **Step 1.** Set up the spectrum analyzer in accordance with its operating manual.
- **Step 2.** On the Test Set:
  - a. Press Preset.
  - **b.** Press the RF Gen key.
  - c. Set the Output Port field to Dupl.
  - d. Set the RF Gen Freq to 1 MHz.
  - e. Set the Amplitude to -10 dBm.
- **Step 3.** Set the test set's RF generator to the frequencies and levels shown in the Performance Test Record (PTR) and measure the second and third harmonics. For each measurement convert the harmonic level to dB below the fundamental (dBc) and compare the computed levels to the limits.

# **RF Generator Spurious Spectral Purity Performance Test 7**

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-7, "RF Generator Spurious Spectral Purity Test 7 Record" on page 248. Spurious signals with the carrier set to several frequencies and two different levels (maximum output and minimum level vernier) are searched for by an RF spectrum analyzer.

# **Setup**

#### Figure 8-12



#### **Procedure**

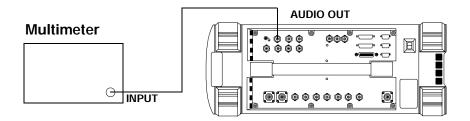
- **Step 1.** Set up the spectrum analyzer in accordance with its operating manual.
- **Step 2.** On the Test Set:
  - a. Press Preset.
  - **b.** Press the RF Gen key.
  - c. Set the Output Port field to Dupl.
  - d. Set the RF Gen Freq to 242 MHz.
  - e. Set the Amplitude to -10 dBm.
- **Step 3.** Set the test set's RF generator to the frequencies and levels shown in the Performance Test Record (PTR) and measure the level of the spurious signals at the frequencies shown. For each measurement convert the harmonic level to dB below the fundamental (dBc) and compare the computed levels to the limits.

# **AF Generator AC Level Accuracy Performance Test 8**

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-8, "AF Generator AC Level Accuracy Test 8 Record" on page 250. There are two audio generators. AC level accuracy is measured directly with a digital multimeter.

## **Setup**

#### Figure 8-13



#### **Procedure**

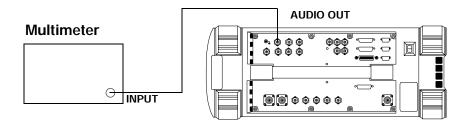
- **Step 1.** Set the multimeter to measure AC volts.
- **Step 2.** On the Test Set:
  - a. Press Preset.
  - **b.** Press the RF Gen key.
  - c. Set the AFGen1 To and AFGen2 To fields to Audio Out.
- **Step 3.** On the Test Set for Audio Frequency Generator 1 do the following:
  - a. Set the AFGen2 To level field to Off.
  - **b.** Set the audio frequency and level as shown in the Performance Test Record (PTR) and measure the AC level. Compare the measured voltage to the limits.
- **Step 4.** On the Test Set for Audio Frequency Generator 2 do the following:
  - a. Set the AFGen1 To level field to Off and AFGen2 To level field to On.
  - **b.** Set the audio frequency and level as shown in the PTR and measure the AC level. Compare the measured voltage to the limits.

# **AF Generator DC Level Accuracy Performance Test 9**

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-9, "AF Generator DC Level Accuracy Test 9 Record" on page 251. There are two DC generators. DC level accuracy is measured directly with a digital multimeter.

## **Setup**

#### Figure 8-14



#### **Procedure**

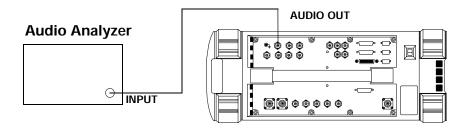
- **Step 1.** Set the multimeter to measure DC volts.
- **Step 2.** On the Test Set:
  - a. Press Preset.
  - **b.** Press the RF Gen key.
  - c. Set the AFGen1 To and AFGen2 To fields to Audio Out.
  - d. Set the AFGen1 Freq and AFGen2 Freq fields to 0.0 Hz.
  - e. Set the Audio Out field to DC.
- **Step 3.** On the Test Set for Audio Frequency Generator 1 do the following:
  - a. Set the AFGen2 To level field to Off.
  - **b.** Set the audio frequency and level as shown in the Performance Test Record (PTR) and measure the DC level. Compare the measured voltage to the limits.
- **Step 4.** On the Test Set for Audio Frequency Generator 2 do the following:
  - a. Set the AFGen1 To level field to Off and AFGen2 To level field to on.
  - **b.** Set the audio frequency and level as shown in the PTR and measure the DC level. Compare the measured voltage to the limits.

# AF Generator Residual Distortion Performance Test 10

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-10, "AF Generator Residual Distortion Test 10 Record" on page 252. Audio distortion is measured directly with an audio analyzer.

## **Setup**

### Figure 8-15



#### **Procedure**

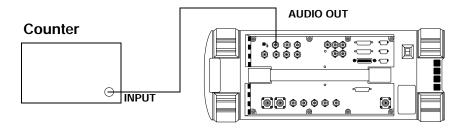
- **Step 1.** On the audio analyzer:
  - a. Reset the instrument.
  - **b.** Select the 80 kHz low-pass filter.
  - **c.** Set the measurement mode to distortion.
- **Step 2.** On the Test Set:
  - a. Press Preset.
  - **b.** Press the RF Gen key.
  - c. Set the AFGen1 To and AFGen2 To fields to Audio Out.
- **Step 3.** On the Test Set for Audio Frequency Generator 1, do the following:
  - a. Set the AFGen2 To level field to Off.
  - **b.** Set the audio frequency and level as shown in the Performance Test Record (PTR) and measure the audio distortion. Compare the measured distortion to the limits.
- **Step 4.** On the Test Set for Audio Frequency Generator 2 do the following:
  - a. Set the AFGen1 To level field to Off and AFGen2 To level field to on.
  - **b.** Set the audio frequency and level as shown in the PTR and measure the audio distortion. Compare the measured distortion to the limits.

# **AF Generator Frequency Accuracy Performance Test 11**

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-11, "AC Generator Frequency Accuracy Test 11 Record" on page 253. Frequency accuracy is measured directly with a frequency counter. The counter must be able to resolve 0.005% at 20 Hz.

## **Setup**

#### Figure 8-16



#### **Procedure**

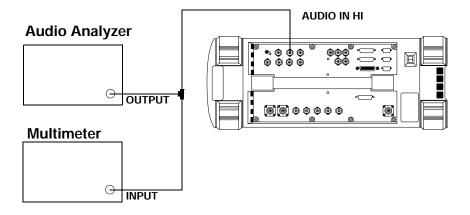
- **Step 1.** Set the counter to measure frequency.
- **Step 2.** On the Test Set:
  - a. Press Preset.
  - **b.** Press the RF Gen key.
  - c. Set the AFGen1 To and AFGen2 To fields to Audio Out.
- **Step 3.** On the Test Set for Audio Frequency Generator 1 do the following:
  - a. Set the AFGen2 To level field to Off.
  - **b.** Set the audio frequency and level as shown in the Performance Test Record (PTR) and measure the audio frequency. Compare the measured frequency to the limits.
- **Step 4.** On the Test Set for Audio Frequency Generator 2 do the following:
  - a. Set the AFGen1 To level field to Off and AFGen2 To level field to on.
  - **b.** Set the audio frequency and level as shown in the PTR and measure the audio frequency. Compare the measured frequency to the limits.

# **AF Analyzer AC Level Accuracy Performance Test 12**

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-12, "AC Analyzer ACVoltage AccuracyTest 12 Record" on page 254. To measure AC voltage accuracy, an AC signal is measured by an external multimeter and compared to the Test Set's internal AC voltmeter reading.

## **Setup**

Figure 8-17



#### **Procedure**

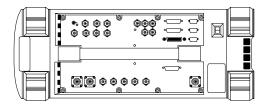
- **Step 1.** Set the digital multimeter to measure AC volts.
- **Step 2.** On the Test Set:
  - a. Press Preset.
  - **b.** Press the RF Gen key.
  - c. Set the Filter 2 field to >99kHz LPF.
  - d. Set the Detector field to RMS (default).
  - e. Set the Settling field to Slow.
  - f. Verify the Audio In Lo field is set to Gnd (default).
- **Step 3.** Set the audio analyzer's source to the frequencies and levels shown in the Performance Test Record. (Adjust the level until the digital multimeter reads the correct level.)
- **Step 4.** Measure the AC level on the Test Set and compare the measured level to the limits.

# **AF Analyzer Residual Noise Performance Test 13**

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-13, "AF Analyzer Residual Noise Test 13 Record" on page 255. The AC level of the audio input is measured with no signal source connected.

# Setup

#### Figure 8-18



#### **Procedure**

### **Step 1.** On the Test Set:

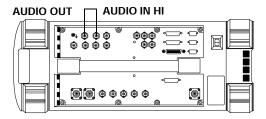
- a. Press Preset.
- **b.** Select the AF ANALYZER screen.
- c. Set the AF Anl In field to Audio In.
- d. Set the Filter 2 field to 15kHz LPF.
- e. Set the Audio In Lofield to Gnd.
- f. Set the Detector field to RMS.
- **Step 2.** Measure the AC level (residual noise) on the Test Set and compare the measured level to the limits shown in the Performance Test Record.
- Step 3. Set the Filter 2 field to >99kHz LP.
- **Step 4.** Measure the AC level (residual noise) on the Test Set and compare the measured level to the limits shown in the Performance Test Record.

# **AF Analyzer Distortion and SINAD Accuracy Performance Test 14**

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-14, "AF Analyzer Distortion and SINAD Accuracy Test 14 Record" on page 256. A calibrated distortion source is created by summing the two internal audio generators. Levels are measured separately by the internal AC voltmeter. One source is set to a harmonic two or three times the frequency of the other. The measured distortion and SINAD is compared with the calculated value.

## Setup

#### Figure 8-19



## **Procedure**

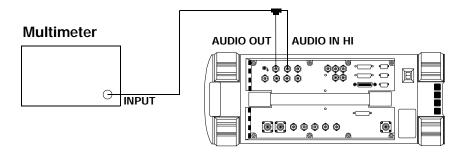
- **Step 1.** On the Test Set, press Preset.
- **Step 2.** Press the AF Anl key and verify:
  - the AF Anl Infield is set to Audio In (default).
  - the Audio In Lo field is set to Gnd (default).
  - the Detector field is set to RMS (default).
- **Step 3.** Select the RF GENERATOR screen.
  - a. Set the AFGen1 To field to Audio Out.
  - b. Set the AFGen1 To level field to 1.00 V.
  - c. Set the AFGen2 To field to Audio Out.
- **Step 4.** For the frequency (the harmonic) and level settings of Audio Frequency Generator 2 shown in the Performance Test Record, measure the distortion and SINAD on the Test Set and compare the measured values to the limits.

# **AF Analyzer DC Level Accuracy Performance Test 15**

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-15, "AF Analyzer DC Level Accuracy Test 15 Record" on page 257. To measure DC level accuracy, a DC signal is measured by an external digital multimeter and compared to the Test Set's internal DC voltmeter reading.

## Setup

### Figure 8-20



#### **Procedure**

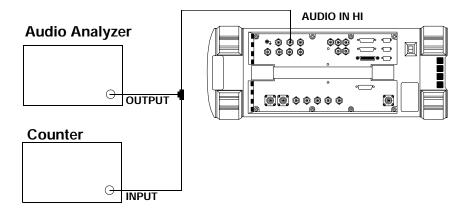
- **Step 1.** Set the multimeter to measure DC volts.
- **Step 2.** On the Test Set:
  - a. Press Preset.
  - **b.** Press the AF Anl key.
  - c. Set the AF Anl In field to Audio In (default).
  - d. Set the Audio In Lofield to Gnd (default).
  - e. Select the RF GENERATOR screen.
  - f. Set the AFGen1 Freq field to 0.0 Hz.
  - g. Set the AFGen1 To field to Audio Out.
  - h. Set the Audio Out field to DC.
  - i. Set the level of Audio Frequency Generator 1 as shown in the Performance Test Record and measure the DC level. Compare the measured voltage to the limits.

# **AF Analyzer Frequency Accuracy to 100 kHz Performance Test 16**

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-16, "AF Analyzer Frequency Accuracy to 100 kHz Test 16 Record" on page 258. To measure frequency accuracy up to 100 kHz, an AC signal at the audio input is measured by an external frequency counter and compared to the Test Set's internal audio frequency counter.

# **Setup**

Figure 8-21



#### **Procedure**

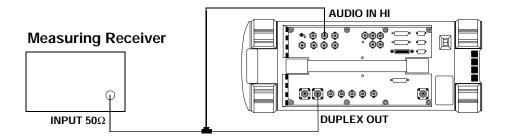
- **Step 1.** Set the frequency counter to measure frequency.
- **Step 2.** On the Test Set:
  - a. Press Preset.
  - **b.** Press the AF Anl key.
  - c. Set the AF Anl In field to Audio In (default).
  - d. Set the Filter 2 field to >99kHz LPF.
  - e. Set the Audio In Lofield to Gnd (default).
- **Step 3.** Set the audio analyzer's source to 1 V and set the frequencies as shown in the Performance Test Record. Measure the frequency on the Test Set and compare the measured frequency to the limits.

# AF Analyzer Frequency Accuracy at 400 kHz Performance Test 17

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-17, "AF Analyzer Frequency Accuracy at 400 kHz Test 17 Record" on page 259. To measure frequency accuracy at 400 kHz, the RF signal from the Test Set's DUPLEX OUT port is applied to the audio input and the input to the measuring receiver and the two measured frequencies are compared.

# **Setup**

#### Figure 8-22



#### **Procedure**

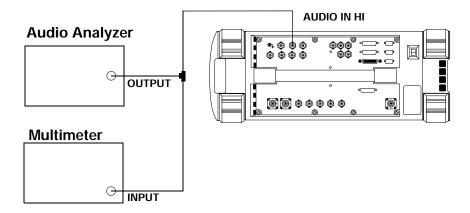
- **Step 1.** On the measuring receiver:
  - a. Reset the instrument.
  - **b.** Set the measurement mode to frequency.
- **Step 2.** On the Test Set:
  - a. Press Preset.
  - **b.** Press the RF GEN key.
  - c. Set the RF Gen Freq to 0.4 MHz.
  - d. Set the Amplitude to -21 dBm (20 mV).
  - e. Set the Output Port field to Dupl.
  - **f.** Press the AF Anl key.
  - g. Set the AF Anl In field to Audio In (default).
  - h. Set the Filter 2 field to >99kHz LPF.
  - i. Set the Audio In Lofield to Gnd (default).
- **Step 3.** Measure the audio frequency on the measuring receiver and the Test Set and note the frequency difference. Compare the calculated difference to the limits shown in the Performance Test Record.

# Oscilloscope Amplitude Accuracy Performance Test 18

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-18, "Oscilliscope Amplitude Accuracy Test 18 Record" on page 260. The 5V AC signal from the audio analyzer is measured by both an external multimeter and by the Test Set's internal oscilloscope. Since the oscilloscope reads peak volts, the RMS reading of the multimeter is multiplied by the square root of two.

## Setup

#### Figure 8-23



#### **Procedure**

- **Step 1.** Set the digital multimeter to measure AC volts.
- **Step 2.** On the Test Set:
  - a. Press Preset.
  - **b.** Press the AF Anl key.
  - c. Set the AF Anl In field to Audio In (default).
  - d. Set the Filter 2 field to >99kHz LPF.
  - e. Set the Audio In Lofield to Gnd (default).
  - **f.** Press the SCOPE key.
  - g. Set the Controls field to Marker and move the cursor to the Marker To Peak+ field.
- **Step 3.** Set the audio analyzer's source to 1 kHz and 5 V and fine adjust the level until the voltmeter reads 5V.
- **Step 4.** Set the frequency as shown in the Performance Test Record (PTR). For each setting, perform the following:

- a. Adjust the level until the digital multimeter reads 5V.
- **b.** Set Controls to Main and adjust the Time/Div on the Test Set to display 2 to 3 cycles of the waveform.
- **c.** Set Controls to Marker and press the knob (with the cursor in the Marker To Peak+ field) to move the marker to the peak of the waveform.
- **d.** Read the Lvl and compare the reading to the limits in the PTR.

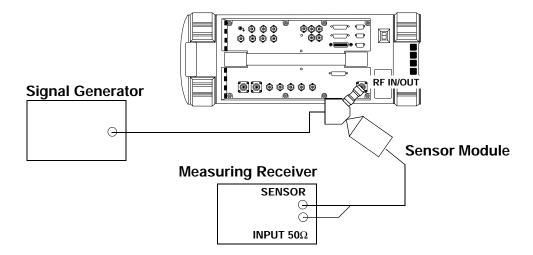
# RF Analyzer Level Accuracy Performance Test 19

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-19, "RF Analyzer Level Accuracy Test 19" on page 261. Level accuracy is measured using a system power calibration program that resides on a memory card.

#### **Procedure**

- **Step 1.** Obtain the memory card containing the System Power Calibration program (order Agilent Technologies part number E6380-61811). To order see "Ordering Parts" on page 38.
- **Step 2.** Run the System Power Calibration as follows:
  - **a.** Insert the memory card into the memory card slot.
  - **b.** Press the (Software) Menu key.
  - c. Set the Select Procedure Location: field to Card.
  - d. Set the Select Procedure Filename field to SYSPWRO.
  - e. Press the Run Test key.
- **Step 3.** Follow the instructions as they are presented. As the power difference is displayed, write these numbers in the Performance Test Record and compare them with the limits. (If two passes are chosen, average the two sets of data.) After the acquisition of levels is complete, select No when asked if you want the calibration factors downloaded into the Test Set's memory.

Figure 8-24



# RF Analyzer FM Accuracy Performance Test 20

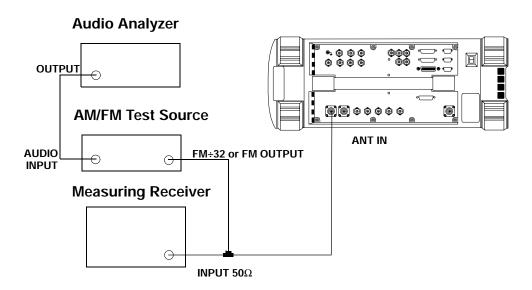
The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-20, "RF Analyzer FM Accuracy Test 20 Record" on page 263. The AM/FM test source provides the RF signal with FM. The signal is measured both by the Test Set's internal RF analyzer and the measuring receiver. The FM signal comes from the external audio source in the audio analyzer. The audio level is varied until the modulation is at the desired FM deviation as measured by the measuring receiver.

**NOTE** 

Use the AM/FM test source output labeled FM $\pm$ 32 for 12.5 MHz and the output labeled FM for 400 MHz. You can measure the frequency with the measuring receiver and adjust it with the carrier frequency tune knob, but the exact frequency is not critical.

## Setup

Figure 8-25



#### **Procedure**

- **Step 1.** On the AM/FM test source, set the test mode to FM.
- **Step 2.** On the measuring receiver:
  - a. Reset the instrument.
  - **b.** Set the measurement mode to FM.
  - c. Set the detector to RMS.

**Step 3.** On the audio analyzer:

- **a.** Reset the instrument.
- **b.** Set the output frequency to 50 Hz.

#### **Step 4.** On the Test Set:

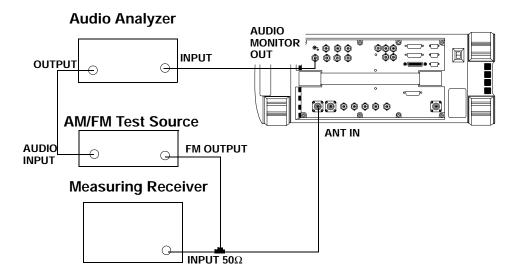
- a. Press Preset.
- **b.** Press the RF GEN key.
- c. Set the Tune Freq to 12.5 MHz.
- d. Set the Input Port field to Ant.
- e. Set the IF Filter field to 230 kHz.
- **f.** Press the AF Anl key.
- g. Set the AF Anl In field to FM Demod.
- h. Set the Filter 2 field to >99kHz LP.
- i. Set the Detector field to RMS.
- **Step 5.** For each RF output from the AM/FM test source (12.5 MHz and 400 MHz corresponding to the FM÷32 and FM outputs) shown in the Performance Test Record (PTR), do the following:
- **Step 1.** Set the audio analyzer's frequency (rate) as shown in the PTR.
- **Step 2.** Adjust the audio analyzer's level until the measuring receiver reads the FM deviation shown in the PTR.
- **Step 3.** Read the FM deviation on the Test Set and compare the results to the limits shown in the PTR.

# RF Analyzer FM Distortion Performance Test 21

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-20, "RF Analyzer FM Accuracy Test 20 Record" on page 263. An audio signal from the audio analyzer provides FM for the AM/FM test source. The AM/FM test source provides an RF signal (with FM) to the Test Set's internal RF analyzer. The measuring receiver is used to monitor FM deviation as the level of the audio signal from the audio analyzer is varied. The audio analyzer then measures distortion introduced by the Test Set.

# Setup

Figure 8-26



#### **Procedure**

- **Step 1.** On the AM/FM test source, set the test mode to FM.
- **Step 2.** On the measuring receiver:
  - **a.** Reset the instrument.
  - **b.** Set the measurement mode to FM.
  - c. Set the high-pass filter to 300 Hz.
  - d. Set the low-pass filter to 3 kHz.
- **Step 3.** On the audio analyzer:
  - **a.** Reset the instrument.
  - **b.** Set the output frequency to 1 kHz.

**c.** Set the measurement mode to distortion.

### **Step 4.** On the Test Set:

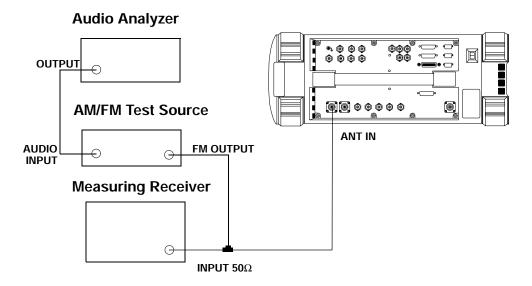
- a. Press Preset.
- **b.** Press the RF Anl key.
- c. Set the Tune Freq to 400 MHz.
- d. Set the Input Port field to Ant.
- e. Set the IF Filter field to 230 kHz.
- **f.** Press the AF Anl key.
- g. Set the AF Anl In field to FM Demod.
- h. Set the Filter 1 field to 300Hz HPF.
- i. Set the Filter 2 field to 3kHz LPF.
- j. Set the Detector field to Pk+.
- **Step 5.** For each FM deviation setting shown in the Performance Test Record (PTR) do the following:
  - **a.** Adjust the audio analyzer's level until the measuring receiver reads the FM deviation shown in the PTR.
  - **b.** Read the distortion on the audio analyzer and compare the results to the limits shown in the PTR.

# RF Analyzer FM Bandwidth Performance Test 22

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-22, "RF Analyzer FM Bandwidth Test 22 Record" on page 265. An audio signal from the audio analyzer provides FM for the AM/FM test source. The AM/FM test source provides an RF signal (with FM) to the Test Set's internal RF analyzer. The measuring receiver is used to monitor FM deviation as the level of the audio signal from the audio analyzer is varied. The audio rate is varied in several steps from 20 Hz to 70 kHz. The difference between the maximum and minimum FM peak deviation is noted.

## Setup

Figure 8-27



#### **Procedure**

- **Step 1.** On the AM/FM test source, set the test mode to FM.
- **Step 2.** On the measuring receiver:
  - a. Reset the instrument.
  - **b.** Set the measurement mode to FM.
  - c. Set the all filters off.
- **Step 3.** On the audio analyzer:
  - a. Reset the instrument.

**b.** Set the output frequency to 1 kHz.

### **Step 4.** On the Test Set:

- a. Press Preset.
- **b.** Press the RF Anl key.
- c. Set the Tune Freq to 400 MHz.
- d. Set the Input Port field to Ant.
- e. Set the IF Filter field to 230 kHz.
- f. Set the Squelch field to Open.
- g. Press the AF Anl key.
- h. Set the AF Anl In field to FM Demod.
- i. Set the Filter 2 field to >99kHz LP.
- j. Set the Detector field to Pk+.
- **Step 5.** Set the audio analyzer to the following frequencies: 20 Hz, 100 Hz, 1 kHz, 10 kHz, 35 kHz, and 70 kHz. For each frequency adjust the audio analyzer's level until the measuring receiver reads 25 kHz FM deviation and record the deviation read on the Test Set.
- **Step 6.** Of the FM deviations measured by the Test Set find the maximum and minimum deviations and make the following calculation:

#### Step 7.

$$dB = 20 \bullet \log \left( \frac{\text{Maximum Deviation}}{\text{Minimum Deviation}} \right)$$

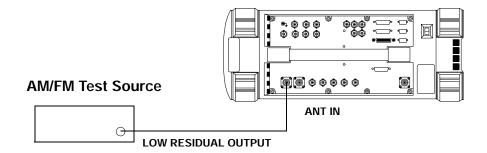
Record the dB difference in the Performance Test Record and compare it with the limits shown.

# RF Analyzer Residual FM Performance Test 23

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-23, "RF Analyzer Residual FM Test 23 Record" on page 266. The AM/FM test source provides a CW signal with minimal residual FM. The FM is measured by the Test Set's internal RF analyzer.

## **Setup**

#### Figure 8-28



#### **Procedure**

- **Step 1.** On the AM/FM test source, set the test mode to residual FM.
- **Step 2.** On the Test Set:
  - a. Press Preset.
  - **b.** Press the RF Anl key.
  - c. Set the Tune Freq to 560 MHz.
  - d. Set the Input Port field to Ant.
  - e. Set the IF Filter field to 230 kHz.
  - **f.** Press the AF Anl key.
  - g. Set the AF Anl In field to FM Demod.
  - h. Set the Filter 1 field to 300Hz HPF.
  - i. Set the Filter 2 field to 3kHz LPF.
  - j. Set the Detector field to RMS (default).
- **Step 3.** Read the FM deviation (residual FM) and record the deviation read on the Test Set in the Performance Test Record and compare it to the limits.

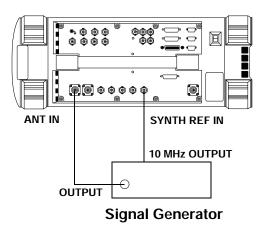
# Spectrum Analyzer Image Rejection Performance Test 24

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-24, "Spectrum Analyzer Image Rejection (Image) Test 24 Record" on page 267. This test has two procedures. The first procedure measures the spectrum analyzer's ability to reject image frequencies. The spectrum analyzer is tuned to a signal frequency while an image signal from the signal generator is applied to the antenna input port.

The second procedure measures the spectrum analyzer's residual response at several frequencies.

## Setup

#### Figure 8-29 Spectrum Analyzer Image Rejection Test 24



#### **Procedure 1**

**Step 1.** On the signal generator:

- a. Set the level to -20 dBm.
- **b.** Set the frequency to 613.6 MHz.
- c. Set modulation off.

**Step 2.** On the Test Set:

- a. Press Preset.
- **b.** Press the Spec Anl key.
- c. Set the RF In/Ant field to Ant.
- d. Set the Ref Level field to -25 dBm.
- e. Set the Span field to 5 kHz.

- f. Set the Controls field to Marker.
- g. Set the Marker To field to Center Freq.
- h. Set the Controls field back to Main.
- **Step 3.** Set the signal generator's frequency and the Test Set's spectrum analyzer center frequency as shown in the Performance Test Record (PTR) and read the image response on the spectrum analyzer. The image response is the spectrum analyzer's marker level (in dBm) minus the signal generator's output level (minus -20 dBm). (In other words, add 20 dB to the marker level.) Compare the results to the limits.

#### **Procedure 2**

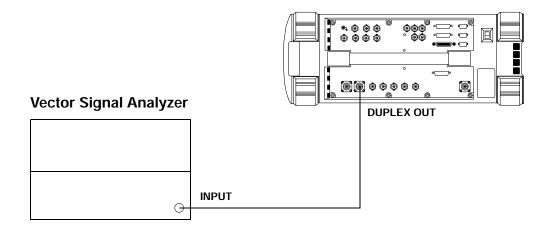
- **Step 1.** Disconnect the signal generator from the Test Set.
- **Step 2.** On the Test Set:
  - a. Set the Controls field to Auxiliary.
  - **b.** Set the Input Atten field to Hold at 0 dB.
  - c. Set the Controls field back to Marker.
  - d. Set the Marker To field to Center Freq.
  - e. Set the Controls field to Main.
  - f. Set the Span field to 10 MHz.
  - g. Set the Ref Level field to -20 dBm.
- **Step 3.** Set the Test Set's Center Freq field to the frequencies shown in the PTR and measure the residual response on the spectrum analyzer's marker field and compare it to the limits.

# **TDMA Generator Modulation Accuracy Performance Test 25**

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-26, "TDMA Generator Modulation Accuracy Test 25 Record" on page 268. The modulation accuracy of the TDMA generator is directly measured with a vector signal analyzer at the DUPLEX OUT port.

## **Setup**

## Figure 8-30 TDMA Generator Modulation Accuracy Test 25



#### **Procedure**

#### **Step 1.** On the Test Set:

- a. Press Preset.
- **b.** Press the RF Gen key.
- c. Set RF Gen Freq to 859 MHz.
- d. Set Output Port to Dupl.
- e. Set Amplitude to -10 dBM.
- f. Press the TDMA Gen/Anl key.
- g. Set RF Path to IQ.
- h. Select Send in the Digital Gen field.

### **Step 2.** On the Vector Signal Analyzer:

- **a.** Press the Frequency key.
- **b.** Set center frequency to 859 MHz.
- c. Press the Instrument Mode key

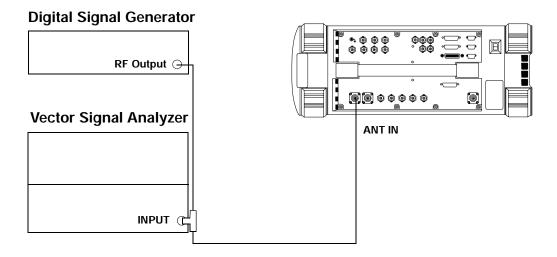
- d. Press the Digital Demodulation (F4) key
- **e.** Press the D key.
- **Step 3.** Record and compare the EVM, Magnitude Error, Phase Error, and IQ Offset to the values listed in table 9-26, "TDMA Generator Modulation Accuracy Test 25 Record" on page 268.
- **Step 4.** On the Test Set:
  - a. Press the RF Gen key.
  - b. Set RF Gen Freq to 1880 MHz.
  - c. Set Amplitude to -10 dBM.
  - d. Press the TDMA Gen/Anl key.
  - e. Select Send in the Digital Gen field.
- **Step 5.** On the Vector Signal Analyzer:
  - **a.** Press the Frequency key.
  - **b.** Set center frequency to 1880 MHz.
  - c. Press the Instrument Mode key
  - d. Press the Digital Demodulation (F4) key
  - e. Press the D key.
- **Step 6.** Record and compare the EVM, Magnitude Error, Phase Error, and IQ Offset to the values listed in table 9-26, "TDMA Generator Modulation Accuracy Test 25 Record" on page 268.

# TDMA Analyzer Modulation Accuracy Performance Test 26

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) TDMA Generator Modulation Accuracy Performance Test 25 Record table 9-27, "TDMA Analyzer Modulation AccuracyTest 26 Record" on page 269. This test verifies the performance of the Test Set's TDMA analyzer. A digital signal generator is used to generate a pi/4 DQPSK signal. That signal is then measured by the Test Set and the vector signal analyzer. These values are compared and recorded in the PTR.

# Setup

Figure 8-31 TDMA Analyzer Modulation Accuracy Test 26



#### **Procedure**

- **Step 1.** On the digital signal generator:
  - a. Set the Frequency to 880 MHz.
  - **b.** Set the Amplitude to -10dBm.
  - c. Set the Modulation format to pi/4 DQPSK (NADC).
- **Step 2.** On the vector signal analyzer:
  - a. Press the Frequency key.
  - **b.** Set the center frequency to 880 MHz.
  - c. Press the Instrument Mode key.
  - d. Press the Digital Demodulation (F4) key.
  - e. Press the D display button.

#### **Step 3.** On the Test Set:

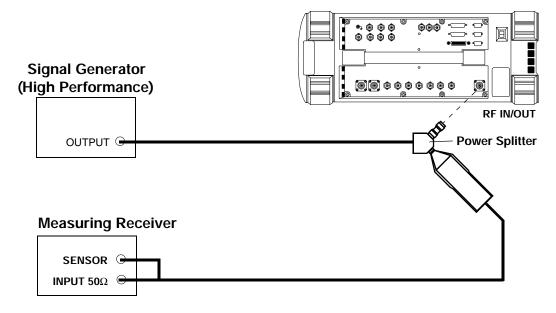
- a. Press the Preset key.
- **b.** Press the RF Anl key.
- c. Set the Tune Freq to 880 MHz.
- **d.** Ensure the Input Port to Ant.
- e. Press the TDMA Gen/Anl key.
- f. Set the Gain to 6 dBm.
- g. Set Correlate to None.
- **Step 4.** Compare the values of EVM on the test set and vector signal analyzer and record the difference in the PTR table 9-27, "TDMA Analyzer Modulation Accuracy Test 26 Record" on page 269.
- **Step 5.** On the digital signal generator:
  - a. Set the Frequency to 1960 MHz.
- **Step 6.** On the vector signal analyzer:
  - a. Press the Frequency key.
  - **b.** Set the center frequency to 1960 MHz.
- **Step 7.** On the Test Set:
  - a. Press the RF Anl key.
  - **b.** Set the Tune Freq to 1960 MHz.
  - c. Press the TDMA Gen/Anl key.
- **Step 8.** Compare the values of EVM on the test set and vector signal analyzer and record the difference in the PTR table 9-27, "TDMA Analyzer Modulation Accuracy Test 26 Record" on page 269.

# TDMA Analyzer Channel Power Level Accuracy Performance Test 27

The purpose of this test is to verify that the Test Set meets the specification limits in PTR (Performance Test Record) table 9-28, "TDMA Analyzer Channel Power Level Accuracy Test 27" on page 270. The tuned channel power level accuracy is verified by comparing the measured power in a CW signal with the power level measured by a measuring receiver.

## Setup

Figure 8-32 TDMA Analyzer Channel Power Level Accuracy Test 28



#### **Procedure**

- **Step 1.** On the measuring receiver:
  - **a.** Set the measurement mode to RF Power.
  - **b.** Set the display mode to LOG.
  - **c.** Calibrate the power sensor.
- **Step 2.** On the measuring receiver key in 881.52 MHz.
- **Step 3.** On the signal generator:
  - **a.** Set the frequency to 881.52 MHz.
  - **b.** Set the output level so the measuring receiver reads +11 dBm.

#### **Step 4.** On the Test Set:

#### **TDMA Analyzer Channel Power Level Accuracy Performance Test 27**

- a. Push Preset.
- **b.** Select the RF Analyzer screen.
- c. Set the Tune Freq to 881.52 MHz.
- **d.** Select the TDMA Test screen.
- e. Select the Chan Pwr measurement.
- f. Select Calibrate under Chn Pwr Cal.
- **Step 5.** Record the Chan Pwr dBm measurement in the PTR, see table 9-28, "TDMA Analyzer Channel Power Level Accuracy Test 27" on page 270.
- **Step 6.** Repeat steps 2 through 5 for each of the data points listed in the PTR.

| NOTE  | The Chan Po  | r Cal is only required t | when the frequency is changed. |
|-------|--------------|--------------------------|--------------------------------|
| IVOIL | THE CHAIL IV | vi car is only required  | when the frequency is changed. |

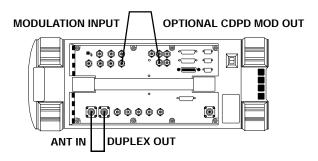
#### **CDPD**

#### **Performance Test 28**

The purpose of this test is to verify that the CDPD option (Option 003) of the Test Set meets the specification limits in the CDPD PTR (Performance Test Record) tables on page 270.

#### **Setup**

#### Figure 8-33 CDPD Performance Test 28



#### **Procedure**

- **Step 1.** Press the Preset button.
- Step 2. For Select Procedure Location: select ROM
- Step 3. For Select Procedure Filename: select SERVICE6
- Step 4. Select Run Test
- Step 5. Select CDPD Performance Tests (Opt 003)
- **Step 6.** Follow the instructions on the screen.
- **Step 7.** Record and calculate the information requested by the PTR tables of "CDPD Performance Test 28" on page 221.

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### 9 Performance Test Records

Use this chapter to record the results of the performance tests in Chapter 8, "Performance Tests," on page 173.

## **RF Generator FM Distortion Performance Test 1 Record**

For test procedure, see "RF Generator FM Distortion Performance Test 1" on page 178.

**Table 9-1 Generator FM Distortion Test 1 Record** 

| Level | RF      | Deviation | Rate  | FM Distort | tion Limits (%) |
|-------|---------|-----------|-------|------------|-----------------|
| (dBm) | (MHz)   | (kHz)     | (kHz) | Upper      | Actual          |
| -10   | 10      | 99        | 1     | 0.50       |                 |
| -10   | 10      | 5         | 1     | 0.50       |                 |
| -10   | 312.5   | 5         | 1     | 0.50       |                 |
| -10   | 425     | 50        | 1     | 0.50       |                 |
| -10   | 501     | 99        | 1     | 0.50       |                 |
| -10   | 501     | 50        | 1     | 0.50       |                 |
| -10   | 501     | 5         | 1     | 0.50       |                 |
| -10   | 568.75  | 50        | 1     | 0.50       |                 |
| -10   | 656.25  | 99        | 1     | 0.50       |                 |
| -10   | 656.25  | 50        | 1     | 0.50       |                 |
| -10   | 656.25  | 5         | 1     | 0.50       |                 |
| -10   | 750     | 99        | 1     | 0.50       |                 |
| -10   | 750     | 50        | 1     | 0.50       |                 |
| -10   | 750     | 5         | 1     | 0.50       |                 |
| -10   | 856.25  | 99        | 1     | 0.50       |                 |
| -10   | 856.25  | 50        | 1     | 0.50       |                 |
| -10   | 856.25  | 5         | 1     | 0.50       |                 |
| -10   | 956.25  | 50        | 1     | 0.50       |                 |
| -10   | 976.002 | 5         | 1     | 0.50       |                 |
| -10   | 1000    | 99        | 1     | 0.50       |                 |
| -10   | 1000    | 50        | 1     | 0.50       |                 |
| -10   | 1000    | 11        | 1     | 0.50       |                 |
| -10   | 1000    | 5         | 1     | 0.50       |                 |
| -10   | 1000    | 6         | 1     | 0.50       |                 |

**Table 9-1 Generator FM Distortion Test 1 Record** 

| Level           | RF                 | Deviation    | Rate     | FM Distort | ion Limits (%) |
|-----------------|--------------------|--------------|----------|------------|----------------|
| (dBm)           | (MHz)              | (kHz)        | (kHz)    | Upper      | Actual         |
| -10             | 1000               | 7            | 1        | 0.50       |                |
| -10             | 1000               | 8            | 1        | 0.50       |                |
| -10             | 1000               | 9            | 1        | 0.50       |                |
| -10             | 998.401            | 8            | 1        | 0.50       |                |
| -10             | 768.001            | 8            | 1        | 0.50       |                |
| -10             | 512.001            | 8            | 1        | 0.50       |                |
| -10             | 511.601            | 8            | 1        | 0.50       |                |
| -10             | 511.201            | 8            | 1        | 0.50       |                |
| The following e | ntries are for the | 2 GHz setup. | <u> </u> |            | •              |
| -10             | 1700               | 99           | 1        | 1.00       |                |
| -10             | 1700               | 50           | 1        | 1.00       |                |
| -10             | 1700               | 5            | 1        | 1.00       |                |
| -10             | 2000               | 99           | 1        | 1.00       |                |
| -10             | 2000               | 50           | 1        | 1.00       |                |
| -10             | 2000               | 5            | 1        | 1.00       |                |

## **RF Generator FM Accuracy Performance Test 2 Record**

For test procedure, see "RF Generator FM Accuracy Performance Test 2" on page 180.

Table 9-2 RF Generator FM Accuracy Test 2 Record

| Level | RF      | Deviation | Rate  | FM Devia | FM Deviation Limits (kHz) |        |  |
|-------|---------|-----------|-------|----------|---------------------------|--------|--|
| (dBm) | (MHz)   | (kHz)     | (kHz) | Lower    | Upper                     | Actual |  |
| -10   | 10      | 99        | 1     | 95.035   | 102.965                   |        |  |
| -10   | 10      | 3         | 1     | 2.845    | 3.155                     |        |  |
| -10   | 312.5   | 3         | 1     | 2.845    | 3.155                     |        |  |
| -10   | 425     | 50        | 1     | 47.750   | 52.25                     |        |  |
| -10   | 501     | 99        | 1     | 95.035   | 102.965                   |        |  |
| -10   | 501     | 50        | 1     | 47.750   | 52.25                     |        |  |
| -10   | 501     | 3         | 1     | 2.845    | 3.155                     |        |  |
| -10   | 568.75  | 50        | 1     | 47.750   | 52.25                     |        |  |
| -10   | 656.25  | 99        | 1     | 95.035   | 102.965                   |        |  |
| -10   | 656.25  | 50        | 1     | 47.750   | 52.25                     |        |  |
| -10   | 656.25  | 3         | 1     | 2.845    | 3.155                     |        |  |
| -10   | 750     | 99        | 1     | 95.035   | 102.965                   |        |  |
| -10   | 750     | 50        | 1     | 47.750   | 52.25                     |        |  |
| -10   | 750     | 3         | 1     | 2.845    | 3.155                     |        |  |
| -10   | 856.25  | 99        | 1     | 95.035   | 102.965                   |        |  |
| -10   | 856.25  | 50        | 1     | 47.750   | 52.25                     |        |  |
| -10   | 856.25  | 3         | 1     | 2.845    | 3.155                     |        |  |
| -10   | 956.25  | 50        | 1     | 47.750   | 52.25                     |        |  |
| -10   | 976.002 | 3         | 1     | 2.845    | 3.155                     |        |  |
| -10   | 1000    | 99        | 1     | 95.035   | 102.965                   |        |  |
| -10   | 1000    | 50        | 1     | 47.750   | 52.25                     |        |  |
| -10   | 1000    | 11        | 1     | 10.115   | 11.885                    |        |  |
| -10   | 1000    | 3         | 1     | 2.845    | 3.155                     |        |  |

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Table 9-2 RF Generator FM Accuracy Test 2 Record

| Level | RF    | Deviation | Rate  | FM Devia | Hz)     |        |
|-------|-------|-----------|-------|----------|---------|--------|
| (dBm) | (MHz) | (kHz)     | (kHz) | Lower    | Upper   | Actual |
| _     | 1700  | 99        | 1     | 95.035   | 102.965 |        |
| 10    |       |           |       |          |         |        |
| _     | 1700  | 50        | 1     | 47.750   | 52.25   |        |
| 10    |       |           |       |          |         |        |
| _     | 1700  | 3         | 1     | 2.845    | 3.155   |        |
| 10    |       |           |       |          |         |        |
| _     | 2000  | 99        | 1     | 95.035   | 102.965 |        |
| 10    |       |           |       |          |         |        |
| _     | 2000  | 50        | 1     | 47.750   | 52.25   |        |
| 10    |       |           |       |          |         |        |
| _     | 2000  | 3         | 1     | 2.845    | 3.155   |        |
| 10    |       |           |       |          |         |        |

## **RF Generator FM Flatness Performance Test 3 Record**

For test procedure, see "RF Generator FM Flatness Performance Test 3" on page 182.

Table 9-3 RF Generator FM Flatness Test 3 Record

| Level<br>(dBm) | RF<br>(MHz)    | Deviation<br>(kHz) | Rate<br>(kHz) |           | Computed FM<br>Flatness Limits (dB) |          | Computed<br>Results<br>(dB) |
|----------------|----------------|--------------------|---------------|-----------|-------------------------------------|----------|-----------------------------|
|                |                |                    |               | Lower     | Upper                               | Reading  | Computed                    |
| -10            | 521            | 50                 | 1             | Reference |                                     |          | 0 dB                        |
| -10            | 521            | 50                 | 0.1           | -1        | 1                                   |          |                             |
| -10            | 521            | 50                 | 0.2           | -1        | 1                                   |          |                             |
| -10            | 521            | 50                 | 2             | -1        | 1                                   |          |                             |
| -10            | 521            | 50                 | 10            | -1        | 1                                   |          |                             |
| -10            | 521            | 50                 | 25            | -1        | 1                                   |          |                             |
| -10            | 975.5          | 50                 |               | Reference | - 1                                 |          | 0 dB                        |
| -10            | 975.5          | 50                 | 0.1           | -1        | 1                                   |          |                             |
| -10            | 975.5          | 50                 | 0.2           | -1        | 1                                   |          |                             |
| -10            | 975.5          | 50                 | 2             | -1        | 1                                   |          |                             |
| -10            | 975.5          | 50                 | 10            | -1        | 1                                   |          |                             |
| -10            | 975.5          | 50                 | 25            | -1        | 1                                   |          |                             |
| The follov     | ving entries a | re for the 2 GF    | Iz setup.     |           |                                     | <b>-</b> | <u> </u>                    |
| -10            | 1700           | 50                 |               | Reference |                                     |          | 0 dB                        |
| -10            | 1700           | 50                 | 0.1           | -1        | 1                                   |          |                             |
| -10            | 1700           | 50                 | 0.2           | -1        | 1                                   |          |                             |
| -10            | 1700           | 50                 | 2             | -1        | 1                                   |          |                             |
| -10            | 1700           | 50                 | 10            | -1        | 1                                   |          |                             |
| -10            | 1700           | 50                 | 25            | -1        | 1                                   |          |                             |
| -10            | 2000           | 50                 |               | Reference | l                                   |          | 0 dB                        |
| -10            | 2000           | 50                 | 0.1           | -1        | 1                                   |          |                             |
| -10            | 2000           | 50                 | 0.2           | 1         | 1                                   |          |                             |

Table 9-3 RF Generator FM Flatness Test 3 Record

| Level<br>(dBm) | RF<br>(MHz) | Deviation<br>(kHz) | Rate<br>(kHz) | Computed FM<br>Flatness Limits (dB) |       | Measured<br>Reading<br>(kHz) | Computed<br>Results<br>(dB) |
|----------------|-------------|--------------------|---------------|-------------------------------------|-------|------------------------------|-----------------------------|
|                |             |                    |               | Lower                               | Upper | Reading                      | Computed                    |
| -10            | 2000        | 50                 | 0.2           | -1                                  | 1     |                              |                             |
| -10            | 2000        | 50                 | 10            | -1                                  | 1     |                              |                             |
| -10            | 2000        | 50                 | 25            | -1                                  | 1     |                              |                             |

## **RF Generator Residual FM Performance Test 4 Record**

For test procedure, see "RF Generator Residual FM Performance Test 4" on page 184.

Table 9-4 RF Generator Residual FM Test 4 Record

| LO<br>(MHz) | RF<br>(MHz) | Residual F | M Limits (Hz) |
|-------------|-------------|------------|---------------|
| (MHZ)       | (WITZ)      | Upper      | Actual        |
| 11.5        | 10          | 7          |               |
| 101.5       | 100         | 7          |               |
| 249.5       | 248         | 7          |               |
| 251.5       | 250         | 4          |               |
| 401.5       | 400         | 4          |               |
| 501.5       | 500         | 4          |               |
| 502.5       | 501         | 7          |               |
| 512.701     | 511.201     | 7          |               |
| 513.101     | 511.601     | 7          |               |
| 513.501     | 512.001     | 7          |               |
| 626.5       | 625         | 7          |               |
| 736.5       | 735         | 7          |               |
| 741.5       | 740         | 7          |               |
| 746.5       | 745         | 7          |               |
| 751.5       | 750         | 7          |               |
| 769.501     | 768.001     | 7          |               |
| 846.5       | 845         | 7          |               |
| 851.5       | 850         | 7          |               |
| 856.5       | 855         | 7          |               |
| 866.5       | 865         | 7          |               |
| 901.5       | 900         | 7          |               |
| 999.901     | 998.401     | 7          |               |
| 1001.5      | 1000        | 7          |               |

Table 9-4 RF Generator Residual FM Test 4 Record

| LO<br>(MHz)  | RF<br>(MHz)      | Residual FM Limits (Hz) |        |  |
|--------------|------------------|-------------------------|--------|--|
| (MIIIZ)      | (141112)         | Upper                   | Actual |  |
| The followin | g entries are fo | or the 2 GHz set        | up.    |  |
| 201.5        | 1700             | 14                      |        |  |
| 501.5        | 2000             | 14                      |        |  |

### **RF Generator Level Accuracy Performance Test 5 Record**

For test procedure, see "RF Generator Level Accuracy Performance Test 5" on page 187.

Table 9-5 RF Generator Level Accuracy Test 5 Results

| Port          | RF   | Level | Level Lim | its (dBm) |        |  |  |  |  |  |
|---------------|--|-------|-----------|-----------|--------|--|--|--|--|--|
|               | (MHz)                                      | (dBm) | Lower     | Upper     | Actual |  |  |  |  |  |
| The following | The following entries are for Procedure 1. |       |           |           |        |  |  |  |  |  |
| DUPLEX<br>OUT | 3  | -10   | -11.500   | -8.500    |        |  |  |  |  |  |
| DUPLEX<br>OUT | 3  | -15   | -16.500   | -13.500   |        |  |  |  |  |  |
| DUPLEX<br>OUT | 3  | -20   | -21.500   | -18.500   |        |  |  |  |  |  |
| DUPLEX<br>OUT | 3  | -25   | -26.500   | -23.500   |        |  |  |  |  |  |
| DUPLEX<br>OUT | 3  | -30   | -31.500   | -28.500   |        |  |  |  |  |  |
| DUPLEX<br>OUT | 3  | -35   | -36.500   | -33.500   |        |  |  |  |  |  |
| DUPLEX<br>OUT | 3  | -40   | -41.500   | -38.500   |        |  |  |  |  |  |
| DUPLEX<br>OUT | 3  | -45   | -46.500   | -43.500   |        |  |  |  |  |  |
| DUPLEX<br>OUT | 3  | -50   | -51.500   | -48.500   |        |  |  |  |  |  |
| DUPLEX<br>OUT | 3  | -55   | -56.500   | -53.500   |        |  |  |  |  |  |
| DUPLEX<br>OUT | 3  | -60   | -61.500   | -58.500   |        |  |  |  |  |  |
| DUPLEX<br>OUT | 3  | -65   | -66.500   | -63.500   |        |  |  |  |  |  |
| DUPLEX<br>OUT | 3  | -70   | -71.500   | -68.500   |        |  |  |  |  |  |
| DUPLEX<br>OUT | 3  | -75   | -76.500   | -73.500   |        |  |  |  |  |  |

Table 9-5 RF Generator Level Accuracy Test 5 Results

| Port          | RF    | Level | Level Limi | imits (dBm) |        |  |
|---------------|-------|-------|------------|-------------|--------|--|
|               | (MHz) | (dBm) | Lower      | Upper       | Actual |  |
| DUPLEX<br>OUT | 3     | -80   | -81.500    | -78.500     |        |  |
| DUPLEX<br>OUT | 3     | -85   | -86.500    | -83.500     |        |  |
| DUPLEX<br>OUT | 3     | -90   | -91.500    | -88.500     |        |  |
| DUPLEX<br>OUT | 3     | -95   | -96.500    | -93.500     |        |  |
| DUPLEX<br>OUT | 3     | -100  | -101.500   | -98.500     |        |  |
| DUPLEX<br>OUT | 3     | -105  | -106.500   | -103.500    |        |  |
| DUPLEX<br>OUT | 3     | -110  | -111.500   | -108.500    |        |  |
| DUPLEX<br>OUT | 3     | -115  | -116.500   | -113.500    |        |  |
| DUPLEX<br>OUT | 3     | -120  | -121.500   | -118.500    |        |  |
| DUPLEX<br>OUT | 3     | -125  | -126.500   | -123.500    |        |  |
| RF<br>IN/OUT  | 3     | -40   | -41.000    | -39.000     |        |  |
| RF<br>IN/OUT  | 3     | -45   | -46.000    | -44.000     |        |  |
| RF<br>IN/OUT  | 3     | -50   | -51.000    | -49.000     |        |  |
| RF<br>IN/OUT  | 3     | -55   | -56.000    | -54.000     |        |  |
| RF<br>IN/OUT  | 3     | -60   | -61.000    | -59.000     |        |  |
| RF<br>IN/OUT  | 3     | -65   | -66.000    | -64.000     |        |  |
| RF<br>IN/OUT  | 3     | -70   | -71.000    | -69.000     |        |  |

Table 9-5 RF Generator Level Accuracy Test 5 Results

| Port          | RF    | Level | Level Limi | ts (dBm) |        |
|---------------|-------|-------|------------|----------|--------|
|               | (MHz) | (dBm) | Lower      | Upper    | Actual |
| RF<br>IN/OUT  | 3     | -75   | -76.000    | -74.000  |        |
| RF<br>IN/OUT  | 3     | -80   | -81.000    | -79.000  |        |
| RF<br>IN/OUT  | 3     | -85   | -86.000    | -84.000  |        |
| RF<br>IN/OUT  | 3     | -90   | -91.000    | -89.000  |        |
| RF<br>IN/OUT  | 3     | -95   | -96.000    | -94.000  |        |
| RF<br>IN/OUT  | 3     | -100  | -101.000   | -99.000  |        |
| RF<br>IN/OUT  | 3     | -105  | -106.000   | -104.000 |        |
| RF<br>IN/OUT  | 3     | -110  | -111.000   | -109.000 |        |
| RF<br>IN/OUT  | 3     | -115  | -116.000   | -114.000 |        |
| RF<br>IN/OUT  | 3     | -120  | -121.000   | -119.000 |        |
| RF<br>IN/OUT  | 3     | -125  | -126.000   | -124.000 |        |
| DUPLEX<br>OUT | 687.5 | -10   | -11.500    | -8.500   |        |
| DUPLEX<br>OUT | 687.5 | -15   | -16.500    | -13.500  |        |
| DUPLEX<br>OUT | 687.5 | -20   | -21.500    | -18.500  |        |
| DUPLEX<br>OUT | 687.5 | -25   | -26.500    | -23.500  |        |
| DUPLEX<br>OUT | 687.5 | -30   | -31.500    | -28.500  |        |
| DUPLEX<br>OUT | 687.5 | -35   | -36.500    | -33.500  |        |

Table 9-5 RF Generator Level Accuracy Test 5 Results

| Port          | RF    | Level | Level Limits (dBm) |          |        |
|---------------|-------|-------|--------------------|----------|--------|
|               | (MHz) | (dBm) | Lower              | Upper    | Actual |
| DUPLEX<br>OUT | 687.5 | -40   | -41.500            | -38.500  |        |
| DUPLEX<br>OUT | 687.5 | -45   | -46.500            | -43.500  |        |
| DUPLEX<br>OUT | 687.5 | -50   | -51.500            | -48.500  |        |
| DUPLEX<br>OUT | 687.5 | -55   | -56.500            | -53.500  |        |
| DUPLEX<br>OUT | 687.5 | -60   | -61.500            | -58.500  |        |
| DUPLEX<br>OUT | 687.5 | -65   | -66.500            | -63.500  |        |
| DUPLEX<br>OUT | 687.5 | -70   | -71.500            | -68.500  |        |
| DUPLEX<br>OUT | 687.5 | -75   | -76.500            | -73.500  |        |
| DUPLEX<br>OUT | 687.5 | -80   | -81.500            | -78.500  |        |
| DUPLEX<br>OUT | 687.5 | -85   | -86.500            | -83.500  |        |
| DUPLEX<br>OUT | 687.5 | -90   | -91.500            | -88.500  |        |
| DUPLEX<br>OUT | 687.5 | -95   | -96.500            | -93.500  |        |
| DUPLEX<br>OUT | 687.5 | -100  | -101.500           | -98.500  |        |
| DUPLEX<br>OUT | 687.5 | -105  | -106.500           | -103.500 |        |
| DUPLEX<br>OUT | 687.5 | -110  | -111.500           | -108.500 |        |
| DUPLEX<br>OUT | 687.5 | -115  | -116.500           | -113.500 |        |
| DUPLEX<br>OUT | 687.5 | -120  | -121.500           | -118.500 |        |

Table 9-5 RF Generator Level Accuracy Test 5 Results

| Port          | RF    | Level<br>(dBm) | Level Limi |          |        |
|---------------|-------|----------------|------------|----------|--------|
|               | (MHz) | (dBm)          | Lower      | Upper    | Actual |
| DUPLEX<br>OUT | 687.5 | -125           | -126.500   | -123.500 |        |
| RF<br>IN/OUT  | 687.5 | -40            | -41.000    | -39.000  |        |
| RF<br>IN/OUT  | 687.5 | -45            | -46.000    | -44.000  |        |
| RF<br>IN/OUT  | 687.5 | -50            | -51.000    | -49.000  |        |
| RF<br>IN/OUT  | 687.5 | -55            | -56.000    | -54.000  |        |
| RF<br>IN/OUT  | 687.5 | -60            | -61.000    | -59.000  |        |
| RF<br>IN/OUT  | 687.5 | -65            | -66.000    | -64.000  |        |
| RF<br>IN/OUT  | 687.5 | -70            | -71.000    | -69.000  |        |
| RF<br>IN/OUT  | 687.5 | -75            | -76.000    | -74.000  |        |
| RF<br>IN/OUT  | 687.5 | -80            | -81.000    | -79.000  |        |
| RF<br>IN/OUT  | 687.5 | -85            | -86.000    | -84.000  |        |
| RF<br>IN/OUT  | 687.5 | -90            | -91.000    | -89.000  |        |
| RF<br>IN/OUT  | 687.5 | -95            | -96.000    | -94.000  |        |
| RF<br>IN/OUT  | 687.5 | -100           | -101.000   | -99.000  |        |
| RF<br>IN/OUT  | 687.5 | -105           | -106.000   | -104.000 |        |
| RF<br>IN/OUT  | 687.5 | -110           | -111.000   | -109.000 |        |
| RF<br>IN/OUT  | 687.5 | -115           | -116.000   | -114.000 |        |

Table 9-5 RF Generator Level Accuracy Test 5 Results

| Port          | RF    | Level | Level Limi | ts (dBm) |        |
|---------------|-------|-------|------------|----------|--------|
|               | (MHz) | (dBm) | Lower      | Upper    | Actual |
| RF<br>IN/OUT  | 687.5 | -120  | -121.000   | -119.000 |        |
| RF<br>IN/OUT  | 687.5 | -125  | -126.000   | -124.000 |        |
| DUPLEX<br>OUT | 1000  | -10   | -11.500    | -8.500   |        |
| DUPLEX<br>OUT | 1000  | -15   | -16.500    | -13.500  |        |
| DUPLEX<br>OUT | 1000  | -20   | -21.500    | -18.500  |        |
| DUPLEX<br>OUT | 1000  | -25   | -26.500    | -23.500  |        |
| DUPLEX<br>OUT | 1000  | -30   | -31.500    | -28.500  |        |
| DUPLEX<br>OUT | 1000  | -35   | -36.500    | -33.500  |        |
| DUPLEX<br>OUT | 1000  | -40   | -41.500    | -38.500  |        |
| DUPLEX<br>OUT | 1000  | -45   | -46.500    | -43.500  |        |
| DUPLEX<br>OUT | 1000  | -50   | -51.500    | -48.500  |        |
| DUPLEX<br>OUT | 1000  | -55   | -56.500    | -53.500  |        |
| DUPLEX<br>OUT | 1000  | -60   | -61.500    | -58.500  |        |
| DUPLEX<br>OUT | 1000  | -65   | -66.500    | -63.500  |        |
| DUPLEX<br>OUT | 1000  | -70   | -71.500    | -68.500  |        |
| DUPLEX<br>OUT | 1000  | -75   | -76.500    | -73.500  |        |
| DUPLEX<br>OUT | 1000  | -80   | -81.500    | -78.500  |        |

Table 9-5 RF Generator Level Accuracy Test 5 Results

| Port          | RF Level Level Limits (MHz) |       |          | ts (dBm) |        |
|---------------|-----------------------------|-------|----------|----------|--------|
|               | (MHz)                       | (авш) | Lower    | Upper    | Actual |
| DUPLEX<br>OUT | 1000                        | -85   | -86.500  | -83.500  |        |
| DUPLEX<br>OUT | 1000                        | -90   | -91.500  | -88.500  |        |
| DUPLEX<br>OUT | 1000                        | -95   | -96.500  | -93.500  |        |
| DUPLEX<br>OUT | 1000                        | -100  | -101.500 | -98.500  |        |
| DUPLEX<br>OUT | 1000                        | -105  | -106.500 | -103.500 |        |
| DUPLEX<br>OUT | 1000                        | -110  | -111.500 | -108.500 |        |
| DUPLEX<br>OUT | 1000                        | -115  | -116.500 | -113.500 |        |
| DUPLEX<br>OUT | 1000                        | -120  | -121.500 | -118.500 |        |
| DUPLEX<br>OUT | 1000                        | -125  | -126.500 | -123.500 |        |
| RF<br>IN/OUT  | 1000                        | -40   | -41.000  | -39.000  |        |
| RF<br>IN/OUT  | 1000                        | -45   | -46.000  | -44.000  |        |
| RF<br>IN/OUT  | 1000                        | -50   | -51.000  | -49.000  |        |
| RF<br>IN/OUT  | 1000                        | -55   | -56.000  | -54.000  |        |
| RF<br>IN/OUT  | 1000                        | -60   | -61.000  | -59.000  |        |
| RF<br>IN/OUT  | 1000                        | -65   | -66.000  | -64.000  |        |
| RF<br>IN/OUT  | 1000                        | -70   | -71.000  | -69.000  |        |
| RF<br>IN/OUT  | 1000                        | -75   | -76.000  | -74.000  |        |

Table 9-5 RF Generator Level Accuracy Test 5 Results

| Port          | RF            | Level           | Level Limits (dBm) |          |        |
|---------------|---------------|-----------------|--------------------|----------|--------|
|               | (MHz)         | (dBm)           | Lower              | Upper    | Actual |
| RF<br>IN/OUT  | 1000          | -80             | -81.000            | -79.000  |        |
| RF<br>IN/OUT  | 1000          | -85             | -86.000            | -84.000  |        |
| RF<br>IN/OUT  | 1000          | -90             | -91.000            | -89.000  |        |
| RF<br>IN/OUT  | 1000          | -95             | -96.000            | -94.000  |        |
| RF<br>IN/OUT  | 1000          | -100            | -101.000           | -99.000  |        |
| RF<br>IN/OUT  | 1000          | -105            | -106.000           | -104.000 |        |
| RF<br>IN/OUT  | 1000          | -110            | -111.000           | -109.000 |        |
| RF<br>IN/OUT  | 1000          | -115            | -116.000           | -114.000 |        |
| RF<br>IN/OUT  | 1000          | -120            | -121.000           | -119.000 |        |
| RF<br>IN/OUT  | 1000          | -125            | -126.000           | -124.000 |        |
| The followi   | ng entries ar | e for the 2 GHz | setup              |          |        |
| DUPLEX<br>OUT | 1700          | -10             | -11.500            | -8.500   |        |
| DUPLEX<br>OUT | 1700          | -15             | -16.500            | -13.500  |        |
| DUPLEX<br>OUT | 1700          | -20             | -21.500            | -18.500  |        |
| DUPLEX<br>OUT | 1700          | -25             | -26.500            | -23.500  |        |
| DUPLEX<br>OUT | 1700          | -30             | -31.500            | -28.500  |        |
| DUPLEX<br>OUT | 1700          | -35             | -36.500            | -33.500  |        |
| DUPLEX<br>OUT | 1700          | -40             | -41.500            | -38.500  |        |

Table 9-5 RF Generator Level Accuracy Test 5 Results

| Port          | RF    | Level | Level Limi |          |        |
|---------------|-------|-------|------------|----------|--------|
|               | (MHz) | (dBm) | Lower      | Upper    | Actual |
| DUPLEX<br>OUT | 1700  | -45   | -46.500    | -43.500  |        |
| DUPLEX<br>OUT | 1700  | -50   | -51.500    | -48.500  |        |
| DUPLEX<br>OUT | 1700  | -55   | -56.500    | -53.500  |        |
| DUPLEX<br>OUT | 1700  | -60   | -61.500    | -58.500  |        |
| DUPLEX<br>OUT | 1700  | -65   | -66.500    | -63.500  |        |
| DUPLEX<br>OUT | 1700  | -70   | -71.500    | -68.500  |        |
| DUPLEX<br>OUT | 1700  | -75   | -76.500    | -73.500  |        |
| DUPLEX<br>OUT | 1700  | -80   | -81.500    | -78.500  |        |
| DUPLEX<br>OUT | 1700  | -85   | -86.500    | -83.500  |        |
| DUPLEX<br>OUT | 1700  | -90   | -91.500    | -88.500  |        |
| DUPLEX<br>OUT | 1700  | -95   | -96.500    | -93.500  |        |
| DUPLEX<br>OUT | 1700  | -100  | -101.500   | -98.500  |        |
| DUPLEX<br>OUT | 1700  | -5    | -106.500   | -103.500 |        |
| DUPLEX<br>OUT | 1700  | -110  | -111.500   | -108.500 |        |
| DUPLEX<br>OUT | 1700  | -115  | -116.500   | -113.500 |        |
| DUPLEX<br>OUT | 1700  | -120  | -121.500   | -118.500 |        |
| DUPLEX<br>OUT | 1700  | -125  | -126.500   | -123.500 |        |

Table 9-5 RF Generator Level Accuracy Test 5 Results

| Port         | RF    |       | Level Limi | Level Limits (dBm) |        |  |
|--------------|-------|-------|------------|--------------------|--------|--|
|              | (MHz) | (dBm) | Lower      | Upper              | Actual |  |
| RF<br>IN/OUT | 1700  | -40   | -41.000    | -39.000            |        |  |
| RF<br>IN/OUT | 1700  | -45   | -46.000    | -44.000            |        |  |
| RF<br>IN/OUT | 1700  | -50   | -51.000    | -49.000            |        |  |
| RF<br>IN/OUT | 1700  | -55   | -56.000    | -54.000            |        |  |
| RF<br>IN/OUT | 1700  | -60   | -61.000    | -59.000            |        |  |
| RF<br>IN/OUT | 1700  | -65   | -66.000    | -64.000            |        |  |
| RF<br>IN/OUT | 1700  | -70   | -71.000    | -69.000            |        |  |
| RF<br>IN/OUT | 1700  | -75   | -76.000    | -74.000            |        |  |
| RF<br>IN/OUT | 1700  | -80   | -81.000    | -79.000            |        |  |
| RF<br>IN/OUT | 1700  | -85   | -86.000    | -84.000            |        |  |
| RF<br>IN/OUT | 1700  | -90   | -91.000    | -89.000            |        |  |
| RF<br>IN/OUT | 1700  | -95   | -96.000    | -94.000            |        |  |
| RF<br>IN/OUT | 1700  | -100  | -101.000   | -99.000            |        |  |
| RF<br>IN/OUT | 1700  | -105  | -106.000   | -104.000           |        |  |
| RF<br>IN/OUT | 1700  | -110  | -111.000   | -109.000           |        |  |
| RF<br>IN/OUT | 1700  | -115  | -116.000   | -114.000           |        |  |
| RF<br>IN/OUT | 1700  | -120  | -121.000   | -119.000           |        |  |

Table 9-5 RF Generator Level Accuracy Test 5 Results

| Port          | RF    | Level | Level Limits (dBm) |          |        |
|---------------|-------|-------|--------------------|----------|--------|
|               | (MHz) | (dBm) | Lower              | Upper    | Actual |
| RF<br>IN/OUT  | 1700  | -125  | -126.000           | -124.000 |        |
| DUPLEX<br>OUT | 2000  | -10   | -11.500            | -8.500   |        |
| DUPLEX<br>OUT | 2000  | -15   | -16.500            | -13.500  |        |
| DUPLEX<br>OUT | 2000  | -20   | -21.500            | -18.500  |        |
| DUPLEX<br>OUT | 2000  | -25   | -26.500            | -23.500  |        |
| DUPLEX<br>OUT | 2000  | -30   | -31.500            | -28.500  |        |
| DUPLEX<br>OUT | 2000  | -35   | -36.500            | -33.500  |        |
| DUPLEX<br>OUT | 2000  | -40   | -41.500            | -38.500  |        |
| DUPLEX<br>OUT | 2000  | -45   | -46.500            | -43.500  |        |
| DUPLEX<br>OUT | 2000  | -50   | -51.500            | -48.500  |        |
| DUPLEX<br>OUT | 2000  | -55   | -56.500            | -53.500  |        |
| DUPLEX<br>OUT | 2000  | -60   | -61.500            | -58.500  |        |
| DUPLEX<br>OUT | 2000  | -65   | -66.500            | -63.500  |        |
| DUPLEX<br>OUT | 2000  | -70   | -71.500            | -68.500  |        |
| DUPLEX<br>OUT | 2000  | -75   | -76.500            | -73.500  |        |
| DUPLEX<br>OUT | 2000  | -80   | -81.500            | -78.500  |        |
| DUPLEX<br>OUT | 2000  | -85   | -86.500            | -83.500  |        |

Table 9-5 RF Generator Level Accuracy Test 5 Results

| Port          | RF    | Level<br>(dBm) | Level Limi |          |        |
|---------------|-------|----------------|------------|----------|--------|
|               | (MHz) |                | Lower      | Upper    | Actual |
| DUPLEX<br>OUT | 2000  | -90            | -91.500    | -88.500  |        |
| DUPLEX<br>OUT | 2000  | -95            | -96.500    | -93.500  |        |
| DUPLEX<br>OUT | 2000  | -100           | -101.500   | -98.500  |        |
| DUPLEX<br>OUT | 2000  | -105           | -106.500   | -103.500 |        |
| DUPLEX<br>OUT | 2000  | -110           | -111.500   | -108.500 |        |
| DUPLEX<br>OUT | 2000  | -115           | -116.500   | -113.500 |        |
| DUPLEX<br>OUT | 2000  | -120           | -121.500   | -118.500 |        |
| DUPLEX<br>OUT | 2000  | -125           | -126.500   | -123.500 |        |
| RF<br>IN/OUT  | 2000  | -40            | -41.000    | -39.000  |        |
| RF<br>IN/OUT  | 2000  | -45            | -46.000    | -44.000  |        |
| RF<br>IN/OUT  | 2000  | -50            | -51.000    | -49.000  |        |
| RF<br>IN/OUT  | 2000  | -55            | -56.000    | -54.000  |        |
| RF<br>IN/OUT  | 2000  | -60            | -61.000    | -59.000  |        |
| RF<br>IN/OUT  | 2000  | -65            | -66.000    | -64.000  |        |
| RF<br>IN/OUT  | 2000  | -70            | -71.000    | -69.000  |        |
| RF<br>IN/OUT  | 2000  | -75            | -76.000    | -74.000  |        |
| RF<br>IN/OUT  | 2000  | -80            | -81.000    | -79.000  |        |

Table 9-5 RF Generator Level Accuracy Test 5 Results

| Port         | RF    | Level | Level Limits (dBm) |          |        |
|--------------|-------|-------|--------------------|----------|--------|
|              | (MHz) | (dBm) | Lower              | Upper    | Actual |
| RF<br>IN/OUT | 2000  | -85   | -86.000            | -84.000  |        |
| RF<br>IN/OUT | 2000  | -90   | -91.000            | -89.000  |        |
| RF<br>IN/OUT | 2000  | -95   | -96.000            | -94.000  |        |
| RF<br>IN/OUT | 2000  | -100  | -101.000           | -99.000  |        |
| RF<br>IN/OUT | 2000  | -105  | -106.000           | -104.000 |        |
| RF<br>IN/OUT | 2000  | -110  | -111.000           | -109.000 |        |
| RF<br>IN/OUT | 2000  | -115  | -116.000           | -114.000 |        |
| RF<br>IN/OUT | 2000  | -120  | -121.000           | -119.000 |        |
| RF<br>IN/OUT | 2000  | -125  | -126.000           | -124.000 |        |

# **RF Generator Harmonics Spectral Purity Performance Test 6 Record**

For test procedure, see "RF Generator Harmonics Spectral Purity Performance Test 6" on page 191.

Table 9-6 RF Generator Harmonics Spectral Purity Test 6 Record

| Level<br>(dBm) | RF Freq<br>(MHz) | Harmonic<br>Number | Harmonic | Limits (dBc) |
|----------------|------------------|--------------------|----------|--------------|
| (abiii)        | (MIIIZ)          | Number             | Upper    | Actual       |
| -10            | 1                | 2nd                | -25.000  |              |
| -10            | 1                | 3rd                | -25.000  |              |
| -10            | 2                | 2nd                | -25.000  |              |
| -10            | 2                | 3rd                | -25.000  |              |
| -10            | 5                | 2nd                | -25.000  |              |
| -10            | 5                | 3rd                | -25.000  |              |
| -10            | 10               | 2nd                | -25.000  |              |
| -10            | 10               | 3rd                | -25.000  |              |
| -10            | 20               | 2nd                | -25.000  |              |
| -10            | 20               | 3rd                | -25.000  |              |
| -10            | 50               | 2nd                | -25.000  |              |
| -10            | 50               | 3rd                | -25.000  |              |
| -10            | 100              | 2nd                | -25.000  |              |
| -10            | 100              | 3rd                | -25.000  |              |
| -10            | 200              | 2nd                | -25.000  |              |
| -10            | 200              | 3rd                | -25.000  |              |
| -10            | 300              | 2nd                | -25.000  |              |
| -10            | 300              | 3rd                | -25.000  |              |
| -10            | 400              | 2nd                | -25.000  |              |
| -10            | 400              | 3rd                | -25.000  |              |
| -10            | 500              | 2nd                | -25.000  |              |
| -10            | 500              | 3rd                | -25.000  |              |
| -10            | 600              | 2nd                | -25.000  |              |
| -10            | 600              | 3rd                | -25.000  |              |

Table 9-6 RF Generator Harmonics Spectral Purity Test 6 Record

| Level<br>(dBm) | RF Freq<br>(MHz) | Harmonic<br>Number |         |        |
|----------------|------------------|--------------------|---------|--------|
| (dBiii)        | (WITZ)           | Number             | Upper   | Actual |
| -10            | 700              | 2nd                | -25.000 |        |
| -10            | 700              | 3rd                | -25.000 |        |
| -10            | 800              | 2nd                | -25.000 |        |
| -10            | 800              | 3rd                | -25.000 |        |
| -10            | 900              | 2nd                | -25.000 |        |
| -10            | 900              | 3rd                | -25.000 |        |
| -10            | 1000             | 2nd                | -25.000 |        |
| -10            | 1000             | 3rd                | -25.000 |        |
| -10            | 1700             | 2nd                | -25.000 |        |
| -10            | 1700             | 3rd                | -25.000 |        |
| -10            | 1800             | 2nd                | -25.000 |        |
| -10            | 1800             | 3rd                | -25.000 |        |
| -10            | 1900             | 2nd                | -25.000 |        |
| -10            | 1900             | 3rd                | -25.000 |        |
| -10            | 2000             | 2nd                | -25.000 |        |
| -10            | 2000             | 3rd                | -25.000 |        |
| -11            | 1                | 2nd                | -25.000 |        |
| -11            | 1                | 3rd                | -25.000 |        |
| -11            | 2                | 2nd                | -25.000 |        |
| -11            | 2                | 3rd                | -25.000 |        |
| -11            | 5                | 2nd                | -25.000 |        |
| -11            | 5                | 3rd                | -25.000 |        |
| -11            | 10               | 2nd                | -25.000 |        |
| -11            | 10               | 3rd                | -25.000 |        |
| -11            | 20               | 2nd                | -25.000 |        |
| -11            | 20               | 3rd                | -25.000 |        |
| -11            | 50               | 2nd                | -25.000 |        |
| -11            | 50               | 3rd                | -25.000 |        |

Table 9-6 RF Generator Harmonics Spectral Purity Test 6 Record

| Level | RF Freq | Harmonic | Harmonic | Limits (dBc) |
|-------|---------|----------|----------|--------------|
| (dBm) | (MHz)   | Number   | Upper    | Actual       |
| -11   | 100     | 2nd      | -25.000  |              |
| -11   | 100     | 3rd      | -25.000  |              |
| -11   | 200     | 2nd      | -25.000  |              |
| -11   | 200     | 3rd      | -25.000  |              |
| -11   | 300     | 2nd      | -25.000  |              |
| -11   | 300     | 3rd      | -25.000  |              |
| -11   | 400     | 2nd      | -25.000  |              |
| -11   | 400     | 3rd      | -25.000  |              |
| -11   | 500     | 2nd      | -25.000  |              |
| -11   | 500     | 3rd      | -25.000  |              |
| -11   | 600     | 2nd      | -25.000  |              |
| -11   | 600     | 3rd      | -25.000  |              |
| -11   | 700     | 2nd      | -25.000  |              |
| -11   | 700     | 3rd      | -25.000  |              |
| -11   | 800     | 2nd      | -25.000  |              |
| -11   | 800     | 3rd      | -25.000  |              |
| -11   | 900     | 2nd      | -25.000  |              |
| -11   | 900     | 3rd      | -25.000  |              |
| -11   | 1000    | 2nd      | -25.000  |              |
| -11   | 1000    | 3rd      | -25.000  |              |
| -12   | 1700    | 2nd      | -25.000  |              |
| -12   | 1700    | 3rd      | -25.000  |              |
| -12   | 1800    | 2nd      | -25.000  |              |
| -12   | 1800    | 3rd      | -25.000  |              |
| -12   | 1900    | 2nd      | -25.000  |              |
| -12   | 1900    | 3rd      | -25.000  |              |
| -12   | 2000    | 2nd      | -25.000  |              |
| -12   | 2000    | 3rd      | -25.000  |              |
|       |         | L        | 1        | 1            |

# **RF Generator Spurious Spectral Purity Performance Test 7 Record**

For test procedure, see "RF Generator Spurious Spectral Purity Performance Test 7" on page 192.

Table 9-7 RF Generator Spurious Spectral Purity Test 7 Record

| Spurious<br>Source | Level<br>(dBm) | RF Freq<br>(MHz) | Spur Freq<br>(MHz) | Spurious S<br>(dBc) | Signal Limits |
|--------------------|----------------|------------------|--------------------|---------------------|---------------|
|                    |                |                  |                    | Upper               | Actual        |
| 3/2 Mixer          | -10            | 242              | 274                | -45.000             |               |
| 3/2 Mixer          | -10            | 247              | 359                | -45.000             |               |
| Supply             | -11            | 100              | 100.03             | -45.000             |               |
| Supply             | -11            | 400              | 400.03             | -60.000             |               |
| Supply             | -11            | 501              | 501.03             | -60.000             |               |
| Supply             | -11            | 1000             | 999.97             | -60.000             |               |
| RF Feedthru        | -11            | 1                | 999                | -45.000             |               |
| LO Feedthru        | -11            | 1                | 1000               | -45.000             |               |
| RF Feedthru        | -11            | 11               | 989                | -45.000             |               |
| RF Feedthru        | -11            | 21               | 979                | -45.000             |               |
| RF Feedthru        | -11            | 41               | 959                | -45.000             |               |
| RF Feedthru        | -11            | 61               | 939                | -45.000             |               |
| RF Feedthru        | -11            | 81               | 919                | -45.000             |               |
| RF Feedthru        | -11            | 91               | 909                | -45.000             |               |
| RF Feedthru        | -11            | 101              | 899                | -45.000             |               |
| RF Feedthru        | -11            | 111              | 889                | -45.000             |               |
| RF Feedthru        | -11            | 121              | 879                | -45.000             |               |
| 3/2 Mixer          | -11            | 242              | 274                | -45.000             |               |
| 3/2 Mixer          | -11            | 247              | 259                | -45.000             |               |
| 4/3 Mixer          | -11            | 242              | 32                 | -45.000             |               |
| 4/3 Mixer          | -11            | 247              | 12                 | -45.000             |               |
| 5/4 Mixer          | -11            | 211              | 55                 | -45.000             |               |
| 5/4 Mixer          | -11            | 217              | 85                 | -45.000             |               |

Table 9-7 RF Generator Spurious Spectral Purity Test 7 Record

| Spurious<br>Source | Level<br>(dBm) | RF Freq<br>(MHz) | Spur Freq<br>(MHz) | Spurious Signal Limits (dBc) |        |
|--------------------|----------------|------------------|--------------------|------------------------------|--------|
|                    |                |                  |                    | Upper                        | Actual |
| 5/4 Mixer          | -11            | 221              | 105                | -45.000                      |        |
| 5/4 Mixer          | -11            | 227              | 135                | -45.000                      |        |
| 5/4 Mixer          | -11            | 231              | 155                | -45.000                      |        |
| 5/4 Mixer          | -11            | 237              | 185                | -45.000                      |        |
| Ref 10 MHz         | -11            | 165              | 175                | -45.000                      |        |
| Ref 1 MHz          | -11            | 150              | 150.2              | -45.000                      |        |
| Ref 1 MHz          | -11            | 150              | 149.8              | -45.000                      |        |
| Ref 1 MHz          | -11            | 150              | 150.4              | -45.000                      |        |
| Ref 1 MHz          | -11            | 150              | 149.6              | -45.000                      |        |
| Ref 1 MHz          | -11            | 150              | 150.6              | -45.000                      |        |
| Reference          | -11            | 150              | 149.4              | -45.000                      |        |
| Signal<br>Feedthru | -10            | 1700             | 1000               | -55.000                      |        |
| Signal<br>Feedthru | -10            | 1700             | 2000               | -55.000                      |        |
| LO Feedthru        | -10            | 1700             | 2700               | -55.000                      |        |
| Signal<br>Feedthru | -10            | 1851             | 800                | -55.000                      |        |
| Signal<br>Feedthru | -10            | 1851             | 1600               | -55.000                      |        |
| LO Feedthru        | -10            | 1851             | 1651               | -55.000                      |        |

### **AF Generator AC Level Accuracy Performance Test 8 Record**

For test procedure, see "AF Generator AC Level Accuracy Performance Test 8" on page 193.

Table 9-8 AF Generator AC Level Accuracy Test 8 Record

| AF        | Frequency | Level | AC Level Li | mits (mV) |        |
|-----------|-----------|-------|-------------|-----------|--------|
| Generator | (Hz)      | (mV)  | Lower       | Upper     | Actual |
| 1         | 25000     | 4000  | 3885.000    | 4115.000  |        |
| 1         | 25000     | 700   | 682.500     | 717.500   |        |
| 1         | 25000     | 75    | 70.000      | 80.000    |        |
| 1         | 10000     | 4000  | 3885.000    | 4115.000  |        |
| 1         | 10000     | 700   | 682.500     | 717.500   |        |
| 1         | 10000     | 75    | 70.000      | 80.000    |        |
| 1         | 1000      | 4000  | 3885.000    | 4115.000  |        |
| 1         | 1000      | 700   | 682.500     | 717.500   |        |
| 1         | 1000      | 75    | 70.000      | 80.000    |        |
| 1         | 100       | 4000  | 3885.000    | 4115.000  |        |
| 1         | 100       | 700   | 682.500     | 717.500   |        |
| 1         | 100       | 75    | 70.000      | 80.000    |        |
| 2         | 25000     | 4000  | 3885.000    | 4115.000  |        |
| 2         | 25000     | 700   | 682.500     | 717.500   |        |
| 2         | 25000     | 75    | 70.000      | 80.000    |        |
| 2         | 10000     | 4000  | 3885.000    | 4115.000  |        |
| 2         | 10000     | 700   | 682.500     | 717.500   |        |
| 2         | 10000     | 75    | 70.000      | 80.000    |        |
| 2         | 1000      | 4000  | 3885.000    | 4115.000  |        |
| 2         | 1000      | 700   | 682.500     | 717.500   |        |
| 2         | 1000      | 75    | 70.000      | 80.000    |        |
| 2         | 100       | 4000  | 3885.000    | 4115.000  |        |
| 2         | 100       | 700   | 682.500     | 717.500   |        |
| 2         | 100       | 75    | 70.000      | 80.000    |        |

## **AF Generator DC Level Accuracy Performance Test 9 Record**

For test procedure, see "AF Generator DC Level Accuracy Performance Test 9" on page 194.

#### Table 9-9 AF Generator DC Level Accuracy Test 9 Record

| AF<br>Generator | Level DC Level Limits (mV) (mV) |          |          |        |  |
|-----------------|---------------------------------|----------|----------|--------|--|
| Generator       | (111 V)                         | Lower    | Upper    | Actual |  |
| 1               | 4000                            | 3820.000 | 4180.000 |        |  |
| 1               | 1000                            | 925.000  | 1075.000 |        |  |
| 2               | 4000                            | 3820.000 | 4180.000 |        |  |
| 2               | 1000                            | 925.000  | 1075.000 |        |  |

## **AF Generator Residual Distortion Performance Test 10 Record**

For test procedure, see "AF Generator Residual Distortion Performance Test 10" on page 195.

**Table 9-10** AF Generator Residual Distortion Test 10 Record

| AF Generator | Frequency (Hz) | Level (mV) | Distortion | Distortion Limits (%) |        |  |
|--------------|----------------|------------|------------|-----------------------|--------|--|
|              |                |            | Lower      | Upper                 | Actual |  |
| 1            | 25000          | 4000       | N/A        | 0.125                 |        |  |
| 1            | 25000          | 2000       | N/A        | 0.125                 |        |  |
| 1            | 25000          | 200        | N/A        | 0.125                 |        |  |
| 1            | 10000          | 4000       | N/A        | 0.125                 |        |  |
| 1            | 10000          | 2000       | N/A        | 0.125                 |        |  |
| 1            | 10000          | 200        | N/A        | 0.125                 |        |  |
| 1            | 1000           | 4000       | N/A        | 0.125                 |        |  |
| 1            | 1000           | 2000       | N/A        | 0.125                 |        |  |
| 1            | 1000           | 200        | N/A        | 0.125                 |        |  |
| 1            | 100            | 4000       | N/A        | 0.125                 |        |  |
| 1            | 100            | 2000       | N/A        | 0.125                 |        |  |
| 1            | 100            | 200        | N/A        | 0.125                 |        |  |
| 2            | 25000          | 4000       | N/A        | 0.125                 |        |  |
| 2            | 25000          | 2000       | N/A        | 0.125                 |        |  |
| 2            | 25000          | 200        | N/A        | 0.125                 |        |  |
| 2            | 10000          | 4000       | N/A        | 0.125                 |        |  |
| 2            | 10000          | 2000       | N/A        | 0.125                 |        |  |
| 2            | 10000          | 200        | N/A        | 0.125                 |        |  |
| 2            | 1000           | 4000       | N/A        | 0.125                 |        |  |
| 2            | 1000           | 2000       | N/A        | 0.125                 |        |  |
| 2            | 1000           | 200        | N/A        | 0.125                 |        |  |
| 2            | 100            | 4000       | N/A        | 0.125                 |        |  |
| 2            | 100            | 2000       | N/A        | 0.125                 |        |  |
| 2            | 100            | 200        | N/A        | 0.125                 |        |  |

## **AF Generator Frequency Accuracy Performance Test 11 Record**

For test procedure, see "AF Generator Frequency Accuracy Performance Test 11" on page 196.

Table 9-11 AC Generator Frequency Accuracy Test 11 Record

| AF Generator | Frequency (Hz) | Frequency Limits (Hz) |           |        |
|--------------|----------------|-----------------------|-----------|--------|
|              |                | Lower                 | Upper     | Actual |
| 1            | 25000          | 24993.750             | 25006.250 |        |
| 1            | 10000          | 9997.500              | 10002.500 |        |
| 1            | 5000           | 4998.750              | 500.125   |        |
| 1            | 2000           | 1999.500              | 2000.500  |        |
| 1            | 1000           | 999.750               | 1000.250  |        |
| 1            | 500            | 499.875               | 500.125   |        |
| 1            | 200            | 199.950               | 200.050   |        |
| 1            | 100            | 99.95                 | 100.025   |        |
| 1            | 50             | 49.988                | 50.012    |        |
| 1            | 20             | 19.995                | 20.005    |        |
| 2            | 25000          | 24993.750             | 25006.250 |        |
| 2            | 10000          | 9997.500              | 10002.500 |        |
| 2            | 5000           | 4998.750              | 500.125   |        |
| 2            | 2000           | 1999.500              | 2000.500  |        |
| 2            | 1000           | 999.750               | 1000.250  |        |
| 2            | 500            | 499.875               | 500.125   |        |
| 2            | 200            | 199.950               | 200.050   |        |
| 2            | 100            | 99.95                 | 100.025   |        |
| 2            | 50             | 49.988                | 50.012    |        |
| 2            | 20             | 19.995                | 20.005    |        |

### **AF Analyzer AC Level Accuracy Performance Test 12 Record**

For test procedure, see "AF Analyzer AC Level Accuracy Performance Test 12" on page 197.

Table 9-12 AC Analyzer AC Voltage Accuracy Test 12 Record

| Frequency (Hz) | Level (mV) | AC Voltage Limits (mV) |          |        |  |
|----------------|------------|------------------------|----------|--------|--|
|                |            | Lower                  | Upper    | Actual |  |
| 15000          | 5000       | 4849.550               | 5150.450 |        |  |
| 2000           | 5000       | 4849.550               | 5150.450 |        |  |
| 200            | 5000       | 4849.550               | 5150.450 |        |  |
| 20             | 5000       | 4849.550               | 5150.450 |        |  |
| 15000          | 500        | 484.550                | 515.450  |        |  |
| 2000           | 500        | 484.550                | 515.450  |        |  |
| 200            | 500        | 484.550                | 515.450  |        |  |
| 20             | 500        | 484.550                | 515.450  |        |  |
| 15000          | 50         | 48.050                 | 51.950   |        |  |
| 2000           | 50         | 4.050                  | 51.950   |        |  |
| 200            | 50         | 48.050                 | 51.950   |        |  |
| 20             | 50         | 48.050                 | 51.950   |        |  |

#### **AF Analyzer Residual Noise Performance Test 13 Record**

For test procedure, see "AF Analyzer Residual Noise Performance Test 13" on page 198.

Table 9-13 AF Analyzer Residual Noise Test 13 Record

| Residual Noise Limits (μV) |     |  |  |  |  |
|----------------------------|-----|--|--|--|--|
| Filter 2 Upper Actual      |     |  |  |  |  |
| 15 kHz LPF                 | 150 |  |  |  |  |
| >99 kHz LP 450             |     |  |  |  |  |

### **AF Analyzer Distortion and SINAD Accuracy Performance Test 14 Record**

For test procedure, see "AF Analyzer Distortion and SINAD Accuracy Performance Test 14" on page 199.

Table 9-14 AF Analyzer Distortion and SINAD AccuracyTest 14 Record

| AF Generator         | AF Generator  2 Level (mV)  Type |            | <b>Distortion and SINAD Limits</b> |           |        |
|----------------------|----------------------------------|------------|------------------------------------|-----------|--------|
| 2 Frequency<br>(kHz) | 2 Level (mV)                     | Туре       | Lower                              | Upper     | Actual |
| 2                    | 100                              | Distortion | 8.856%                             | 11.144%   |        |
| 2                    | 100                              | SINAD      | 19.043 dB                          | 21.043 dB |        |
| 3                    | 100                              | Distortion | 8.856%                             | 11.144%   |        |
| 3                    | 100                              | SINAD      | 19.043 dB                          | 21.043 dB |        |
| 2                    | 10                               | Distortion | 0.890%                             | 1.120%    |        |
| 2                    | 10                               | SINAD      | 39.000 dB                          | 41.000 dB |        |
| 3                    | 10                               | Distortion | 0.890%                             | 1.120%    |        |
| 3                    | 10                               | SINAD      | 39.000 dB                          | 41.000 dB |        |
| 2                    | 5                                | Distortion | 0.445%                             | 0.560%    |        |
| 2                    | 5                                | SINAD      | 45.021 dB                          | 47.021 dB |        |
| 3                    | 5                                | Distortion | 0.445%                             | 0.560%    |        |
| 3                    | 5                                | SINAD      | 45.021 dB                          | 47.021 dB |        |

## **AF Analyzer DC Level Accuracy Performance Test 15 Record**

For test procedure, see "AF Analyzer DC Level Accuracy Performance Test 15" on page 200.

Table 9-15 AF Analyzer DC Level Accuracy Test 15 Record

| AF Generator<br>1 Level | DC Voltage Limits (mV) |          |  | DC Voltage Limits (mV) |  |
|-------------------------|------------------------|----------|--|------------------------|--|
| (mV)                    | Lower Upper Actual     |          |  |                        |  |
| 5000                    | 4905.000               | 5095.000 |  |                        |  |
| 500                     | 450.000                | 550.000  |  |                        |  |

## **AF Analyzer Frequency Accuracy to 100 kHz Performance Test 16 Record**

For test procedure, see "AF Analyzer Frequency Accuracy to 100 kHz Performance Test 16" on page 201.

Table 9-16 AF Analyzer Frequency Accuracy to 100 kHz Test 16 Record

| Frequency (Hz) | Frequency Limits (Hz) |          |        |
|----------------|-----------------------|----------|--------|
|                | Lower                 | Upper    | Actual |
| 20             | 19.896                | 20.104   |        |
| 100            | 99.880                | 100.120  |        |
| 1000           | 999.70                | 1000.30  |        |
| 10000          | 9997.90               | 10002.10 |        |
| 100000         | 99979.9               | 100020.1 |        |

## **AF Analyzer Frequency Accuracy at 400 kHz Performance Test 17 Record**

For test procedure, see "AF Analyzer Frequency Accuracy at 400 kHz Performance Test 17" on page 202.

Table 9-17 AF Analyzer Frequency Accuracy at 400 kHz Test 17 Record

| Frequency Difference Limits (kHz) |       |  |  |
|-----------------------------------|-------|--|--|
| Lower Upper Actual                |       |  |  |
| -0.080                            | 0.080 |  |  |

## Oscilloscope Amplitude Accuracy Performance Test 18 Record

For test procedure, see "Oscilloscope Am p l i t u d e  $\ A\ c\ c\ u\ r\ a\ c\ y\ P\ e\ r\ f\ o\ r\ m\ a\ n\ c\ e\ T\ e\ s\ t\ 1\ 8$ " 203.

Table 9-18 Oscilliscope Amplitude Accuracy Test 18 Record

| Frequency<br>(kHz) | Amplitude Limits (V)  Lower Upper Actual |        |  | Amplitude Limits (V) |  |
|--------------------|--|--------|--|----------------------|--|
| (KIIZ)             |  |        |  |                      |  |
| 1                  | 6.765                                    | 7.377  |  |                      |  |
| 10                 | 6.765                                    | 7.377  |  |                      |  |
| 50                 | 5.000                                    | 10.000 |  |                      |  |

## **RF Analyzer Level Accuracy Performance Test 19 Record**

For test procedure, see "RF Analyzer Level Accuracy Performance Test 19" on page 205.

Table 9-19 RF Analyzer Level Accuracy Test 19

| Frequenc<br>y (MHz) | Level Difference Limits (dB) |       |        |
|---------------------|------------------------------|-------|--------|
| y (MHZ)             | Lower                        | Upper | Actual |
| 30                  | -0.212                       | 0.212 |        |
| 50                  | -0.212                       | 0.212 |        |
| 100                 | -0.212                       | 0.212 |        |
| 150                 | -0.212                       | 0.212 |        |
| 200                 | -0.212                       | 0.212 |        |
| 250                 | -0.212                       | 0.212 |        |
| 300                 | -0.212                       | 0.212 |        |
| 350                 | -0.212                       | 0.212 |        |
| 400                 | -0.212                       | 0.212 |        |
| 450                 | -0.212                       | 0.212 |        |
| 500                 | -0.212                       | 0.212 |        |
| 550                 | -0.212                       | 0.212 |        |
| 600                 | -0.212                       | 0.212 |        |
| 650                 | -0.212                       | 0.212 |        |
| 700                 | -0.212                       | 0.212 |        |
| 750                 | -0.212                       | 0.212 |        |
| 800                 | -0.212                       | 0.212 |        |
| 850                 | -0.212                       | 0.212 |        |
| 900                 | -0.212                       | 0.212 |        |
| 950                 | -0.212                       | 0.212 |        |
| 1000                | -0.212                       | 0.212 |        |
| 1700                | -0.212                       | 0.212 |        |
| 1725                | -0.212                       | 0.212 |        |

Table 9-19 RF Analyzer Level Accuracy Test 19

| Frequenc<br>y (MHz) | Level Difference Limits (dB) |       |        |
|---------------------|------------------------------|-------|--------|
| у (МНZ)             | Lower                        | Upper | Actual |
| 1750                | _                            | 0.212 |        |
|                     | 0.212                        |       |        |
| 1775                | _                            | 0.212 |        |
|                     | 0.212                        |       |        |
| 1800                | _                            | 0.212 |        |
|                     | 0.212                        |       |        |
| 1825                | _                            | 0.212 |        |
|                     | 0.212                        |       |        |
| 1850                | -                            | 0.212 |        |
|                     | 0.212                        |       |        |
| 1875                | _                            | 0.212 |        |
|                     | 0.212                        |       |        |
| 1900                | _                            | 0.212 |        |
|                     | 0.212                        |       |        |
| 1925                | _                            | 0.212 |        |
|                     | 0.212                        |       |        |
| 1950                | _                            | 0.212 |        |
|                     | 0.212                        |       |        |
| 1975                | _                            | 0.212 |        |
|                     | 0.212                        |       |        |
| 2000                | _                            | 0.212 |        |
|                     | 0.212                        |       |        |

## RF Analyzer FM Accuracy Performance Test 20 Record

For test procedure, see "RF Analyzer FM Accuracy Performance Test 20" on page 206.

Table 9-20 RF Analyzer FM Accuracy Test 20 Record

| RF (MHz) | Deviation | Rate FM Deviation Limits (kHz) |        | )      |        |
|----------|-----------|--------------------------------|--------|--------|--------|
|          | (kHz)     | (Hz)                           | Lower  | Upper  | Actual |
| 12.5     | 1         | 50                             | 0.960  | 1.040  |        |
| 12.5     | 1         | 1000                           | 0.960  | 1.040  |        |
| 12.5     | 1         | 25000                          | 0.960  | 1.040  |        |
| 12.5     | 10        | 50                             | 9.600  | 10.400 |        |
| 12.5     | 10        | 1000                           | 9.600  | 10.400 |        |
| 12.5     | 10        | 25000                          | 9.600  | 10.400 |        |
| 400      | 10        | 50                             | 9.600  | 10.400 |        |
| 400      | 10        | 1000                           | 9.600  | 10.400 |        |
| 400      | 10        | 25000                          | 9.600  | 10.400 |        |
| 400      | 17        | 50                             | 16.320 | 17.680 |        |
| 400      | 17        | 1000                           | 16.320 | 17.680 |        |
| 400      | 17        | 25000                          | 16.320 | 17.680 |        |

## **RF Analyzer FM Distortion Performance Test 21 Record**

For test procedure, see "RF Analyzer FM Distortion Performance Test 21" on page 208.

Table 9-21 RF Analyzer FM Distortion Test 21 Record

| FM Deviation (kHz) | FM Distortion Limits (%) |        |
|--------------------|--------------------------|--------|
|                    | Upper                    | Actual |
| 5                  | 1.000                    |        |
| 25                 | 1.000                    |        |
| 75                 | 1.000                    |        |

## RF Analyzer FM Bandwidth Performance Test 22 Record

For test procedure, see "RF Analyzer FM Bandwidth Performance Test 22" on page 210.

Table 9-22 RF Analyzer FM Bandwidth Test 22 Record

| FM Deviation Difference Limits (dB) |  |  |
|-------------------------------------|--|--|
| Upper Actual                        |  |  |
| 3.0                                 |  |  |

## RF Analyzer Residual FM Performance Test 23 Record

For test procedure, see "RF Analyzer Residual FM Performance Test 23" on page 212.

Table 9-23 RF Analyzer Residual FM Test 23 Record

| FM Deviation Limits (Hz) |  |  |
|--------------------------|--|--|
| Upper Actual             |  |  |
| 7.0                      |  |  |

## **Spectrum Analyzer Image Rejection Performance Test 24 Record**

For test procedure, see "Spectrum Analyzer Image Rejection Performance Test 24" on page 213.

Table 9-24 Spectrum Analyzer Image Rejection (Image) Test 24 Record

| RF Generator       | Spectrum                       | Image Response Limits (dB) |        |
|--------------------|--------------------------------|----------------------------|--------|
| Frequency<br>(MHz) | Analyzer<br>Frequency<br>(MHz) | Upper                      | Actual |
| 613.6              | 385.0                          | -50                        |        |
| 873.6              | 645.0                          | -50                        |        |
| 883.6              | 655.0                          | -50                        |        |
| 1023.6             | 795.0                          | -50                        |        |
| 1000.0             | 771.4                          | -50                        |        |
| 576.4              | 805.0                          | -50                        |        |
| 771.4              | 1000.0                         | -50                        |        |
| 319.02             | 300.0                          | -50                        |        |

Table 9-25 Spectrum Analyzer Image Rejection (Image) Test 24

| Spectrum Analyzer<br>Center Frequency<br>(MHz) | Residual Response Limits (dBm) |        |  |
|--|--------------------------------|--------|--|
| (MIIIZ)  | Upper                          | Actual |  |
| 5.534  | -70                            |        |  |
| 10.0   | -70                            |        |  |
| 20.0   | -70                            |        |  |
| 21.4   | -70                            |        |  |
| 107.126  | -70                            |        |  |
| 164.28   | -70                            |        |  |
| 257.139  | -70                            |        |  |
| 271.4  | -70                            |        |  |
| 347.607  | -70                            |        |  |
| 500.0  | -70                            |        |  |

## **TDMA Generator Modulation Accuracy Performance Test 25 Record**

For test procedure, see TDMA Generator Modulation Accuracy Performance Test 25.

Table 9-26 TDMA Generator Modulation Accuracy Test 25 Record

| RF (MHz) | Measurement        | Units   | Measurement Value |        |
|----------|--------------------|---------|-------------------|--------|
|          |                    |         | Lower<br>Limit    | Actual |
| 859      | EVM                | % rms   | 3                 |        |
| 859      | Magnitude<br>Error | % rms   | 3                 |        |
| 859      | Phase Error        | Degrees | 3                 |        |
| 859      | IQ Offset          | dBc     | -30               |        |
| 1,880    | EVM                | % rms   | 3                 |        |
| 1,880    | Magnitude<br>Error | % rms   | 3                 |        |
| 1,880    | Phase Error        | Degrees | 3                 |        |
| 1,880    | IQ Offset          | dBc     | -30               |        |

## TDMA Analyzer Modulation Accuracy Performance Test 26 Record

For test procedure, see TDMA Analyzer Modulation Accuracy Performance Test 26.

Table 9-27 TDMA Analyzer Modulation AccuracyTest 26 Record

| RF (MHz) | Measurement | Units | Measurement Value |                |        |
|----------|-------------|-------|-------------------|----------------|--------|
|          |             |       | Upper<br>Limit    | Lower<br>Limit | Actual |
| 880      | EVM         | % rms | 0.42              | -0.42          |        |
| 1,960    | EVM         | % rms | 0.42              | -0.42          |        |

# **TDMA Analyzer Channel Power Level Accuracy Performance Test 27 Record**

For test procedure, see "TDMA Analyzer Channel Power Level Accuracy Performance Test 27" on page 219.

Table 9-28 TDMA Analyzer Channel Power Level Accuracy Test 27

| RF      | Measurin<br>g Receiver<br>Level<br>(dBm) | Measured Level Limits (dBm) |        | Bm)    |
|---------|--|-----------------------------|--------|--------|
| (MHz)   |  | Lower                       | Upper  | Actual |
| 881.52  | 11                                       | 10.25                       | 11.75  |        |
| 881.52  | 6  | 5.25                        | 6.75   |        |
| 881.52  | 1  | 0.25                        | 1.75   |        |
| 881.52  | _  | -4.75                       | -3.25  |        |
|         | 4  |                             |        |        |
| 881.52  | -9                                       | -9.75                       | -8.25  |        |
| 881.52  | -14                                      | -14.75                      | -13.25 |        |
| 881.52  | -19                                      | -19.75                      | -18.25 |        |
| 1931.25 | 11                                       | 10.25                       | 11.75  |        |
| 1931.25 | 6  | 5.25                        | 6.75   |        |
| 1931.25 | 1  | 0.25                        | 1.75   |        |
| 1931.25 | -4                                       | -4.75                       | -3.25  |        |
| 1931.25 | -9                                       | -9.75                       | -8.25  |        |
| 1931.25 | -14                                      | -14.75                      | -13.25 |        |
| 1931.25 | -19                                      | -19.75                      | -18.25 |        |

### **CDPD Performance Test 28 Record**

For test procedure, see "CDPD Performance Test 28" on page  $\,$  221.

**Table 9-29 CDPD Generator Spectral Purity Measurement** 

| Channel Power                           | Upper Limit (dBc) | Measured Spectral<br>Purity Actual (dBc) |
|---|-------------------|--|
| Adjacent Channel<br>Power (Adj Pwr dBc) | -26               |  |
| First Alternate Channel (Alt Pwr dBc)   | -45               |  |
| Second Alternate Channel (A12 Pwr dBc)  | -60               |  |

#### **Table 9-30 CDPD Modulation Accuracy Measurement**

| Upper Limit | Lower Limit | Modulation Index<br>(Mod Index) |
|-------------|-------------|---------------------------------|
| 0.525       | 0.475       |                                 |

#### Table 9-31 CDPD Generator On/Off Level Measurement

| Measured Values |           | Calculated Value (dB)                             |             |
|-----------------|-----------|---|-------------|
| ON POWER        | OFF POWER | ON/OFF<br>DIFFERENTIA<br>L <sup>a</sup><br>Actual | Lower Limit |
|                 |           |   |             |

a. ON POWER

OFF POWER = ON/OFF DIFFERENTIAL

## 10 Block Diagrams

This chapter contains block diagrams and descriptions that focus on how the Test Set generates signals and makes measurements. It also has I/O signal information that can be used to help isolate a problem to the assembly level if the Test Set's diagnostic programs are unable to do so.

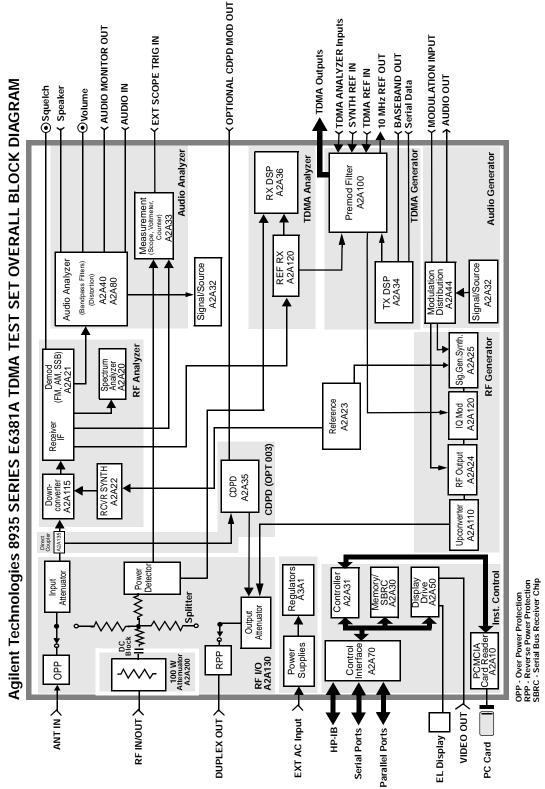
#### Introduction

Shown in figure 10-1 on page 275 is a block-diagram overview of the Test Set. This chapter is organized into the following sections which provide a detailed view of each individual assembly shown in the overview:

- RF Input/Output (see 10-2)
- RF Analyzer (see 10-5)
- Spectrum Analyzer (see 10-6)
- Audio Analyzer (see 10-7 and 10-8)
- Audio Generator (see 10-10)
- RF Generator (see 10-13, 10-14, and 10-15)
- Reference/Regulator (see 10-17 and 10-18)
- Instrument Control (seeFigure 10-19 and Figure 10-20)
- TDMA
- CDPD (OPTION 003)

Input/output and switch information is included to help you determine if voltages and signals are getting to the assemblies with the proper levels, shapes, and frequencies. Line names and connector pin numbers are given on the block diagrams when applicable.

Figure 10-1 Test Set Overview Block Diagram



### **RF Input/Output Section**

#### **RF Power Measurement**

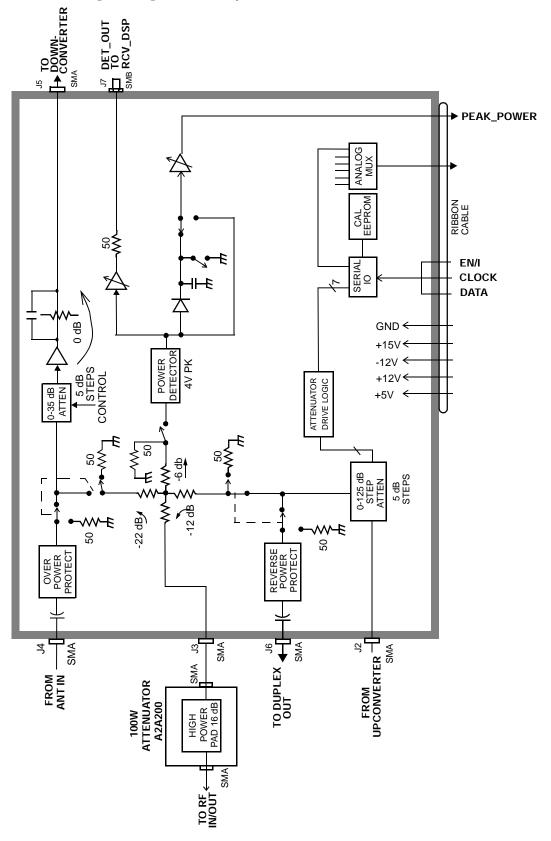
An RF power measurement can only be made by supplying a signal to the RF IN/OUT port of the Test Set. See figure 10-2 on page 277. A power splitter then splits the signal between an RF analysis path and a power measurement path. The power detector has a direct path to the A2A36 Receive DSP where average power measurements are made. There's also a diode peak detector to provide a peak power measurement through the A2A33 Measurement assembly.

Accuracy is insured by factory-generated calibration data which is stored in CAL ROM. The A2A200 100W-attenuator also has calibration data which affects RF power measurements.

#### **Input Gain Control**

Step attenuators in the A2A130 Input/Output Section are switched in and out, manually or automatically. This keeps the input level within an optimum range for the mixers, IF amplifiers, and detectors.

Figure 10-2 RF Input/Output Assembly, A2A130



### **RF Analyzer Section**

#### **Frequency Conversion**

The A2A115 Downconverter, see figure 10-3 on page 279, produces an IF of 114.3, 385.7 or 614.3 MHz. The LO is provided by the A2A22 Receiver Synthesizer, see figure 10-4 on page 280. The IF frequencies developed are as follows in table 10-1.

Table 10-1 IF Frequencies

| Input RF (MHz) | 1st LO (MHz)     | IF (MHz) |
|----------------|------------------|----------|
| 0 to 385.7     | 614.7 to 1000    | 614.3    |
| 385.7 to 800   | 500 to 914.3     | 114.3    |
| 800 to 1000    | 685.7 to 885.7   | 114.3    |
| 1400 to 2200   | 1014.3 to 1814.3 | 385.7    |

Filters are automatically switched in to remove image and other interfering signals. The frequency ranges of the filters are as follows:

- 150 MHz low-pass
- 150 MHz 386 MHz bandpass
- 350 MHz 650 MHz tunable bandpass
- 650 MHz 1000 MHz tunable bandpass
- 1400 MHZ 2200 MHz tunable bandpass

#### **Modulation Measurement**

The A2A21 Receiver assembly demodulates the IF into its FM, AM, and SSB components, see figure 10-5 on page 281. The demodulated signal is sent to the Audio Analyzer section for measurement.

#### **Spectrum Analysis**

The LO on the A2A20 Spectrum Analyzer is swept across the span by the Controller, see figure 10-6 on page 282. The LO starts sweeping when the oscilloscope circuits on the A2A33 Measurement board trigger the display sweep to start. As the LO sweeps, the spectrum analyzer filters and then amplifies the IF signal in a logarithmic detector so the signal voltage will be proportional to the log of power. The signal voltage is measured by a sampler on the Measurement board and displayed.

Spectrum analyzer resolution bandwidth is determined by switching bandwidth IF filters on the A2A20 Spectrum Analyzer. These filters are set by the Controller as a function of the span selected from the front panel.

Figure 10-3 Downconverter Assembly, A2A115

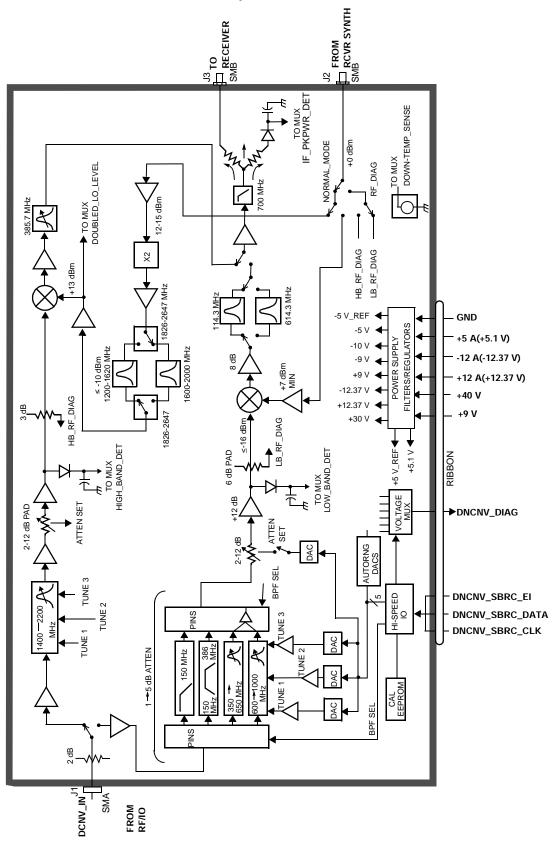


Figure 10-4 Receiver Synthesizer Assembly, A2A22

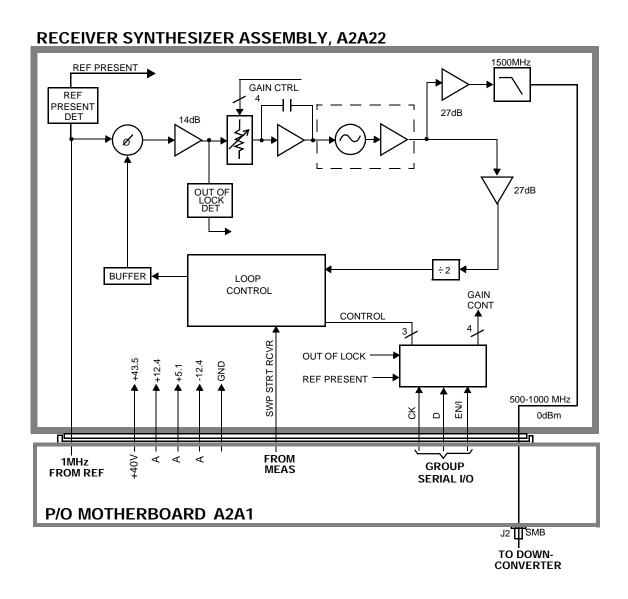


Figure 10-5 Receiver Assembly, A2A21

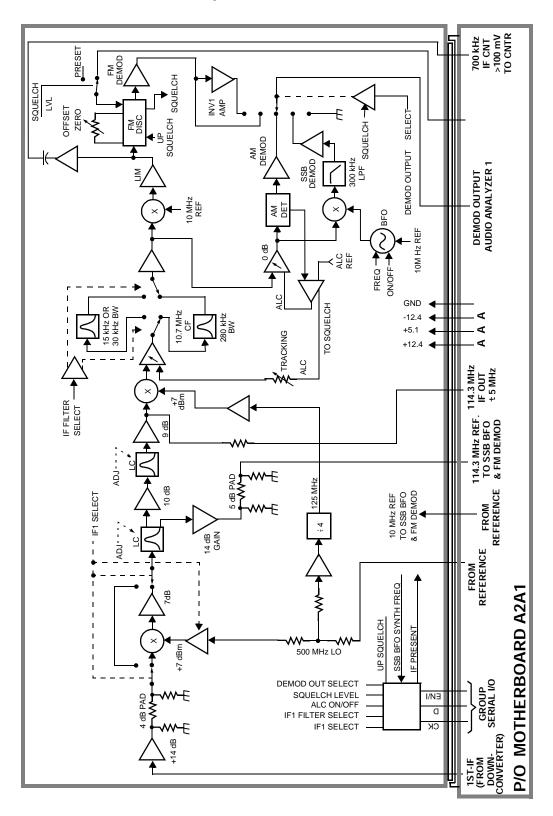
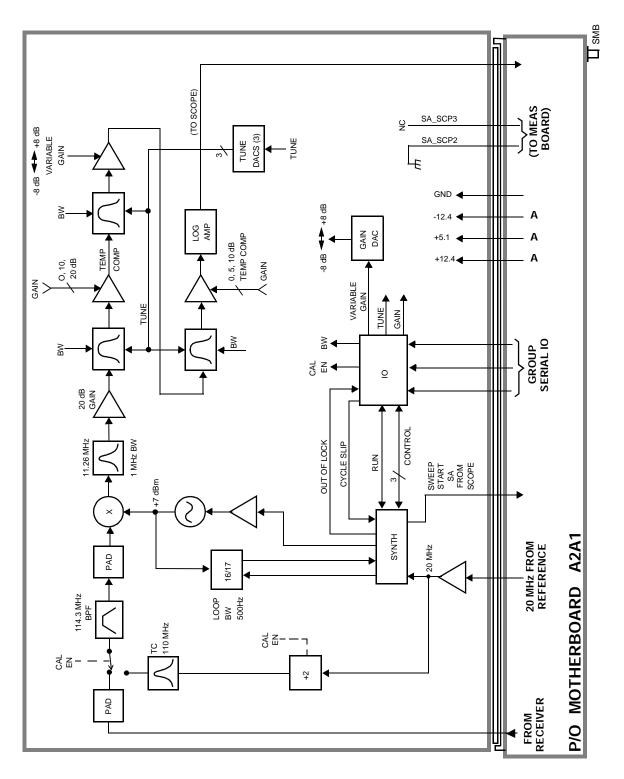


Figure 10-6 Spectrum Analyzer Assembly, A2A20



#### **Audio Analyzer Section**

#### **Input Level Control**

Switchable gain amplifiers on the A2A80 Audio Analyzer #1 (see figure 10-7 on page 284) and A2A40 Audio Analyzer #2 (see figure 10-8 on page 285) assemblies keep the audio input signal within a range suitable for the detectors.

#### **AC and DC Level Measurements**

Detected voltages from the Peak+, Peak –, and RMS detectors are measured on the A2A33 Measurement assembly. The Controller calculates the displayed value taking into account the detector selected from the front panel, the gain of the amplifiers, and the source of the input signal (demodulators, front panel).

#### **Distortion and SINAD Measurements**

Distortion and SINAD can be measured on 300 Hz to 10 kHz audio signals. The Controller calculates distortion and SINAD by comparing the ratio of the voltage after the variable notch filter to the ratio of the voltage before the notch filter.

#### **Oscilloscope Functions**

The Test Set has no specialized oscilloscope assemblies. The A2A80 and A2A40 Audio Analyzer assemblies, A2A33 Measurement assembly (see figure 10-9 on page 286), and the Controller work together to perform the oscilloscope functions.

The audio signal to be displayed goes from the A2A40 Audio Analyzer 2 assembly to a sampler on the A2A33 Measurement assembly (the same sampler used by the Spectrum Analyzer). The Controller calculates the display level by taking the value of the measured signal at each point of the sweep, the gain of the signal path in the Audio Analyzer assemblies, and the volts-per-division setting.

The oscilloscope's trigger signals from the side-panel connector, the A2A32 Signaling Source/Analyzer assembly (figure 10-10 on page 287), and the internal trigger signal are used by the A2A33 Measurement assembly and the Controller to determine when to start the scope sweep. The Controller adds the pre-triggering time entered from the front panel.

Figure 10-7 Audio Analyzer 1, A2A80

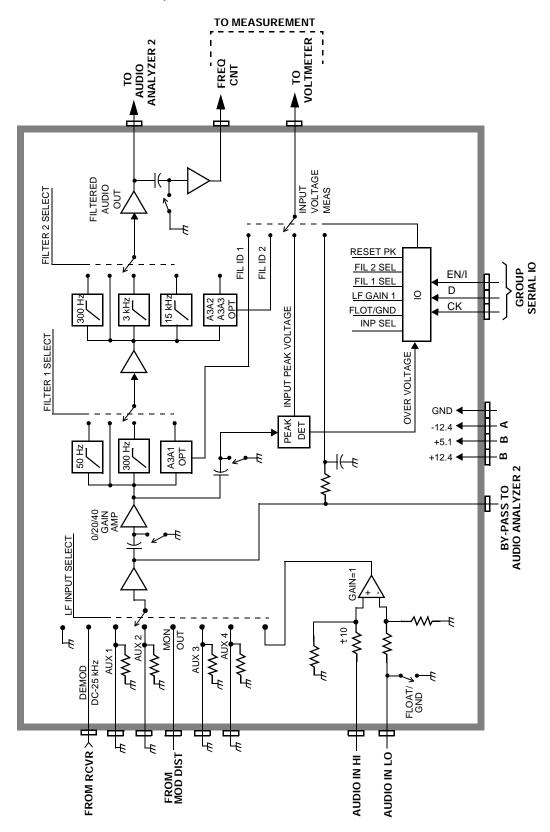


Figure 10-8 Audio Analyzer 2, A2A40 BEEP FROM CONTROLLER SCOPE MONITOR OUT RONT PANEL KEYBOARD VOLUME KEYBOARD SPKR 80hms HI/LOW BEEP TO SCOPE BEEP/ AUDIO ALC/ THRU ALC TO SIGNAL ANAL DE-EMP AUDIO MEAS TO VOLTMETER TO MEAS DC MEAS. PRE-NOTCH RMS POST NOTCH TIME ANALYZED AUDIO OUT SELECT AUDIO MEASUREMENT SELECT 100 W **NEG PEAK** POS PEAK VOLTAGE OUT -PEAK 0/10/20/30/40 dB TIME FREQ. NOTCH VARIABLE RMS BEEP - VOLUME OFF SETTLE SERIAL I/O GND ◀ -12.4 +5.1 PEAK DET. SELECT— 0/10/20/30 +12.4 **◆ GROUP SERIAL I/O** EN/I 0/20 dB/40 dB 100 kHz PEAK <u>o</u> CK EXP SEL 212 Hz PK DET SEL FROM AUDIO HANALYZER 1

Figure 10-9 Measurement Assembly, A2A33

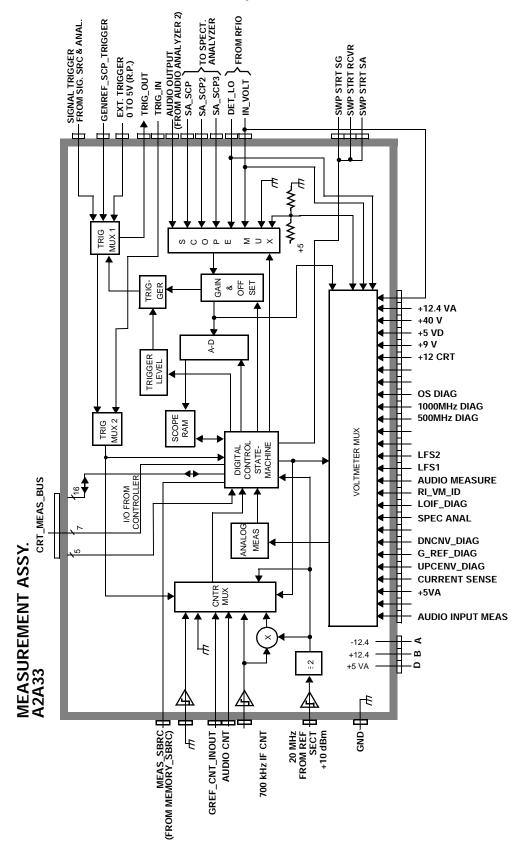
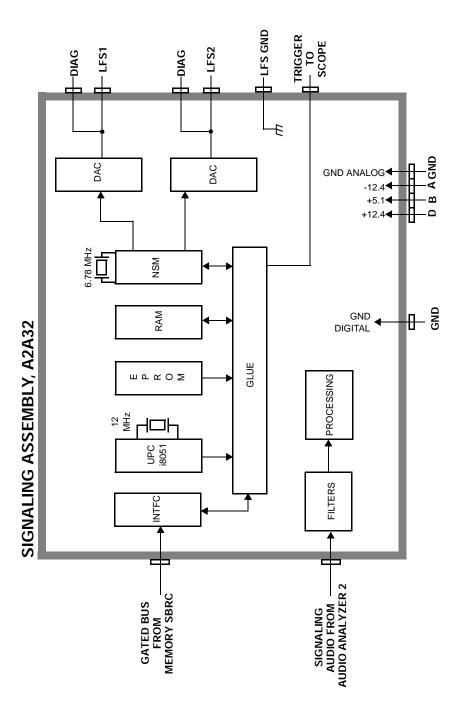


Figure 10-10 Signaling Assembly, A2A32



#### **Audio Generator Section**

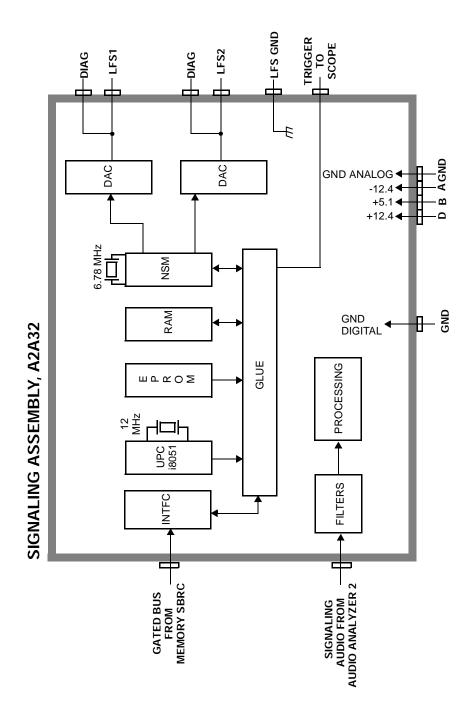
#### **Waveform Generation**

The A2A32 Signaling assembly, see figure 10-11 on page 289, obtains frequency and wave shape information from the A2A31 DCU assembly. Waveform values are calculated real-time by a digital waveform synthesis IC. The LFS1 output is always a sine-wave. The LFS2 output is a sine-wave unless one of the function generator waveforms is selected, or signaling is selected from the front panel.

#### **Level Control**

Audio level is controlled by the A2A44 Modulation Distribution assembly, see figure 10-12 on page 290, by using a DAC and variable attenuators. The leveled audio signal is passed on to the RF Generator section.

Figure 10-11 Signaling Assembly, A2A32



MON OUT TO AUDIO ANALYZERS AUDIO OUT (SIDE PANEL) AM MOD
TO
OUTPUT
SECTION FM MOD TO SIG GEN SYNTH <1W Z OUT S.P. GND S.P. AUDIO OUT DC\_AM FM MOD POLARITY AUDIO AC/DC Ā GNDD ◀ AUDIO MONITOR SELECT-GNDA ▼ TO MIC ON/OFF (MIC AMPL) AUD (1, 0.01, 0) OUT LVL2 В +5.1 AUD OUT **B +**12.4 **◀** (1, 0.01, 0) MOD SELECT (1, 0.1) MOD LVL1 XMTR KEY LFS2 LVL (1, 0.1) (1, 0.1)LFS1 LVL **AUD MON SEI** LFS2 LVL0 MOD LVLO LFS2 LVL0 MOD LVL DAC DAC DAC 9-ŘE OUT**◆** EN/I GROUP SERIAL I/O 0 СК Ž≅ MIC ON/OFF -PRE-EMP11 AÇ/DC LFS1,2 LVLO.1 AUD OUT LVL AC/DC ₩<del>-</del>[ MIC AUDIO INPUT LFS2 (FROM SIGNALING SOURCE) LFS — L GND GND (FROM SIGNALING SOURCE) MODULATION INPUT (SIDE PANEL)

Figure 10-12 Modulation Distribution Assembly, A2A44

#### **RF Generator Section**

#### **Frequency Generation**

The A2A25 Signal Generator Synthesizer (figure 10-13 on page 293) develops a 500 MHz to 1000 MHz signal which is phase-locked to the 200 kHz reference from the A2A23 Reference Assembly (figure 10-17 on page 298). An out-of-lock indicator LED lights if the phase-lock-loop is out-of-lock. When you turn the Test Set's power on, the LED lights for a few seconds then goes out. If it stays on or comes on again, the loop is out-of-lock.

The A2A24 Output Section assembly (figure 10-15 on page 295) develops the RF Generator's 0.4 to 1000 MHz frequency range by mixing, dividing, or passing the 500 MHz to 1000 MHz from the Signal Generator Synthesizer. The frequencies are derived as shown in table 10-2.

The A2A110 Upconverter assembly (figure 10-16 on page 296) develops the RF generator's 1.2 to 2.0 GHz range by mixing the 800-1000 MHz signal from the output section with a 1.5-3.0 GHz LO.

Table 10-2 IF Frequencies

| Output Frequency  | Derivation |
|-------------------|------------|
| 400 kHz - 250 MHz | mix        |
| 250 MHz - 500 MHz | divide     |
| 500 MHz - 1 GHz   | pass       |
| 1.7 GHz - 2.0 GHz | mix        |

#### **Level Control**

The A2A44 Output Section assembly (figure 10-15 on page 295) has an automatic-level-control (ALC) loop that acts as a vernier control of RF level between -2 and +9 dBm. A step attenuator in the A2A130 RF Input/Output assembly takes the level down to -127 dBm (-137 dBm at the RF IN/OUT connector) in 5 dB steps.

Assemblies that affect output level calibration have factory-generated calibration data stored in the Test Set's EEPROM. Calibration data is fed to the digital-to-analog-converters which control level-adjustable devices in the RF path. These assemblies are:

- A2A200 100W Attenuator
- A2A130 RF Input/Output
- A2A24 Output Section

#### **Modulation**

Amplitude modulation (AM) is done on the A2A24 Output Section assembly. The modulating signal from the A2A44 Modulation Distribution assembly is applied to the ALC loop's control voltage.

IQ modulation is done on the A2A120 LO IF/IQ Modulator assembly (see figure 10-14 on page 294). The IQ signal from the A2A34 Data Buffer is modulated onto the RF signal from the A2A25 Signal Generator Synthesizer assembly.

CW RF IN ◆ ACFM/DCFM ► FM ON/OFF 1500MHz EN/I OUT OF BAND FM CONT SERIAL I/O D OUT OF BAND FM DATA 500-1000MHz <u>o</u> GAIN CONT СК 32/33/36/37 CYCLE SLIP OUT OF LOCK REF PRESENT NF CONT NF RUN MODULUS CONT **→** CYCLE CONT SIGNAL GENERATOR SYNTHESIZER ASSEMBLY, A2A25 ₹ SWEEP START SIG GEN MOD SIGN HN+ INTERFACE GND SDFM P10 CNTRI : OUT +5.1 OUT OF BAND FM +12.4 OUT-OF-LOCK GAIN CTRL +40 V OUT OF LOCK A-D **MOTHERBOARD A2A1** ₩ FM CONT OUT OF BAND OUT OF BAND FM DAC FM MOD FROM MOD DISTR 4V=100 KHZ DC - 25 KHZ Z OUT < 10W M FM DAC OUT OF BAND SEC (CMOS) FROM REF DELAY COMPENSATION FILTER REF PRESENT REF PRESENT DET P/0

Figure 10-13 Signal Generator Synthesizer Assembly, A2A25

Figure 10-14 IQ Modulator (Part of IQ Modulator/REF RCVR Assembly), A2A120

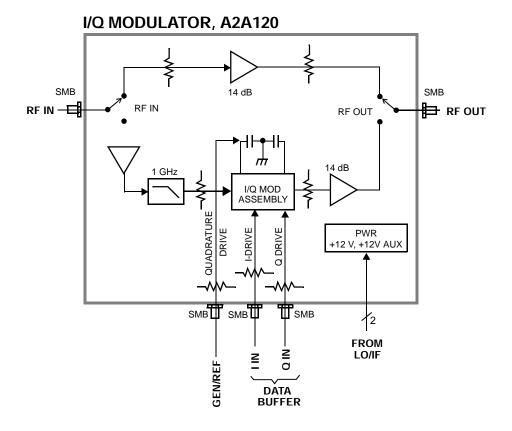


Figure 10-15 RF Output Assembly, A2A24

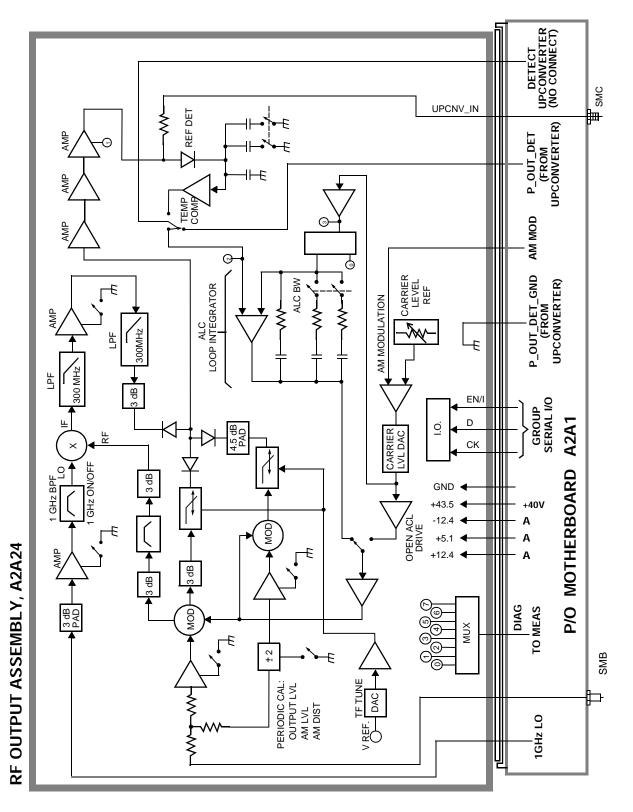
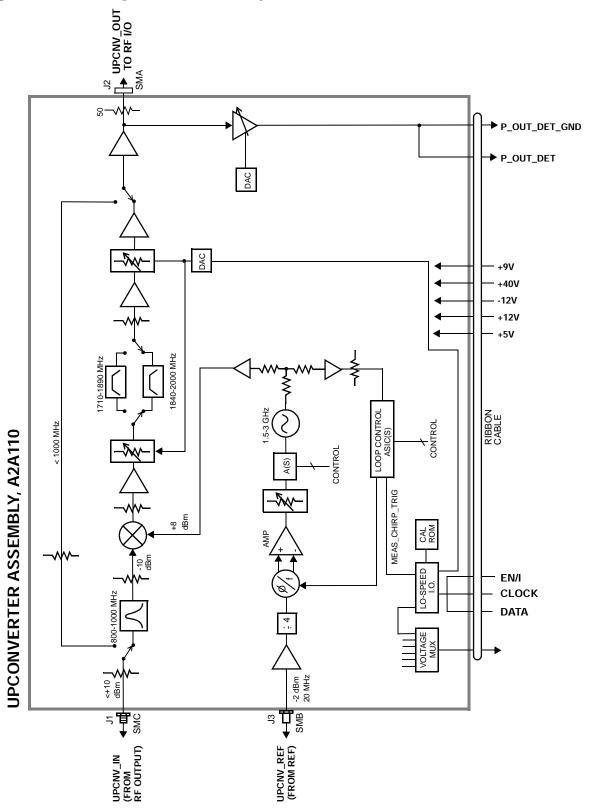


Figure 10-16 Upconverter Assembly, A2A110



## **Reference/Regulator Section**

#### Reference

All frequencies are derived from a 10 MHz reference which can come from an external reference or from a 10 MHz crystal oscillator on the A2A23 Reference assembly (see figure 10-17 on page 298). The Reference assembly develops the local oscillator (LO) and reference signals needed by the assemblies that make up the RF generator, RF analyzer, spectrum analyzer, and the A2A33 Measurement assembly. The Reference assembly includes an oven controlled high stability timebase crystal oscillator, or a rubidium oscillator (OPTION AY5).

## **Power Supply Regulators**

Power supply regulators are distributed to all of the modules and assemblies by the A3A1 Power Supply Regulator assembly (see figure 10-18 on page 299) through the motherboard.

## **Power Supply**

The A3A2 Power Supply assembly is a switching type supply. The power supply generates five different dc supplies. They are:

- +5.5 Vdc
- +13.4 Vdc
- −13.4 Vdc
- +43.5 Vdc
- −12 Vdc AUX

Power Supply voltages are distributed to all of the modules and assemblies through the motherboard.

T0 0CX0 +12V AUX 1000 MHz ON/OFF DIAG LO 1000MHz LO 500MHz 42 DIAG 1GHz (2 DACS ADJUST) OSC FREQ 1000 MHz ON/OFF OUT-OF-LOCK 1GHz VCO +20 <u>o</u> X2 FREQ DOUBLER 10-20MHz 7dBm MIN PANEL TO SIDE 10MHz 10MHz HIGH STABILITY REFERENCE ASSEMBLY, A2A23 TO SA UPCONVERTER REF 20MHz COUNTER 20MHz TO +10/ OUT-OF-LOCK OVERRIDE **EXT REF** CMOS 1MHz RCVR SYNTH REF SYN RCVR CMOS REF **A2A1** SG OCK > 5K OFF 10M (RCVR) < -110 dBc > 5 kHz .20M +10M REFS OUT: ARE < -90dBc SPURS GND ◀ FREQ P/O MOTHERBOARD 500 kHz HPF +5.1 2 DACS ADJUST 10 MHz REF IN 10MHz REF IN (GENREF)

Figure 10-17 High Stability Reference Assembly, A2A23

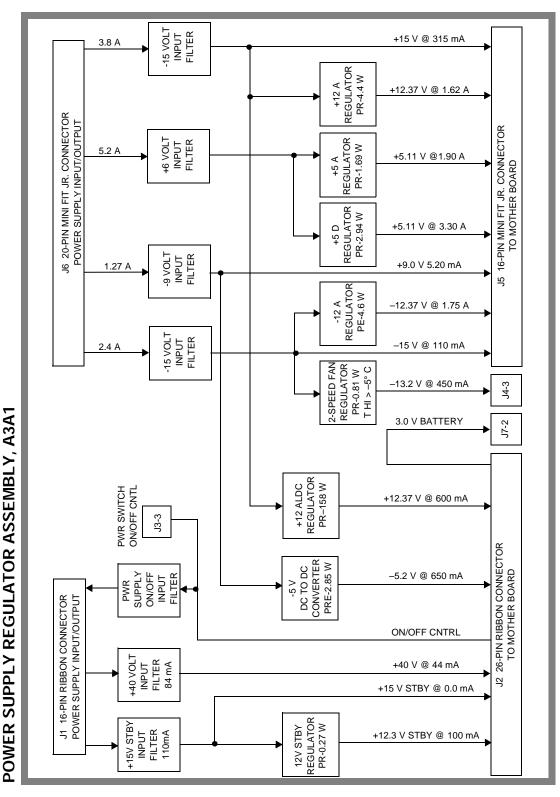


Figure 10-18 Power Supply Regulator Assembly, A3A1

#### **Test Set Control Section**

## **Digital Control**

The Test Set's Digital Control is driven by two assemblies:

- A2A30 Memory/SBRC (see figure 10-19 on page 301)
- A2A31 Digital Controller Unit (DCU) (see figure 10-20 on page 302)

The DCU receives user control information by either the A2A70 Control Interface or by the front panel. Operating firmware on the A2A30 Memory/SBRC is then used by the A2A31 DUC to generate digital control for the Test Set. The digital control bus information is passed back to the A2A30 Memory/SBRC which controls most of the Test Set's modules and assemblies.

## **Display**

The Test Set's Display data is first generated by the DCU and then passed on to the A20 CRT drive. The A20 CRT drive converts the digital information into analog vertical and horizontal drive signals for the A22 CRT display. The A20 CRT drive also provides brightness and contrast signals for the A22 CRT display.

Figure 10-19 Memory/SBRC Assembly, A2A30

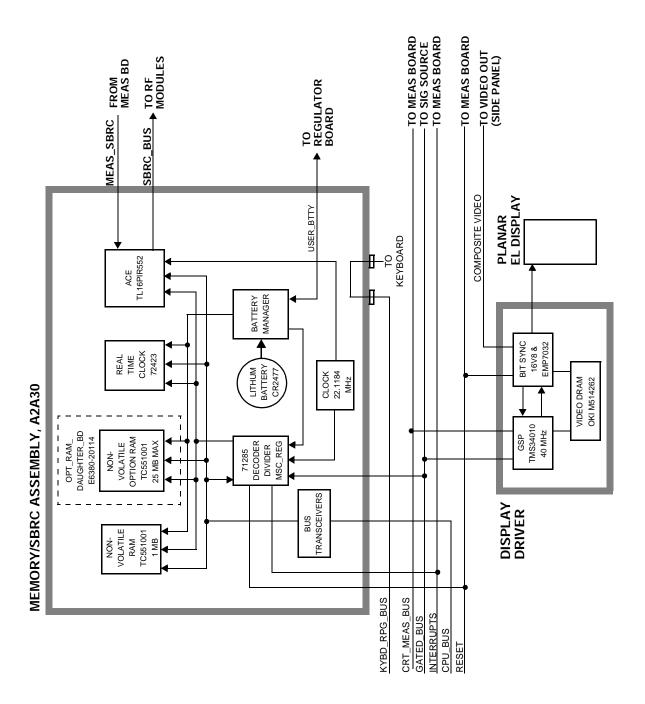
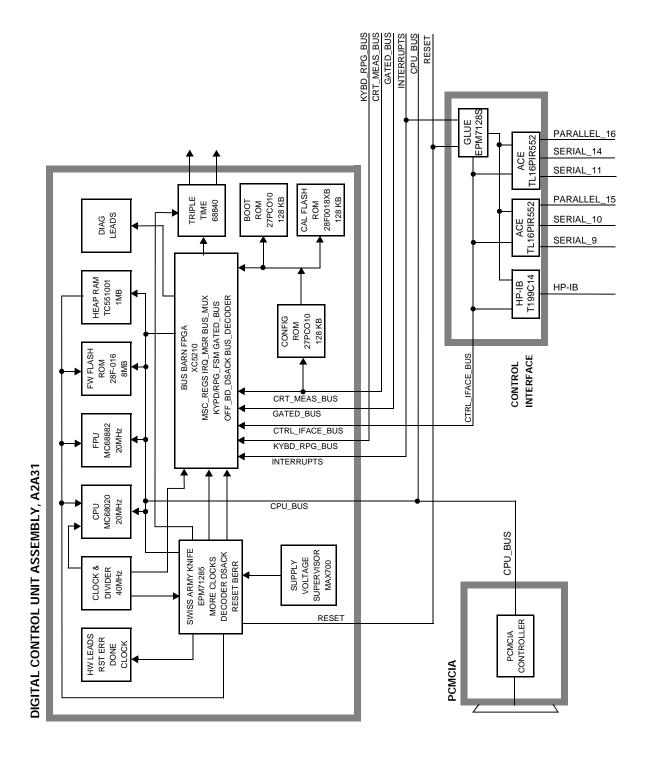


Figure 10-20 Digital Controller Unit Assembly, A2A31



## **TDMA**

The Test Set includes Time Division Multiple Access (TDMA) digital signal processing hardware and firmware to test the transmitter and receiver portions of TDMA base stations (see figures 10-21, 10-22, 10-23, and 10-24). TDMA permits the selective addition of I/Q Modulation to the Test Set's RF output to accommodate the TDMA format. TDMA functions include I/Q demodulation and analysis capability, I/Q encoding and modulation, and timing generation and synchronization.

## **TDMA Analysis**

The analysis is accomplished by downconverting a 114.3 MHz IF signal from the Test Set to 700 kHz for processing by the DSP board.

#### **TDMA Generation**

The Test Set generates digital data with the transmit DSP board, encodes the data using p/4 DQPSK, and then modulates the signal using the I/Q modulator before sending the signal to the output. The Test Set will lock to several different time base reference frequencies. For instance, it can lock to the base station or to another external reference.

Figure 10-21 Transmit DSP, A2A34

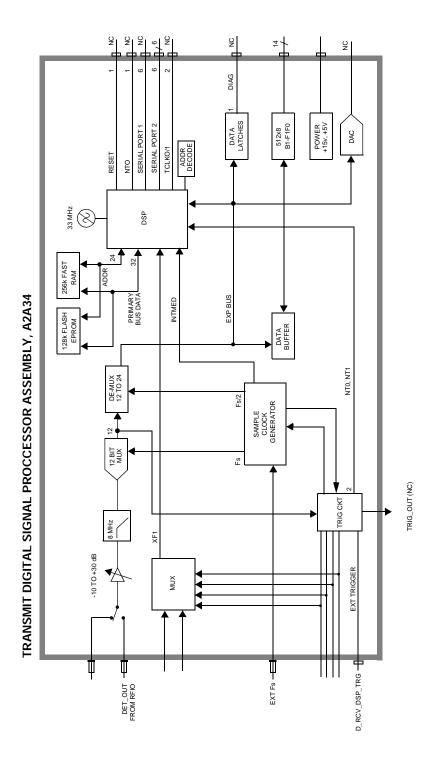


Figure 10-22 Receive DSP, A2A36

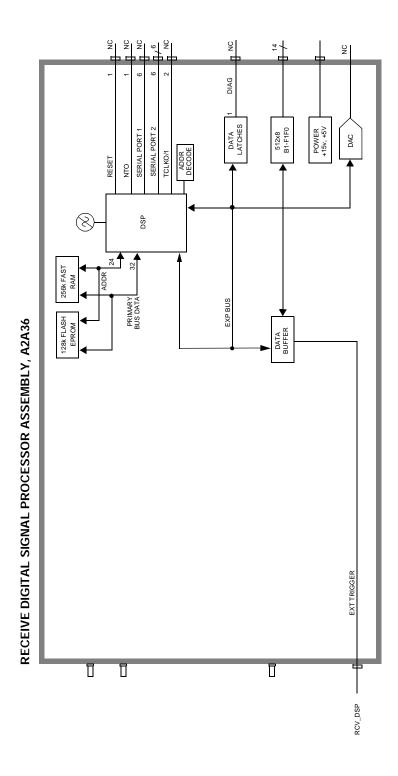


Figure 10-23 Premodulation Filter, A2A100

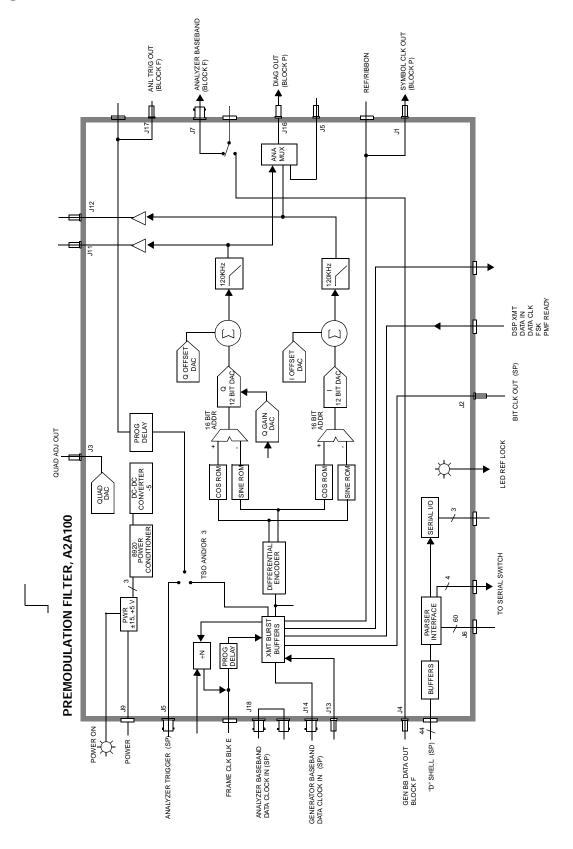
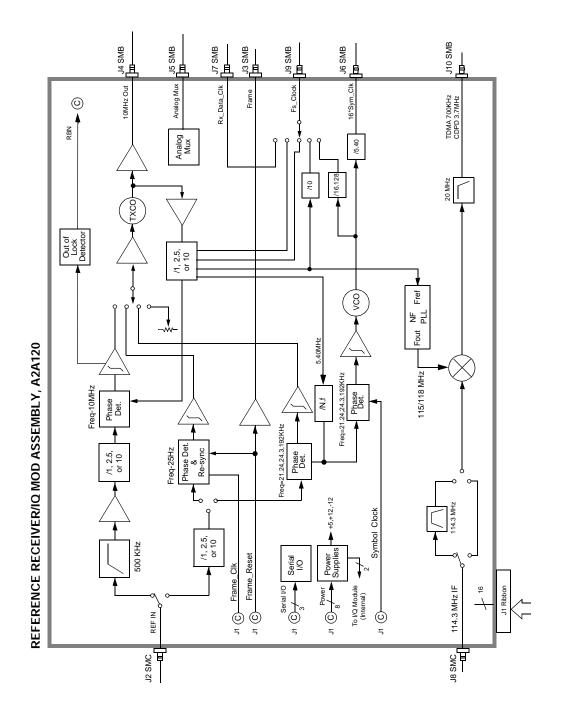


Figure 10-24 Reference Receiver/IQ Modulator, A2A120



#### **CDPD**

#### **CDPD Analysis**

The Test Set down converts the CDPD signal to 114.3 MHz IF, see figure 10-25 on page 309. This 114.3 MHz IF is passed to the Cellular Adapter's receiver where it is converted to 700 MHz and passed to the RX DSP for analysis. The signal is checked for valid CDPD data using the A2A135 directional coupler and the DSP on the A2A35 CDPD assembly.

#### **CDPD Generation**

A CDPD data signal is generated by the DSP on the CDPD assembly, see figure 10-25 on page 309. It is then encoded with 0.5 GMSK then passed back to the RF I/Q modulator for amplitude control before being amplified and transmitted by the Test Set.

## **A2A135 CDPD Directional Coupler & Serial Switch**

The directional coupler passes part of the received CDPD signal to the CDPD module while blocking the transmitted signal. This allows the CDPD module to detect valid CDPD signals. The serial switch board allows the Test Set to send commands to either the CDPD module or the Premod Filter assembly.

## **A2A35 CDPD Assembly**

The A2A35 CDPD assembly performs all of the CDPD signal generation and detects a valid CDPD signal from the base station, see figure 10-25 on page 309. The only way to control the CDPD assembly is over the serial bus using the IBASIC controller built into the Test Set. See table 10-25 on page 309 for a description of the signals and waveforms expected from the connectors of the A2A35 assembly.

Figure 10-25 CDPD

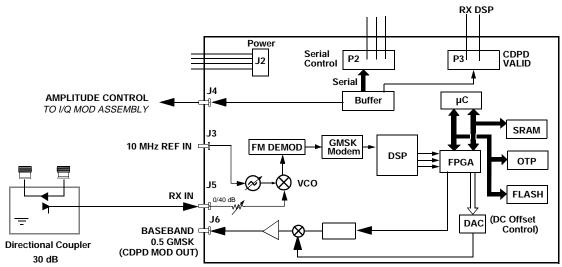


Table 10-3 CDPD Assembly Signals & Waveforms

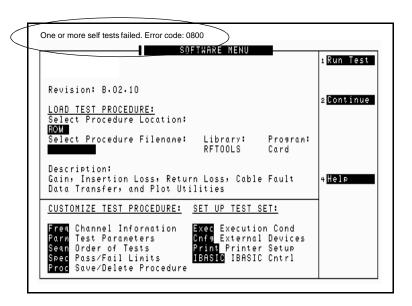
|    | Signal Description  |
|----|---|
| Ј6 | Baseband 0.5 GMSK - Unmodulated CDPD data signal that is passed to the OPTIONAL CDPD MOD OUT side connector; and the OPTIONAL CDPD MOD OUT side connector must be connected to the MODULATION INPUT side connector. This will be active when running the RF loopback test in diagnostics. |
| J5 | Receiver In - Modulated CDPD data signal received from the directional coupler (A2A135). Will be active when running the RF loopback test in the diagnostics.   |
| J3 | 10 MHz Reference In - 10 MHz reference signal from the Premod Filter assembly.  |
| J4 | Amplitude Control - DC control signal for fast switching of the CDPD RF signal.   |
| J2 | Power -15V, GND, +5V, +15V  |
| P2 | Serial Communications - Serial control bus to/from the Serial<br>Switch Board   |
| P3 | Valid CDPD - Notifies the DSP that a valid CDPD signal is being received. This is a DC signal.  |

# 11 Error Messages

## **General Information About Error Messages**

Several types of messages may be displayed on the Test Set's screen. Error messages usually appear at the top of the start-up or default screen as shown in figure 11-1.

#### Figure 11-1 Error Message Location



Error messages descriptions can be found in several manuals. See "Which Document is Required?" on page 33.

The type of message determines which manual to refer to for more information. There are four types of messages:

- Positive numbered error messages
- IBASIC error messages
- · GPIB error messages
- Text only messages

The following paragraphs give a brief description of each message format and direct you to the manual to look in for information about error messages displayed in that format.

NOTE

Beeper Operation: messages are always accompanied by a beep from the internal speaker unless the Beeper field on the INSTRUMENT CONFIGURE screen is set to Off.

**CAUTION** 

IF YOU HEAR A LOUD SIREN OR WARBLING SOUND, THIS IS THE OVER POWER WARNING!

Remove power from the side panel connectors RF IN/OUT, DUPLEX OUT, and ANTENNA IN connectors. NEVER turn off the Test Set while RF power is being applied to these connectors. After RF power is removed, turn the Test Set off and then back on. The Test Set should power up in its factory preset state (unless a POWERON Save/Recall register was saved). The siren should not come back on.

## **Power-Up Self-Test Error Messages**

The following message is typical of an error message you might encounter on the Test Set's power-up.

One or more self tests failed. Error code: 0080

In this example, the hexadecimal code 0080 corresponds to the error message "Keyboard Failure (stuck key)." For examples of other power-up error messages, see "Reading Front Panel or GPIB Codes" on page 54.

## **Diagnostics Messages**

The following message may occur when initiating and running the Functional Diagnostics program.

Direct latch write occurred. Cycle power when done servicing.

For other diagnostic messages see "Frequently Encountered Diagnostic Messages" on page 75.

When a measurement is out of limits, a message is displayed at the end of the test which indicates the following:

- · Suspected faulty assembly.
- · Confidence level of the assertion: low, medium, or high
- Failure code

For a description of the test, including an interpretation of the failure codes, see Chapter 3, "Troubleshooting" on page 47.

## **Calibration Download Failure Error Message**

The following message occurs at powerup when the downloading of calibration data is unsuccessful or a RAM initialization is performed.

Cal file checksum incorrect. File reset to default values.

It indicates that the calibration data is corrupt, and although the Test Set will function, measurements will be inaccurate. Calibration data is downloaded from a memory card when certain assemblies are replaced, or it is generated when the Periodic Calibration program is run. This message will not occur again at powerup unless another unsuccessful downloading occurs.

## Flash ROM Firmware Upgrade Error Messages

Test Set's firmware is stored in flash ROMs. With flash ROMs, the firmware can be quickly upgraded with new firmware from a memory card. It is not necessary to open the Test Set and replace individual ICs. Should problems arise in the process of uploading the new firmware, the user is notified by messages on the display which state the situation and suggest any actions to be taken.

The firmware upgrade process begins when the user inserts the firmware upgrade memory card into the front-panel memory card socket and turns the Test Set on. The Test Set notes the presence of a valid firmware upgrade card and proceeds to upload the firmware on the memory card into the flash ROMs on the A2A31 Controller assembly. Any failures that occur during the upload process are immediately reported and the upload is aborted.

The error messages that may be displayed during a firmware upgrade are listed in alphabetical order in the following paragraphs. Supplemental fault information is included.

## **Memory Card Checksum Error**

The memory card may be at fault. The card reader on the Memory board could also be faulty.

## **Memory Card Read Error**

This error will always appear if the user removes the memory card during the upload process. The memory card itself could be faulty or, less likely, the card reader on the Memory board.

## **Memory Erase Error**

This fault is most likely caused by either the flash ROMs themselves or the controller circuits. In either case replace the A2A31 Controller assembly.

## **Memory Write Error**

This fault is most likely caused by either the flash ROMs themselves or the controller circuits. In either case replace the A2A31 Controller assembly.

## **Programming Voltage Error**

The programming voltage is supplied to the flash ROMs from the power supply through the Controller assembly. The fault is most likely on the Controller but can be caused by the Filter/Regulator assembly.

#### **ROM Checksum Error**

With the new firmware loaded into the Test Set's flash ROMs, the checksum on the ROM is tested. A faulty checksum is most likely caused by the flash ROMs themselves or possibly the controller circuits. In either case replace the A2A31 Controller assembly.

## **Self-Calibration Error Messages**

Voltmeter Self Calibration Failed. Error = 223, 0x0000ffff (EXAMPLE)

The example noted above is one of many messages that may occur during self-calibration. When the Test Set is powered up and at timed intervals for certain measurements, the Test Set calibrates itself internally. Calibration usually takes 20 to 30 ms. The following measurements are calibrated at these timed intervals:

- Voltmeter: approximately every 3 minutes
- Counter: approximately every 3 minutes
- Oscilloscope: approximately every 3 minutes
- Spectrum Analyzer: approximately every 4 minutes

Should a self-calibration fail, an error message is displayed. The error code (223, 0x0000ffff in the example above) will vary depending on the particular failure. Failures of this type are generally caused by hardware. Since a general self-calibration occurs immediately after power-up, these failures often appear as though they are power-up self-test errors.

When a self-calibration failure occurs, check the A2A33 Measurement assembly first since most of the measurement circuitry described above is located on it. However, in the case of the spectrum analyzer calibration, check the A2A20 Spectrum Analyzer assembly first. The A2A23 Reference assembly may also cause its own self-calibration failure or a Spectrum Analyzer error message. (The error message in the example above can be generated by unplugging the A2A23 Reference before powering up the Test Set.)

After displaying a self-calibration error message, the Test Set will proceed with the measurement using default calibration factors. Depending on the nature of the failure, subsequent measurements may look normal. The error message will persist.

## **Text Only Error Messages**

Text only error messages are generally associated with manual operation of the Test Set. Text only error messages can also be displayed while running the Test Set's built-in diagnostic or calibration utility programs. Diagnostic messages are described in "Frequently Encountered Diagnostic Messages" on page 75.

Text only error messages take the form:

This is an error message.

#### For example:

- Input value out of range occurs when trying to set a value above or below its capability (such as attempting to set the RF Gen Freq field to 2.1 GHz).
- Turn off either AM or FM setting occurs when trying to perform simultaneous AM and FM modulation.

## **Positive Numbered Error Messages**

Positive numbered error messages usually occur when trying to save or retrieve an IBASIC file, or when trying to run a faulty IBASIC program. Refer to the Instrument BASIC User's Handbook for information on IBASIC error messages.

Positive numbered error messages take the form:

ERROR XX "error message"

#### For example:

- Error 54 Duplicate file name occurs when trying to save a file to a device where a file with the same name already exists.
- Error 5 Improper Context Terminator occurs when an END, SUBEND, or FNEND statement is not present in the program when required.

## **IBASIC Error Messages**

IBASIC Error Messages are associated with IBASIC language operation. IBASIC error messages can have both positive and negative numbers (but always start with "IBASIC Error:"). Refer to the Instrument BASIC User's Handbook for information on positive numbered error messages. Refer to the GPIB Error Messages section of the 8935 Reference Guide for information on negative numbered error messages (the error message associated with a negative number is the same for GPIB errors and IBASIC errors).

IBASIC error messages take the form:

IBASIC Error: -XX error message

For example:

IBASIC Error: -286 Program runtime error

## **GPIB Error Messages**

GPIB Error Messages are associated with GPIB operation. Refer to the 8935 Reference Guide for information on GPIB error messages.

GPIB error messages take the form:

```
HP-IB Error: -XX error message

or

HP-IB Error error message

For example:

HP-IB Error: -410 Query INTERRUPTED.

or

HP-IB Error: Input value out of range.
```

#### Non-Recoverable Firmware Error

This error occurs when the Test Set encounters a condition that the firmware doesn't understand - causing the Test Set to halt operation until power is cycled. The message appears in the center of the Test Set's display and (except for the two lines in the second paragraph) has the form:

Non-recoverable firmware error. Please record the 2 lines oftext below a nd contact Agilent Technologies through your local service center or by calling 1-800-827-3848 (USA, toll-free) ask to speak to the 8935 Service Engineer.

```
'Address error exception' at line number 0
```

Follow the instructions in the message.

Unfortunately, you cannot recover from this condition without turning the Test Set off. The error may not reoccur when you turn the Test Set back on and rerun the test where the error message first occurred. If the failure reoccurs, you should record exactly what the configuration of the instrument was when the error appeared, and contact Agilent. This information will help us determine the proper course of action for your repair.

## If This Error Occurs at Power-Up

If the Test Set displays this error when first powered up, disabling Test Set operation, it could be related to the Autostart field on the main TESTS screen. This field causes the Test Set to automatically run the last program loaded in memory when the Test Set is powered up. If the program is corrupted, the Test Set will automatically "lock up."

The only way to recover from this condition is to clear the Test Set's operating RAM. This will clear any IBASIC program, Save/Recall registers, and RAM disks that have been saved, as well as two calibration factors. The calibration factors are easily re-entered; the IBASIC programs, Save/Recall registers, and RAM disks must be re-loaded or re-initialized after clearing memory.

To clear the Test Set's RAM:

- 1. Turn the Test Set off.
- 2. Hold the RF AnI and HZ/µV keys down.
- 3. Turn the power on (with the buttons still held down) and wait until the initial power-up screen is displayed.

Use the following procedure to re-enter the two calibration factors that were erased when RAM is cleared. Use the GENERATOR ANALYZER screen keys (to the left of the cursor control knob) to access the required screens.

- Access the RF GENERATOR screen and select DC FM Zero (under the FM Coupling field).
- 2. Disconnect any cables from the ANT IN or RF IN/OUT connectors.
- 3. Access the RF ANALYZER screen and select Zero under the TX Pwr Zero field.

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